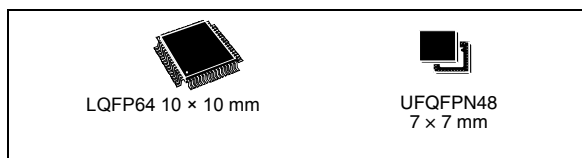


## Ultra-low-power 32-bit MCU ARM<sup>®</sup>-based Cortex<sup>®</sup>-M3, 128KB Flash, 16KB SRAM, 2KB EEPROM, LCD, USB, ADC, DAC

Datasheet - production data

### Features

- Ultra-low-power platform
  - 1.8 V to 3.6 V power supply
  - **-40°C to 85°C** temperature range
  - 0.28 µA Standby mode (2 wakeup pins)
  - 1.11 µA Standby mode + RTC
  - 0.44 µA Stop mode (16 wakeup lines)
  - 1.38 µA Stop mode + RTC
  - 10.9 µA Low-power Run mode
  - 185 µA/MHz Run mode
  - 10 nA ultra-low I/O leakage
  - < 8 µs wakeup time
- Core: ARM<sup>®</sup> Cortex<sup>®</sup>-M3 32-bit CPU
  - From 32 kHz up to 32 MHz max
  - 1.25 DMIPS/MHz (Dhrystone 2.1)
  - Memory protection unit
- Reset and supply management
  - Ultra-safe, low-power BOR (brownout reset) with 5 selectable thresholds
  - Ultra-low-power POR/PDR
  - Programmable voltage detector (PVD)
- Clock sources
  - 1 to 24 MHz crystal oscillator
  - 32 kHz oscillator for RTC with calibration
  - High Speed Internal 16 MHz
  - Internal low-power 37 kHz RC
  - Internal multispeed low-power 65 kHz to 4.2 MHz
  - PLL for CPU clock and USB (48 MHz)
- Pre-programmed bootloader
  - USART supported
- Development support
  - Serial wire debug supported
  - JTAG and trace supported
- Up to 51 fast I/Os (42 I/Os 5V tolerant), all mappable on 16 external interrupt vectors



- Memories
  - Up to 128 Kbytes of Flash memory with ECC
  - Up to 16 Kbytes of RAM
  - Up to 2 Kbytes of true EEPROM with ECC
  - 20-byte backup register
- LCD Driver for up to 8x28 segments
  - Support contrast adjustment
  - Support blinking mode
  - Step-up converter on board
- Rich analog peripherals (down to 1.8 V)
  - 12-bit ADC 1 Msps up to 24 channels
  - 12-bit DAC 2 channels with output buffers
  - 2x ultra-low-power comparators (window mode and wakeup capability)
- DMA controller 7x channels
- 8x peripheral communication interfaces
  - 1x USB 2.0 (internal 48 MHz PLL)
  - 3x USART (ISO 7816, IrDA)
  - 2x SPI 16 Mbit/s
  - 2x I2C (SMBus/PMBus)
- 10x timers: 6x 16-bit with up to 4 IC/OC/PWM channels, 2x 16-bit basic timers, 2x watchdog timers (independent and window)
- CRC calculation unit

**Table 1. Device summary**

| Reference                                         | Part number                                          |
|---------------------------------------------------|------------------------------------------------------|
| STM32L100C6-A,<br>STM32L100R8-A,<br>STM32L100RB-A | STM32L100C6xxA,<br>STM32L100R8xxA,<br>STM32L100RBxxA |

# Contents

|          |                                                                  |           |
|----------|------------------------------------------------------------------|-----------|
| <b>1</b> | <b>Introduction</b>                                              | <b>8</b>  |
| <b>2</b> | <b>Description</b>                                               | <b>9</b>  |
| 2.1      | Device overview                                                  | 10        |
| 2.2      | Ultra-low-power device continuum                                 | 11        |
| 2.2.1    | Performance                                                      | 11        |
| 2.2.2    | Shared peripherals                                               | 11        |
| 2.2.3    | Common system strategy                                           | 11        |
| 2.2.4    | Features                                                         | 11        |
| <b>3</b> | <b>Functional overview</b>                                       | <b>12</b> |
| 3.1      | Low-power modes                                                  | 13        |
| 3.2      | ARM® Cortex®-M3 core with MPU                                    | 17        |
| 3.3      | Reset and supply management                                      | 18        |
| 3.3.1    | Power supply schemes                                             | 18        |
| 3.3.2    | Power supply supervisor                                          | 18        |
| 3.3.3    | Voltage regulator                                                | 19        |
| 3.3.4    | Boot modes                                                       | 19        |
| 3.4      | Clock management                                                 | 20        |
| 3.5      | Low-power real-time clock and backup registers                   | 22        |
| 3.6      | GPIOs (general-purpose inputs/outputs)                           | 22        |
| 3.7      | Memories                                                         | 23        |
| 3.8      | DMA (direct memory access)                                       | 23        |
| 3.9      | LCD (liquid crystal display)                                     | 24        |
| 3.10     | ADC (analog-to-digital converter)                                | 24        |
| 3.10.1   | Internal voltage reference ( $V_{REFINT}$ )                      | 24        |
| 3.11     | DAC (digital-to-analog converter)                                | 25        |
| 3.12     | Ultra-low-power comparators and reference voltage                | 25        |
| 3.13     | Routing interface                                                | 25        |
| 3.14     | Timers and watchdogs                                             | 26        |
| 3.14.1   | General-purpose timers (TIM2, TIM3, TIM4, TIM9, TIM10 and TIM11) | 27        |
| 3.14.2   | Basic timers (TIM6 and TIM7)                                     | 27        |
| 3.14.3   | SysTick timer                                                    | 27        |

|          |                                                                 |           |
|----------|-----------------------------------------------------------------|-----------|
| 3.14.4   | Independent watchdog (IWDG)                                     | 27        |
| 3.14.5   | Window watchdog (WWDG)                                          | 28        |
| 3.15     | Communication interfaces                                        | 28        |
| 3.15.1   | I <sup>2</sup> C bus                                            | 28        |
| 3.15.2   | Universal synchronous/asynchronous receiver transmitter (USART) | 28        |
| 3.15.3   | Serial peripheral interface (SPI)                               | 28        |
| 3.15.4   | Universal serial bus (USB)                                      | 28        |
| 3.16     | CRC (cyclic redundancy check) calculation unit                  | 29        |
| 3.17     | Development support                                             | 29        |
| <b>4</b> | <b>Pin descriptions</b>                                         | <b>30</b> |
| <b>5</b> | <b>Memory mapping</b>                                           | <b>40</b> |
| <b>6</b> | <b>Electrical characteristics</b>                               | <b>41</b> |
| 6.1      | Parameter conditions                                            | 41        |
| 6.1.1    | Minimum and maximum values                                      | 41        |
| 6.1.2    | Typical values                                                  | 41        |
| 6.1.3    | Typical curves                                                  | 41        |
| 6.1.4    | Loading capacitor                                               | 41        |
| 6.1.5    | Pin input voltage                                               | 41        |
| 6.1.6    | Power supply scheme                                             | 42        |
| 6.1.7    | Optional LCD power supply scheme                                | 43        |
| 6.1.8    | Current consumption measurement                                 | 43        |
| 6.2      | Absolute maximum ratings                                        | 44        |
| 6.3      | Operating conditions                                            | 45        |
| 6.3.1    | General operating conditions                                    | 45        |
| 6.3.2    | Embedded reset and power control block characteristics          | 46        |
| 6.3.3    | Embedded internal reference voltage                             | 48        |
| 6.3.4    | Supply current characteristics                                  | 49        |
| 6.3.5    | Wakeup time from Low-power mode                                 | 59        |
| 6.3.6    | External clock source characteristics                           | 60        |
| 6.3.7    | Internal clock source characteristics                           | 65        |
| 6.3.8    | PLL characteristics                                             | 67        |
| 6.3.9    | Memory characteristics                                          | 68        |
| 6.3.10   | EMC characteristics                                             | 69        |
| 6.3.11   | Electrical sensitivity characteristics                          | 70        |

---

|          |                                                                        |            |
|----------|------------------------------------------------------------------------|------------|
| 6.3.12   | I/O current injection characteristics .....                            | 71         |
| 6.3.13   | I/O port characteristics .....                                         | 72         |
| 6.3.14   | NRST pin characteristics .....                                         | 75         |
| 6.3.15   | TIM timer characteristics .....                                        | 76         |
| 6.3.16   | Communication interfaces .....                                         | 77         |
| 6.3.17   | 12-bit ADC characteristics .....                                       | 83         |
| 6.3.18   | DAC electrical specifications .....                                    | 87         |
| 6.3.19   | Comparator .....                                                       | 89         |
| 6.3.20   | LCD controller .....                                                   | 91         |
| <b>7</b> | <b>Package information .....</b>                                       | <b>92</b>  |
| 7.1      | LQFP64 10 x 10 mm, 64-pin low-profile quad flat package information .. | 92         |
| 7.2      | UFQFPN48 7 x 7 mm, 0.5 mm pitch, package information .....             | 95         |
| 7.3      | Thermal characteristics .....                                          | 98         |
| 7.3.1    | Reference document .....                                               | 99         |
| <b>8</b> | <b>Ordering information .....</b>                                      | <b>100</b> |
| <b>9</b> | <b>Revision history .....</b>                                          | <b>101</b> |

## List of tables

|           |                                                                                         |    |
|-----------|-----------------------------------------------------------------------------------------|----|
| Table 1.  | Device summary . . . . .                                                                | 1  |
| Table 2.  | Ultra-low-power STM32L100x6/8/B-A device features and peripheral counts . . . . .       | 10 |
| Table 3.  | Functionalities depending on the operating power supply range . . . . .                 | 14 |
| Table 4.  | CPU frequency range depending on dynamic voltage scaling . . . . .                      | 15 |
| Table 5.  | Working mode-dependent functionalities (from Run/active down to standby) . . . . .      | 16 |
| Table 6.  | VLCD rail decoupling . . . . .                                                          | 24 |
| Table 7.  | Timer feature comparison . . . . .                                                      | 26 |
| Table 8.  | Legend/abbreviations used in the pinout table . . . . .                                 | 32 |
| Table 9.  | STM32L100x6/8/B-A pin definitions . . . . .                                             | 33 |
| Table 10. | Alternate function input/output . . . . .                                               | 37 |
| Table 11. | Voltage characteristics . . . . .                                                       | 44 |
| Table 12. | Current characteristics . . . . .                                                       | 44 |
| Table 13. | Thermal characteristics . . . . .                                                       | 45 |
| Table 14. | General operating conditions . . . . .                                                  | 45 |
| Table 15. | Embedded reset and power control block characteristics . . . . .                        | 46 |
| Table 16. | Embedded internal reference voltage calibration values . . . . .                        | 48 |
| Table 17. | Embedded internal reference voltage . . . . .                                           | 48 |
| Table 18. | Current consumption in Run mode, code with data processing running from Flash . . . . . | 50 |
| Table 19. | Current consumption in Run mode, code with data processing running from RAM . . . . .   | 51 |
| Table 20. | Current consumption in Sleep mode . . . . .                                             | 52 |
| Table 21. | Current consumption in Low power run mode . . . . .                                     | 53 |
| Table 22. | Current consumption in Low power sleep mode . . . . .                                   | 54 |
| Table 23. | Typical and maximum current consumptions in Stop mode . . . . .                         | 55 |
| Table 24. | Typical and maximum current consumptions in Standby mode . . . . .                      | 56 |
| Table 25. | Peripheral current consumption . . . . .                                                | 57 |
| Table 26. | Low-power mode wakeup timings . . . . .                                                 | 59 |
| Table 27. | High-speed external user clock characteristics . . . . .                                | 60 |
| Table 28. | Low-speed external user clock characteristics . . . . .                                 | 61 |
| Table 29. | HSE oscillator characteristics . . . . .                                                | 61 |
| Table 30. | LSE oscillator characteristics ( $f_{LSE} = 32.768$ kHz) . . . . .                      | 63 |
| Table 31. | HSI oscillator characteristics . . . . .                                                | 65 |
| Table 32. | LSI oscillator characteristics . . . . .                                                | 65 |
| Table 33. | MSI oscillator characteristics . . . . .                                                | 66 |
| Table 34. | PLL characteristics . . . . .                                                           | 67 |
| Table 35. | RAM and hardware registers . . . . .                                                    | 68 |
| Table 36. | Flash memory and data EEPROM characteristics . . . . .                                  | 68 |
| Table 37. | Flash memory, data EEPROM endurance and data retention . . . . .                        | 68 |
| Table 38. | EMS characteristics . . . . .                                                           | 69 |
| Table 39. | EMI characteristics . . . . .                                                           | 70 |
| Table 40. | ESD absolute maximum ratings . . . . .                                                  | 70 |
| Table 41. | Electrical sensitivities . . . . .                                                      | 71 |
| Table 42. | I/O current injection susceptibility . . . . .                                          | 71 |
| Table 43. | I/O static characteristics . . . . .                                                    | 72 |
| Table 44. | Output voltage characteristics . . . . .                                                | 73 |
| Table 45. | I/O AC characteristics . . . . .                                                        | 74 |
| Table 46. | NRST pin characteristics . . . . .                                                      | 75 |
| Table 47. | TIMx characteristics . . . . .                                                          | 76 |
| Table 48. | I <sup>2</sup> C characteristics . . . . .                                              | 77 |

|           |                                                                          |     |
|-----------|--------------------------------------------------------------------------|-----|
| Table 49. | SCL frequency ( $f_{PCLK1}$ = 32 MHz, $V_{DD}$ = $V_{DD\_I2C}$ = 3.3 V). | 78  |
| Table 50. | SPI characteristics                                                      | 79  |
| Table 51. | USB startup time.                                                        | 81  |
| Table 52. | USB DC electrical characteristics                                        | 82  |
| Table 53. | USB: full speed electrical characteristics                               | 82  |
| Table 54. | ADC clock frequency                                                      | 83  |
| Table 55. | ADC characteristics                                                      | 83  |
| Table 56. | ADC accuracy.                                                            | 84  |
| Table 57. | Maximum source impedance $R_{AIN}$ max                                   | 86  |
| Table 58. | DAC characteristics                                                      | 87  |
| Table 59. | Comparator 1 characteristics                                             | 89  |
| Table 60. | Comparator 2 characteristics                                             | 90  |
| Table 61. | LCD controller characteristics                                           | 91  |
| Table 62. | LQFP64 10 x 10 mm, 64-pin low-profile quad flat package mechanical data. | 92  |
| Table 63. | UFQFPN48 7 x 7 mm, 0.5 mm pitch, package mechanical data                 | 96  |
| Table 64. | Thermal characteristics.                                                 | 98  |
| Table 65. | Ordering information scheme                                              | 100 |
| Table 66. | Document revision history                                                | 101 |

## List of figures

|            |                                                                                                       |    |
|------------|-------------------------------------------------------------------------------------------------------|----|
| Figure 1.  | Ultra-low-power STM32L100x6/8/B-A block diagram . . . . .                                             | 12 |
| Figure 2.  | Clock tree . . . . .                                                                                  | 21 |
| Figure 3.  | STM32L100RxxxA LQFP64 pinout . . . . .                                                                | 30 |
| Figure 4.  | STM32L100C6xxA UFQFPN48 pinout . . . . .                                                              | 31 |
| Figure 5.  | Memory map . . . . .                                                                                  | 40 |
| Figure 6.  | Pin loading conditions . . . . .                                                                      | 41 |
| Figure 7.  | Pin input voltage . . . . .                                                                           | 41 |
| Figure 8.  | Power supply scheme . . . . .                                                                         | 42 |
| Figure 9.  | Optional LCD power supply scheme . . . . .                                                            | 43 |
| Figure 10. | Current consumption measurement scheme . . . . .                                                      | 43 |
| Figure 11. | High-speed external clock source AC timing diagram . . . . .                                          | 60 |
| Figure 12. | Low-speed external clock source AC timing diagram . . . . .                                           | 61 |
| Figure 13. | HSE oscillator circuit diagram . . . . .                                                              | 63 |
| Figure 14. | Typical application with a 32.768 kHz crystal . . . . .                                               | 64 |
| Figure 15. | I/O AC characteristics definition . . . . .                                                           | 75 |
| Figure 16. | Recommended NRST pin protection . . . . .                                                             | 76 |
| Figure 17. | I <sup>2</sup> C bus AC waveforms and measurement circuit . . . . .                                   | 78 |
| Figure 18. | SPI timing diagram - slave mode and CPHA = 0 . . . . .                                                | 80 |
| Figure 19. | SPI timing diagram - slave mode and CPHA = 1 <sup>(1)</sup> . . . . .                                 | 80 |
| Figure 20. | SPI timing diagram - master mode <sup>(1)</sup> . . . . .                                             | 81 |
| Figure 21. | USB timings: definition of data signal rise and fall time . . . . .                                   | 82 |
| Figure 22. | ADC accuracy characteristics . . . . .                                                                | 85 |
| Figure 23. | Typical connection diagram using the ADC . . . . .                                                    | 85 |
| Figure 24. | Maximum dynamic current consumption on V <sub>DDA</sub> supply pin during ADC<br>conversion . . . . . | 86 |
| Figure 25. | 12-bit buffered /non-buffered DAC . . . . .                                                           | 89 |
| Figure 26. | LQFP64 10 x 10 mm, 64-pin low-profile quad flat package outline . . . . .                             | 92 |
| Figure 27. | LQFP64 10 x 10 mm, 64-pin low-profile quad flat package recommended footprint . . . . .               | 93 |
| Figure 28. | LQFP64 10 x 10 mm, 64-pin low-profile quad flat package top view example . . . . .                    | 94 |
| Figure 29. | UFQFPN48 7 x 7 mm, 0.5 mm pitch, package outline . . . . .                                            | 95 |
| Figure 30. | UFQFPN48 7 x 7 mm, 0.5 mm pitch, package recommended footprint . . . . .                              | 96 |
| Figure 31. | UFQFPN48 7 x 7 mm, 0.5 mm pitch, package top view example . . . . .                                   | 97 |
| Figure 32. | Thermal resistance . . . . .                                                                          | 98 |

# 1 Introduction

This datasheet provides the ordering information and mechanical device characteristics of the STM32L100x6/8/B-A ultra-low-power ARM® Cortex®-M3 based microcontrollers product line.

The ultra-low-power STM32L100x6/8/B-A microcontroller family includes devices in 2 different package types: 48 or 64 pins. Depending on the device chosen, different sets of peripherals are included, the description below gives an overview of the complete range of peripherals proposed in this family.

These features make the ultra-low-power STM32L100x6/8/B-A microcontroller family suitable for a wide range of applications:

- Medical and handheld equipment
- Application control and user interface
- PC peripherals, gaming, GPS and sport equipment
- Alarm systems, Wired and wireless sensors, Video intercom
- Utility metering

This STM32L100x6/8/B-A datasheet should be read in conjunction with the STM32L1xxxx reference manual (RM0038). The document "Getting started with STM32L1xxxx hardware development" AN3216 gives a hardware implementation overview.

Both documents are available from the STMicroelectronics website [www.st.com](http://www.st.com).

For information on the ARM® Cortex®-M3 core please refer to the Cortex®-M3 Technical Reference Manual, available from the ARM website.

*Figure 1* shows the general block diagram of the device family.

**Caution:** This datasheet does not apply to:

- STM32L100x6/8/B

covered by a separate datasheet.

## 2 Description

The ultra-low-power STM32L100x6/8/B-A devices incorporate the connectivity power of the universal serial bus (USB) with the high-performance ARM® Cortex®-M3 32-bit RISC core operating at a frequency of 32 MHz (33.3 DMIPS), a memory protection unit (MPU), high-speed embedded memories (Flash memory up to 128 Kbytes and RAM up to 16 Kbytes) and an extensive range of enhanced I/Os and peripherals connected to two APB buses.

All the devices offer a 12-bit ADC, 2 DACs and 2 ultra-low-power comparators, six general-purpose 16-bit timers and two basic timers, which can be used as time bases.

Moreover, the STM32L100x6/8/B-A devices contain standard and advanced communication interfaces: up to two I<sup>2</sup>Cs and SPIs, three USARTs and a USB.

They also include a real-time clock with sub-second counting and a set of backup registers that remain powered in Standby mode.

Finally, the integrated LCD controller has a built-in LCD voltage generator that allows to drive up to 8 multiplexed LCDs with contrast independent of the supply voltage.

The ultra-low-power STM32L100x6/8/B-A devices operate from a 1.8 to 3.6 V power supply. They are available in the -40 to +85 °C temperature range. A comprehensive set of power-saving modes allows the design of low-power applications.



## 2.1 Device overview

Table 2. Ultra-low-power STM32L100x6/8/B-A device features and peripheral counts

| Peripheral                                    |                  | STM32L100C6xxA                                                             | STM32L100R8/BxxA |     |
|-----------------------------------------------|------------------|----------------------------------------------------------------------------|------------------|-----|
| Flash (Kbytes)                                |                  | 32                                                                         | 64               | 128 |
| Data EEPROM (Kbytes)                          |                  | 2                                                                          |                  |     |
| RAM (Kbytes)                                  |                  | 4                                                                          | 8                | 16  |
| Timers                                        | General-purpose  | 6                                                                          |                  |     |
|                                               | Basic            | 2                                                                          |                  |     |
| Communication interfaces                      | SPI              | 2                                                                          |                  |     |
|                                               | I <sup>2</sup> C | 2                                                                          |                  |     |
|                                               | USART            | 3                                                                          |                  |     |
|                                               | USB              | 1                                                                          |                  |     |
| GPIOs                                         |                  | 37                                                                         | 51               |     |
| 12-bit synchronized ADC<br>Number of channels |                  | 1<br>14 channels                                                           | 1<br>20 channels |     |
| 12-bit DAC<br>Number of channels              |                  | 2<br>2                                                                     |                  |     |
| LCD<br>COM x SEG                              |                  | 4x16                                                                       | 4x32<br>8x28     |     |
| Comparator                                    |                  | 2                                                                          |                  |     |
| Max. CPU frequency                            |                  | 32 MHz                                                                     |                  |     |
| Operating voltage                             |                  | 1.8 V to 3.6 V                                                             |                  |     |
| Operating temperatures                        |                  | Ambient temperatures: –40 to +85 °C<br>Junction temperature: -40 to +105°C |                  |     |
| Packages                                      |                  | UFQFPN48                                                                   | LQFP64           |     |

## 2.2 Ultra-low-power device continuum

The ultra-low-power family offers a large choice of cores and features. From a proprietary 8-bit core up to the Cortex-M3, including the Cortex-M0+, the STM8Lx and STM32Lx series offer the best range of choices to meet your requirements in terms of ultra-low-power features. The STM32 Ultra-low-power series is an ideal fit for applications like gas/water meters, keyboard/mouse, or wearable devices for fitness and healthcare. Numerous built-in features like LCD drivers, dual-bank memory, low-power Run mode, op-amp, AES-128bit, DAC, crystal-less USB and many others, allow to build highly cost-optimized applications by reducing the BOM.

*Note: STMicroelectronics as a reliable and long-term manufacturer ensures as much as possible the pin-to-pin compatibility between any STM8Lx and STM32Lx devices and between any of the STM32Lx and STM32Fx series. Thanks to this unprecedented scalability, your existing applications can be upgraded to respond to the latest market features and efficiency demand.*

### 2.2.1 Performance

All families incorporate highly energy-efficient cores with both Harvard architecture and pipelined execution: advanced STM8 core for STM8L families and ARM Cortex-M3 core for STM32L family. In addition specific care for the design architecture has been taken to optimize the mA/DMIPS and mA/MHz ratios.

This allows the ultra-Low-power performance to range from 5 up to 33.3 DMIPs.

### 2.2.2 Shared peripherals

STM8L15xxx and STM32L1xxxx share identical peripherals which ensure a very easy migration from one family to another:

- Analog peripherals: ADC, DAC and comparators
- Digital peripherals: RTC and some communication interfaces

### 2.2.3 Common system strategy

To offer flexibility and optimize performance, the STM8L15xxx and STM32L1xxxx families use a common architecture:

- Common power supply range from 1.8 V to 3.6 V
- Architecture optimized to reach ultra-low consumption both in low-power modes and Run mode
- Fast startup strategy from low-power modes
- Flexible system clock
- Ultra-safe reset: same reset strategy including power-on reset, power-down reset, brownout reset and programmable voltage detector.

### 2.2.4 Features

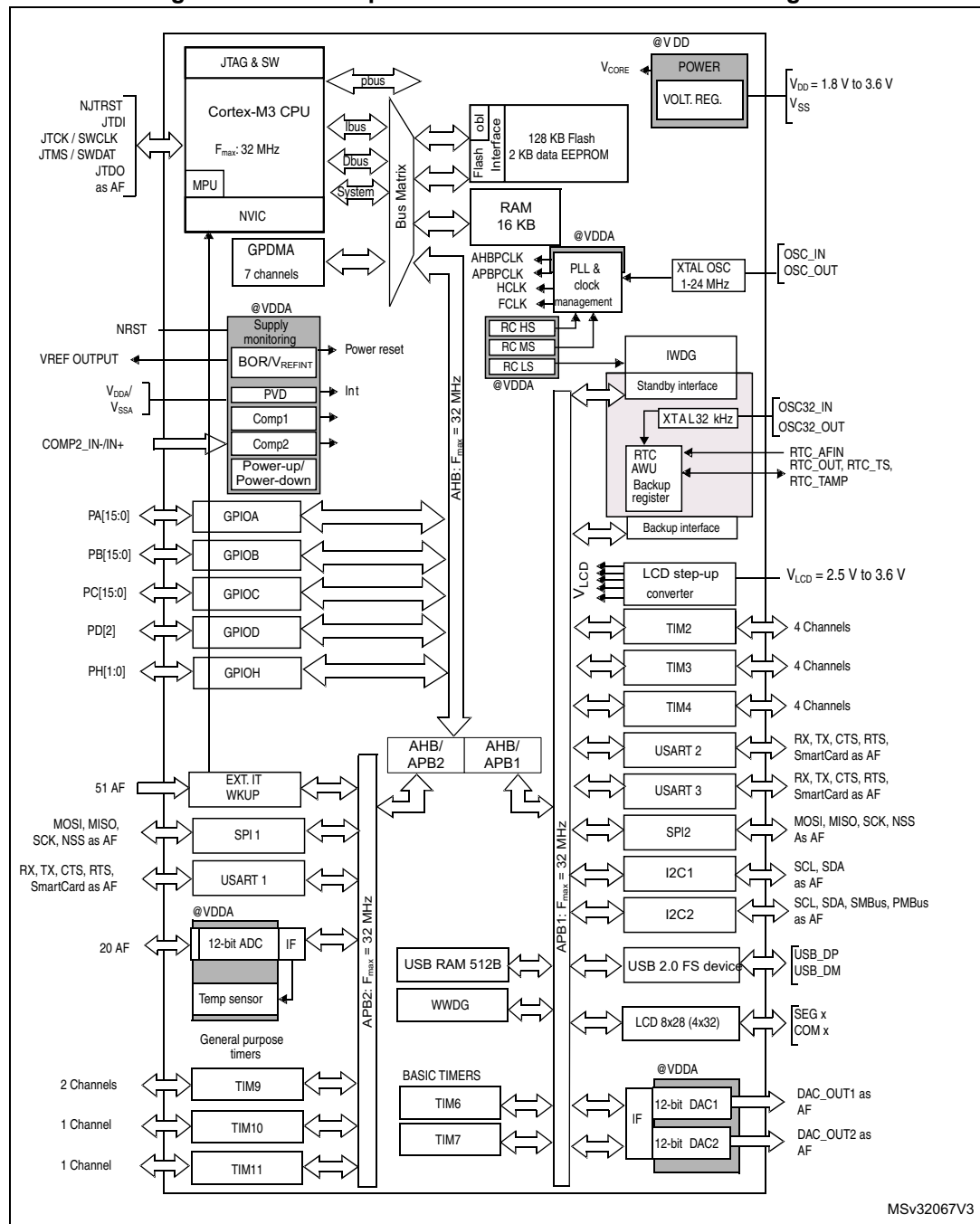
ST ultra-low-power continuum also lies in feature compatibility:

- More than 10 packages with pin count from 20 to 144 pins and size down to 3 x 3 mm
- Memory density ranging from 4 to 512 Kbytes

# 3

*Figure 1* shows the block diagram.

**Figure 1. Ultra-low-power STM32L100x6/8/B-A block diagram**



1. AF = alternate function on I/O port pin.

### 3.1 Low-power modes

The ultra-low-power STM32L100x6/8/B-A devices support dynamic voltage scaling to optimize its power consumption in run mode. The voltage from the internal low-drop regulator that supplies the logic can be adjusted according to the system's maximum operating frequency and the external voltage supply:

- In Range 1 ( $V_{DD}$  range limited to 2.0-3.6 V), the CPU runs at up to 32 MHz (refer to [Table 18](#) for consumption).
- In Range 2 (full  $V_{DD}$  range), the CPU runs at up to 16 MHz (refer to [Table 18](#) for consumption)
- In Range 3 (full  $V_{DD}$  range), the CPU runs at up to 4 MHz (generated only with the multispeed internal RC oscillator clock source). Refer to [Table 18](#) for consumption.

Seven low-power modes are provided to achieve the best compromise between low-power consumption, short startup time and available wakeup sources:

- **Sleep mode**  
In Sleep mode, only the CPU is stopped. All peripherals continue to operate and can wake up the CPU when an interrupt/event occurs.  
Sleep mode power consumption: refer to [Table 20](#).
- **Low-power Run mode**  
This mode is achieved with the multispeed internal (MSI) RC oscillator set to the MSI range 0 or MSI range 1 clock range (maximum 131 kHz), execution from SRAM or Flash memory, and internal regulator in low-power mode to minimize the regulator's operating current. In the low-power Run mode, the clock frequency and the number of enabled peripherals are both limited.  
Low-power Run mode consumption: refer to [Table 21](#).
- **Low-power Sleep mode**  
This mode is achieved by entering the Sleep mode with the internal voltage regulator in low-power mode to minimize the regulator's operating current. In the low-power Sleep mode, both the clock frequency and the number of enabled peripherals are limited; a typical example would be to have a timer running at 32 kHz.  
When wakeup is triggered by an event or an interrupt, the system reverts to the run mode with the regulator on.  
Low-power Sleep mode consumption: refer to [Table 22](#).
- **Stop mode with RTC**  
Stop mode achieves the lowest power consumption while retaining the RAM and register contents and real time clock. All clocks in the  $V_{CORE}$  domain are stopped, the PLL, MSI RC, HSI RC and HSE crystal oscillators are disabled. The LSE or LSI is still running. The voltage regulator is in the low-power mode.  
The device can be woken up from Stop mode by any of the EXTI line, in 8  $\mu$ s. The EXTI line source can be one of the 16 external lines. It can be the PVD output, the Comparator 1 event or Comparator 2 event (if internal reference voltage is on), it can be the RTC alarm(s), the USB wakeup, the RTC tamper events, the RTC timestamp event or the RTC wakeup.
- **Stop mode without RTC**  
Stop mode achieves the lowest power consumption while retaining the RAM and register contents. All clocks are stopped, the PLL, MSI RC, HSI and LSI RC, LSE and HSE crystal oscillators are disabled. The voltage regulator is in the low-power mode. The device can be woken up from Stop mode by any of the EXTI line, in 8  $\mu$ s. The EXTI

line source can be one of the 16 external lines. It can be the PVD output, the Comparator 1 event or Comparator 2 event (if internal reference voltage is on). It can also be wakened by the USB wakeup.

Stop mode consumption: refer to [Table 23](#).

- **Standby mode with RTC**

Standby mode is used to achieve the lowest power consumption and real time clock. The internal voltage regulator is switched off so that the entire  $V_{CORE}$  domain is powered off. The PLL, MSI RC, HSI RC and HSE crystal oscillators are also switched off. The LSE or LSI is still running. After entering Standby mode, the RAM and register contents are lost except for registers in the Standby circuitry (wakeup logic, IWDG, RTC, LSI, LSE Crystal 32K osc, RCC\_CSR).

The device exits Standby mode in 60  $\mu$ s when an external reset (NRST pin), an IWDG reset, a rising edge on one of the two WKUP pins, RTC alarm (Alarm A or Alarm B), RTC tamper event, RTC timestamp event or RTC Wakeup event occurs.

- **Standby mode without RTC**

Standby mode is used to achieve the lowest power consumption. The internal voltage regulator is switched off so that the entire  $V_{CORE}$  domain is powered off. The PLL, MSI, RC, HSI and LSI RC, HSE and LSE crystal oscillators are also switched off. After entering Standby mode, the RAM and register contents are lost except for registers in the Standby circuitry (wakeup logic, IWDG, RTC, LSI, LSE Crystal 32K osc, RCC\_CSR).

The device exits Standby mode in 60  $\mu$ s when an external reset (NRST pin) or a rising edge on one of the two WKUP pin occurs.

Standby mode consumption: refer to [Table 24](#).

**Note:** *The RTC, the IWDG, and the corresponding clock sources are not stopped by entering the Stop or Standby mode.*

**Table 3. Functionalities depending on the operating power supply range**

| Operating power supply range             | Functionalities depending on the operating power supply range <sup>(1)</sup> |                           |                               |
|------------------------------------------|------------------------------------------------------------------------------|---------------------------|-------------------------------|
|                                          | DAC and ADC operation                                                        | USB                       | Dynamic voltage scaling range |
| $V_{DD} = 1.8$ to $2.0$ V <sup>(2)</sup> | Conversion time up to 500 Ksps                                               | Not functional            | Range 2 or Range 3            |
| $V_{DD} = 2.0$ to $2.4$ V                | Conversion time up to 500 Ksps                                               | Functional <sup>(3)</sup> | Range 1, Range 2 or Range 3   |
| $V_{DD} = 2.4$ to $3.6$ V                | Conversion time up to 1 Msps                                                 | Functional <sup>(3)</sup> | Range 1, Range 2 or Range 3   |

1. The GPIO speed also depends from VDD voltage and the user has to refer to [Table 45: I/O AC characteristics](#) for more information about I/O speed.
2. The CPU frequency changes from initial to final must respect " $F_{CPU\ initial} < 4 \cdot F_{CPU\ final}$ " to limit  $V_{CORE}$  drop due to current consumption peak when frequency increases. It must also respect 5  $\mu$ s delay between two changes. For example to switch from 4.2 MHz to 32 MHz, you can switch from 4.2 MHz to 16 MHz, wait 5  $\mu$ s, then switch from 16 MHz to 32 MHz.
3. Should be USB-compliant from I/O voltage standpoint, the minimum  $V_{DD}$  is 3.0 V.

Table 4. CPU frequency range depending on dynamic voltage scaling

| CPU frequency range                                 | Dynamic voltage scaling range |
|-----------------------------------------------------|-------------------------------|
| 16 MHz to 32 MHz (1ws)<br>32 kHz to 16 MHz (0ws)    | Range 1                       |
| 8 MHz to 16 MHz (1ws)<br>32 kHz to 8 MHz (0ws)      | Range 2                       |
| 2.1 MHz to 4.2 MHz (1ws)<br>32 kHz to 2.1 MHz (0ws) | Range 3                       |

Table 5. Working mode-dependent functionalities (from Run/active down to standby)

| Ips                                 | Run/Active | Sleep | Low-power Run | Low-power Sleep | Stop |                   | Standby |                   |
|-------------------------------------|------------|-------|---------------|-----------------|------|-------------------|---------|-------------------|
|                                     |            |       |               |                 |      | Wakeup capability |         | Wakeup capability |
| CPU                                 | Y          | -     | Y             | -               | -    | -                 | -       | -                 |
| Flash                               | Y          | Y     | Y             | -               | -    | -                 | -       | -                 |
| RAM                                 | Y          | Y     | Y             | Y               | Y    | -                 | -       | -                 |
| Backup Registers                    | Y          | Y     | Y             | Y               | Y    | -                 | Y       | -                 |
| EEPROM                              | Y          | Y     | Y             | Y               | Y    | -                 | -       | -                 |
| Brown-out reset (BOR)               | Y          | Y     | Y             | Y               | Y    | Y                 | Y       | -                 |
| DMA                                 | Y          | Y     | Y             | Y               | -    | -                 | -       | -                 |
| Programmable Voltage Detector (PVD) | Y          | Y     | Y             | Y               | Y    | Y                 | Y       | -                 |
| Power On Reset (POR)                | Y          | Y     | Y             | Y               | Y    | Y                 | Y       | -                 |
| Power Down Rest (PDR)               | Y          | Y     | Y             | Y               | Y    | -                 | Y       | -                 |
| High Speed Internal (HSI)           | Y          | Y     | -             | -               | -    | -                 | -       | -                 |
| High Speed External (HSE)           | Y          | Y     | -             | -               | -    | -                 | -       | -                 |
| Low Speed Internal (LSI)            | Y          | Y     | Y             | Y               | Y    | -                 | Y       | -                 |
| Low Speed External (LSE)            | Y          | Y     | Y             | Y               | Y    | -                 | Y       | -                 |
| Multi-Speed Internal (MSI)          | Y          | Y     | Y             | Y               | -    | -                 | -       | -                 |
| Inter-Connect Controller            | Y          | Y     | Y             | Y               | -    | -                 | -       | -                 |
| RTC                                 | Y          | Y     | Y             | Y               | Y    | Y                 | Y       | -                 |
| RTC Tamper                          | Y          | Y     | Y             | Y               | Y    | Y                 | Y       | Y                 |
| Auto Wakeup (AWU)                   | Y          | Y     | Y             | Y               | Y    | Y                 | Y       | Y                 |
| LCD                                 | Y          | Y     | Y             | Y               | Y    | -                 | -       | -                 |
| USB                                 | Y          | Y     | -             | -               | -    | Y                 | -       | -                 |
| USART                               | Y          | Y     | Y             | Y               | Y    | (1)               | -       | -                 |
| SPI                                 | Y          | Y     | Y             | Y               | -    | -                 | -       | -                 |
| I2C                                 | Y          | Y     | -             | -               | -    | (1)               | -       | -                 |
| ADC                                 | Y          | Y     | -             | -               | -    | -                 | -       | -                 |

Table 5. Working mode-dependent functionalities (from Run/active down to standby) (continued)

| Ips                                          | Run/Active                           | Sleep                                 | Low-power Run        | Low-power Sleep     | Stop                                   |                   | Standby                                |                   |
|----------------------------------------------|--------------------------------------|---------------------------------------|----------------------|---------------------|----------------------------------------|-------------------|----------------------------------------|-------------------|
|                                              |                                      |                                       |                      |                     |                                        | Wakeup capability |                                        | Wakeup capability |
| DAC                                          | Y                                    | Y                                     | Y                    | Y                   | Y                                      | -                 | -                                      | -                 |
| Comparators                                  | Y                                    | Y                                     | Y                    | Y                   | Y                                      | Y                 | -                                      | -                 |
| 16-bit Timers                                | Y                                    | Y                                     | Y                    | Y                   | -                                      | -                 | -                                      | -                 |
| IWDG                                         | Y                                    | Y                                     | Y                    | Y                   | Y                                      | Y                 | Y                                      | Y                 |
| WWDG                                         | Y                                    | Y                                     | Y                    | Y                   | -                                      | -                 | -                                      | -                 |
| Systick Timer                                | Y                                    | Y                                     | Y                    | Y                   | -                                      | -                 | -                                      | -                 |
| GPIOs                                        | Y                                    | Y                                     | Y                    | Y                   | Y                                      | Y                 | -                                      | 2 pins            |
| Wakeup time to Run mode                      | 0 $\mu$ s                            | 0.4 $\mu$ s                           | 3 $\mu$ s            | 46 $\mu$ s          | < 8 $\mu$ s                            |                   | 58 $\mu$ s                             |                   |
| Consumption<br>$V_{DD}=1.8$ V to 3.6 V (Typ) | Down to 185 $\mu$ A/MHz (from Flash) | Down to 36.9 $\mu$ A/MHz (from Flash) | Down to 10.9 $\mu$ A | Down to 5.5 $\mu$ A | 0.43 $\mu$ A (No RTC) $V_{DD}=1.8$ V   |                   | 0.27 $\mu$ A (No RTC) $V_{DD}=1.8$ V   |                   |
|                                              |                                      |                                       |                      |                     | 1.13 $\mu$ A (with RTC) $V_{DD}=1.8$ V |                   | 0.87 $\mu$ A (with RTC) $V_{DD}=1.8$ V |                   |
|                                              |                                      |                                       |                      |                     | 0.44 $\mu$ A (No RTC) $V_{DD}=3.0$ V   |                   | 0.28 $\mu$ A (No RTC) $V_{DD}=3.0$ V   |                   |
|                                              |                                      |                                       |                      |                     | 1.38 $\mu$ A (with RTC) $V_{DD}=3.0$ V |                   | 1.11 $\mu$ A (with RTC) $V_{DD}=3.0$ V |                   |

1. The startup on communication line wakes the CPU which was made possible by an EXTI, this induces a delay before entering run mode.

## 3.2 ARM® Cortex®-M3 core with MPU

The ARM® Cortex®-M3 processor is the industry leading processor for embedded systems. It has been developed to provide a low-cost platform that meets the needs of MCU implementation, with a reduced pin count and low-power consumption, while delivering outstanding computational performance and an advanced system response to interrupts.

The ARM® Cortex®-M3 32-bit RISC processor features exceptional code-efficiency, delivering the high-performance expected from an ARM core in the memory size usually associated with 8- and 16-bit devices.

The memory protection unit (MPU) improves system reliability by defining the memory attributes (such as read/write access permissions) for different memory regions. It provides up to eight different regions and an optional predefined background region.

Owing to its embedded ARM core, the STM32L100x6/8/B-A devices are compatible with all ARM tools and software.

### Nested vectored interrupt controller (NVIC)

The ultra-low-power STM32L100x6/8/B-A devices embed a nested vectored interrupt controller able to handle up to 45 maskable interrupt channels (not including the 16 interrupt lines of Cortex-M3) and 16 priority levels.

- Closely coupled NVIC gives low-latency interrupt processing
- Interrupt entry vector table address passed directly to the core
- Closely coupled NVIC core interface
- Allows early processing of interrupts
- Processing of *late arriving*, higher-priority interrupts
- Support for tail-chaining
- Processor state automatically saved on interrupt entry, and restored on interrupt exit, with no instruction overhead

This hardware block provides flexible interrupt management features with minimal interrupt latency.

## 3.3 Reset and supply management

### 3.3.1 Power supply schemes

- $V_{DD} = 1.8$  to  $3.6$  V: external power supply for I/Os and the internal regulator. Provided externally through  $V_{DD}$  pins.
- $V_{SSA}$ ,  $V_{DDA} = 1.8$  to  $3.6$  V: external analog power supplies for ADC, reset blocks, RCs and PLL.  
 $V_{DDA}$  and  $V_{SSA}$  must be connected to  $V_{DD}$  and  $V_{SS}$ , respectively.

### 3.3.2 Power supply supervisor

The device has an integrated ZEROPOWER power-on reset (POR)/power-down reset (PDR) that can be coupled with a brownout reset (BOR) circuitry.

After the  $V_{DD}$  threshold is reached, the option byte loading process starts, either to confirm or modify default thresholds, or to disable the BOR permanently.

BOR ensures proper operation starting from  $1.8$  V whatever the power ramp-up phase before it reaches  $1.8$  V.

Five BOR thresholds are available through option bytes, starting from 1.8 V to 3 V. To reduce the power consumption in Stop mode, it is possible to automatically switch off the internal reference voltage ( $V_{REFINT}$ ) in Stop mode. The device remains in reset mode when  $V_{DD}$  is below a specified threshold,  $V_{POR/PDR}$  or  $V_{BOR}$ , without the need for any external reset circuit.

*Note:* The start-up time at power-on is typically 3.3 ms.

The device features an embedded programmable voltage detector (PVD) that monitors the  $V_{DD}/V_{DDA}$  power supply and compares it to the  $V_{PVD}$  threshold. This PVD offers 7 different levels between 1.85 V and 3.05 V, chosen by software, with a step around 200 mV. An interrupt can be generated when  $V_{DD}/V_{DDA}$  drops below the  $V_{PVD}$  threshold and/or when  $V_{DD}/V_{DDA}$  is higher than the  $V_{PVD}$  threshold. The interrupt service routine can then generate a warning message and/or put the MCU into a safe state. The PVD is enabled by software.

### 3.3.3 Voltage regulator

The regulator has three operation modes: main (MR), low-power (LPR) and power down.

- MR is used in Run mode (nominal regulation)
- LPR is used in the Low-power run, Low-power sleep and Stop modes
- Power down is used in Standby mode. The regulator output is high impedance, the kernel circuitry is powered down, inducing zero consumption but the contents of the registers and RAM are lost except for the standby circuitry (wake-up logic, IWDG, RTC, LSI, LSE crystal 32K osc, RCC\_CSR).

### 3.3.4 Boot modes

At startup, boot pins are used to select one of three boot options:

- Boot from Flash memory
- Boot from System Memory
- Boot from embedded RAM

The boot loader is located in System Memory. It is used to reprogram the Flash memory by using USART1 or USART2. See the application note “STM32 microcontroller system memory boot mode” (AN2606) for details.

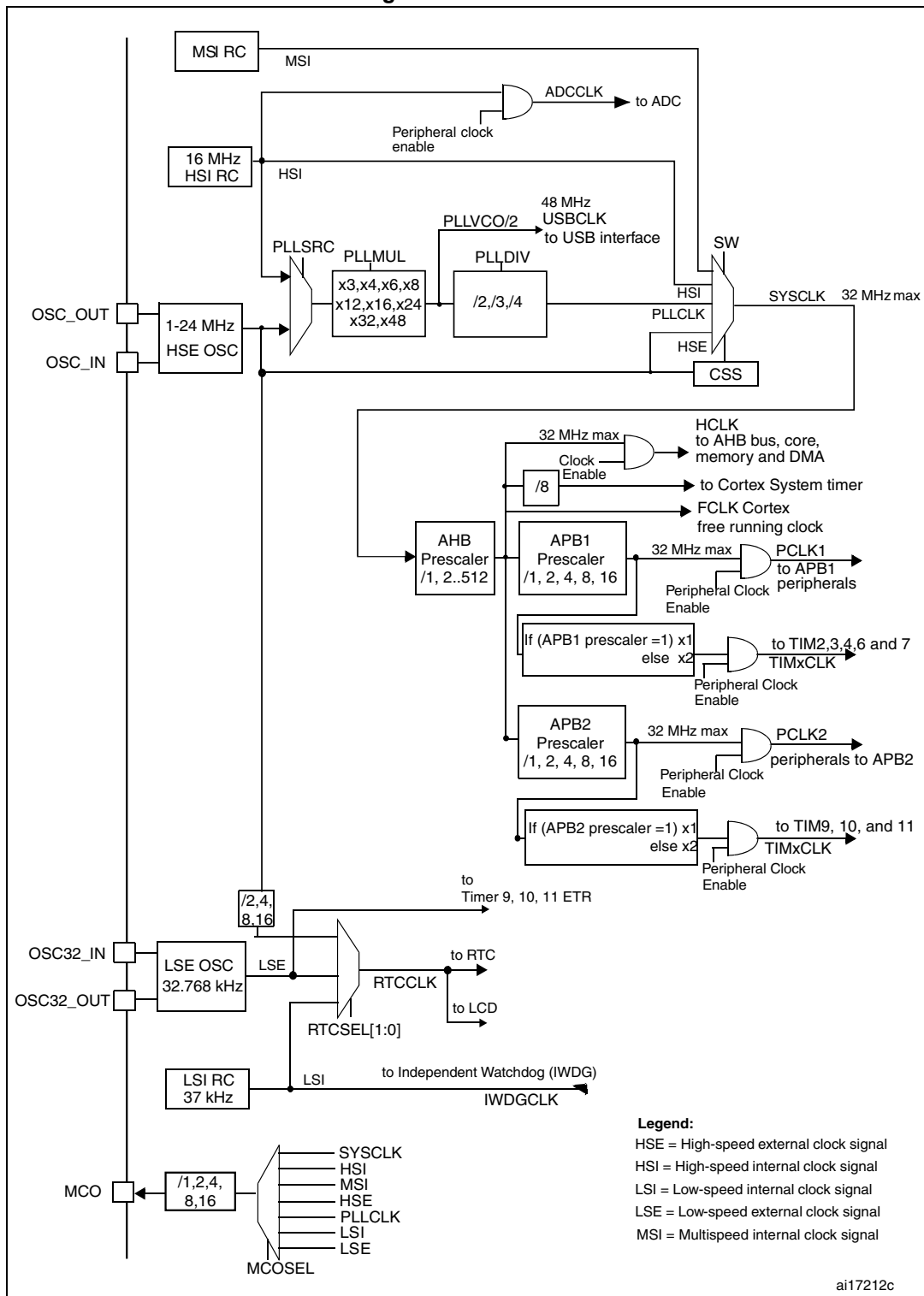
### 3.4 Clock management

The clock controller distributes the clocks coming from different oscillators to the core and the peripherals. It also manages clock gating for low-power modes and ensures clock robustness. It features:

- **Clock prescaler:** to get the best trade-off between speed and current consumption, the clock frequency to the CPU and peripherals can be adjusted by a programmable prescaler
- **Safe clock switching:** clock sources can be changed safely on the fly in run mode through a configuration register.
- **Clock management:** to reduce power consumption, the clock controller can stop the clock to the core, individual peripherals or memory.
- **Master clock source:** three different clock sources can be used to drive the master clock:
  - 1-24 MHz high-speed external crystal (HSE), that can supply a PLL
  - 16 MHz high-speed internal RC oscillator (HSI), trimmable by software, that can supply a PLL
  - Multispeed internal RC oscillator (MSI), trimmable by software, able to generate 7 frequencies (65.5 kHz, 131 kHz, 262 kHz, 524 kHz, 1.05 MHz, 2.1 MHz, 4.2 MHz) with a consumption proportional to speed, down to 750 nA typical. When a 32.768 kHz clock source is available in the system (LSE), the MSI frequency can be trimmed by software down to a  $\pm 0.5\%$  accuracy.
- **Auxiliary clock source:** two ultra-low-power clock sources that can be used to drive the LCD controller and the real-time clock:
  - 32.768 kHz low-speed external crystal (LSE)
  - 37 kHz low-speed internal RC (LSI), also used to drive the independent watchdog. The LSI clock can be measured using the high-speed internal RC oscillator for greater precision.
- **RTC and LCD clock sources:** the LSI, LSE or HSE sources can be chosen to clock the RTC and the LCD, whatever the system clock.
- **USB clock source:** the embedded PLL has a dedicated 48 MHz clock output to supply the USB interface.
- **Startup clock:** after reset, the microcontroller restarts by default with an internal 2.1 MHz clock (MSI). The prescaler ratio and clock source can be changed by the application program as soon as the code execution starts.
- **Clock security system (CSS):** this feature can be enabled by software. If a HSE clock failure occurs, the master clock is automatically switched to HSI and a software interrupt is generated if enabled.
- **Clock-out capability (MCO: microcontroller clock output):** it outputs one of the internal clocks for external use by the application.

Several prescalers allow the configuration of the AHB frequency, the high-speed APB (APB2) and the low-speed APB (APB1) domains. The maximum frequency of the AHB and the APB domains is 32 MHz. See [Figure 2](#) for details on the clock tree.

Figure 2. Clock tree



### 3.5 Low-power real-time clock and backup registers

The real-time clock (RTC) is an independent BCD timer/counter. Dedicated registers contain the sub-second, second, minute, hour (12/24 hour), week day, date, month, year, in BCD (binary-coded decimal) format. Correction for 28, 29 (leap year), 30, and 31 day of the month are made automatically. The RTC provides two programmable alarms and programmable periodic interrupts with wakeup from Stop and Standby modes.

The programmable wakeup time ranges from 120  $\mu$ s to 36 hours.

The RTC can be calibrated with an external 512 Hz output, and a digital compensation circuit helps reduce drift due to crystal deviation. The RTC can also be automatically corrected with a 50/60Hz stable power line.

The RTC calendar can be updated on the fly down to sub second precision, which enables network system synchronization. A time stamp can record an external event occurrence, and generates an interrupt.

There are five 32-bit backup registers provided to store 20 bytes of user application data. They are cleared in case of tamper detection. Three pins can be used to detect tamper events. A change on one of these pins can reset backup register and generate an interrupt. To prevent false tamper event, like ESD event, these three tamper inputs can be digitally filtered.

### 3.6 GPIOs (general-purpose inputs/outputs)

Each of the GPIO pins can be configured by software as output (push-pull or open-drain), as input (with or without pull-up or pull-down) or as peripheral alternate function. Most of the GPIO pins are shared with digital or analog alternate functions, and can be individually remapped using dedicated AFIO registers. All GPIOs are high current capable. The alternate function configuration of I/Os can be locked if needed following a specific sequence in order to avoid spurious writing to the I/O registers. The I/O controller is connected to the AHB with a toggling speed of up to 16 MHz.

#### External interrupt/event controller (EXTI)

The external interrupt/event controller consists of 23 edge detector lines used to generate interrupt/event requests. Each line can be individually configured to select the trigger event (rising edge, falling edge, both) and can be masked independently. A pending register maintains the status of the interrupt requests. The EXTI can detect an external line with a pulse width shorter than the Internal APB2 clock period. Up to 51 GPIOs can be connected to the 16 external interrupt lines. The 7 other lines are connected to RTC, PVD, USB or Comparator events.

### 3.7 Memories

The STM32L100x6/8/B-A devices have the following features:

- Up to 16 Kbytes of embedded RAM accessed (read/write) at CPU clock speed with 0 wait states. With the enhanced bus matrix, operating the RAM does not lead to any performance penalty during accesses to the system bus (AHB and APB buses).
- The non-volatile memory is divided into three arrays:
  - 32, 64 or 128 Kbytes of embedded Flash program memory
  - 2 Kbytes of data EEPROM
  - Options bytes

The options bytes are used to write-protect the memory (with 4 Kbytes granularity) and/or readout-protect the whole memory with the following options:

- Level 0: no readout protection
- Level 1: memory readout protection, the Flash memory cannot be read from or written to if either debug features are connected or boot in RAM is selected
- Level 2: chip readout protection, debug features (Cortex-M3 JTAG and serial wire) and boot in RAM selection disabled (JTAG fuse)

The whole non-volatile memory embeds the error correction code (ECC) feature.

### 3.8 DMA (direct memory access)

The flexible 7-channel, general-purpose DMA is able to manage memory-to-memory, peripheral-to-memory and memory-to-peripheral transfers. The DMA controller supports circular buffer management, avoiding the generation of interrupts when the controller reaches the end of the buffer.

Each channel is connected to dedicated hardware DMA requests, with software trigger support for each channel. Configuration is done by software and transfer sizes between source and destination are independent.

The DMA can be used with the main peripherals: SPI, I<sup>2</sup>C, USART, general-purpose timers and ADC.

### 3.9 LCD (liquid crystal display)

The LCD drives up to 8 common terminals and 32 segment terminals to drive up to 224 pixels.

- Internal step-up converter to guarantee functionality and contrast control irrespective of  $V_{DD}$ . This converter can be deactivated, in which case the  $V_{LCD}$  pin is used to provide the voltage to the LCD
- Supports static, 1/2, 1/3, 1/4 and 1/8 duty
- Supports static, 1/2, 1/3 and 1/4 bias
- Phase inversion to reduce power consumption and EMI
- Up to 8 pixels can be programmed to blink
- Unneeded segments and common pins can be used as general I/O pins
- LCD RAM can be updated at any time owing to a double-buffer
- The LCD controller can operate in Stop mode
- $V_{LCD}$  rail decoupling capability

**Table 6.  $V_{LCD}$  rail decoupling**

|                | Bias          |               |               | Pin  |
|----------------|---------------|---------------|---------------|------|
|                | 1/2           | 1/3           | 1/4           |      |
| $V_{LCDrail1}$ | 1/2 $V_{LCD}$ | 2/3 $V_{LCD}$ | 1/2 $V_{LCD}$ | PB2  |
| $V_{LCDrail2}$ | NA            | 1/3 $V_{LCD}$ | 1/4 $V_{LCD}$ | PB12 |
| $V_{LCDrail3}$ | NA            | NA            | 3/4 $V_{LCD}$ | PB0  |

### 3.10 ADC (analog-to-digital converter)

A 12-bit analog-to-digital converters is embedded into STM32L100x6/8/B-A devices with up to 20 external channels, performing conversions in single-shot or scan mode. In scan mode, automatic conversion is performed on a selected group of analog inputs.

The ADC can be served by the DMA controller.

An analog watchdog feature allows very precise monitoring of the converted voltage of one, some or all selected channels. An interrupt is generated when the converted voltage is outside the programmed thresholds.

The events generated by the general-purpose timers (TIMx) can be internally connected to the ADC start trigger and injection trigger, to allow the application to synchronize A/D conversions and timers. An injection mode allows high priority conversions to be done by interrupting a scan mode which runs in as a background task.

The ADC includes a specific low-power mode. The converter is able to operate at maximum speed even if the CPU is operating at a very low frequency and has an auto-shutdown function. The ADC's runtime and analog front-end current consumption are thus minimized whatever the MCU operating mode.

#### 3.10.1 Internal voltage reference ( $V_{REFINT}$ )

The internal voltage reference ( $V_{REFINT}$ ) provides a stable (bandgap) voltage output for the ADC and Comparators.  $V_{REFINT}$  is internally connected to the ADC\_IN17 input channel. It

enables accurate monitoring of the  $V_{DD}$  value. The precise voltage of  $V_{REFINT}$  is individually measured for each part by ST during production test and stored in the system memory area. It is accessible in read-only mode see [Table 17: Embedded internal reference voltage](#).

### 3.11 DAC (digital-to-analog converter)

The two 12-bit buffered DAC channels can be used to convert two digital signals into two analog voltage signal outputs. The chosen design structure is composed of integrated resistor strings and an amplifier in non-inverting configuration.

This dual digital Interface supports the following features:

- two DAC converters: one for each output channel
- left or right data alignment in 12-bit mode
- synchronized update capability
- noise-wave generation
- triangular-wave generation
- dual DAC channels' independent or simultaneous conversions
- DMA capability for each channel (including the underrun interrupt)
- external triggers for conversion

Eight DAC trigger inputs are used in the STM32L100x6/8/B-A devices. The DAC channels are triggered through the timer update outputs that are also connected to different DMA channels.

### 3.12 Ultra-low-power comparators and reference voltage

The STM32L100x6/8/B-A devices embed two comparators sharing the same current bias and reference voltage. The reference voltage can be internal or external (coming from an I/O).

- one comparator with fixed threshold
- one comparator with rail-to-rail inputs, fast or slow mode. The threshold can be one of the following:
  - DAC output
  - External I/O
  - Internal reference voltage ( $V_{REFINT}$ ) or  $V_{REFINT}$  submultiple (1/4, 1/2, 3/4)

Both comparators can wake up from Stop mode, and be combined into a window comparator.

The internal reference voltage is available externally via a low-power / low-current output buffer (driving current capability of 1  $\mu$ A typical).

### 3.13 Routing interface

The highly flexible routing interface allows the application firmware to control the routing of different I/Os to the TIM2, TIM3 and TIM4 timer input captures. It also controls the routing of internal analog signals to ADC1, COMP1 and COMP2 and the internal reference voltage  $V_{REFINT}$ .

### 3.14 Timers and watchdogs

The ultra-low-power STM32L100x6/8/B-A devices include six general-purpose timers, two basic timers and two watchdog timers.

[Table 7](#) compares the features of the general-purpose and basic timers.

**Table 7. Timer feature comparison**

| Timer            | Counter resolution | Counter type      | Prescaler factor                | DMA request generation | Capture/compare channels | Complementary outputs |
|------------------|--------------------|-------------------|---------------------------------|------------------------|--------------------------|-----------------------|
| TIM2, TIM3, TIM4 | 16-bit             | Up, down, up/down | Any integer between 1 and 65536 | Yes                    | 4                        | No                    |
| TIM9             | 16-bit             | Up, down, up/down | Any integer between 1 and 65536 | No                     | 2                        | No                    |
| TIM10, TIM11     | 16-bit             | Up                | Any integer between 1 and 65536 | No                     | 1                        | No                    |
| TIM6, TIM7       | 16-bit             | Up                | Any integer between 1 and 65536 | Yes                    | 0                        | No                    |

### 3.14.1 General-purpose timers (TIM2, TIM3, TIM4, TIM9, TIM10 and TIM11)

There are six synchronizable general-purpose timers embedded in the STM32L100x6/8/B-A devices (see [Table 7](#) for differences).

#### TIM2, TIM3, TIM4

These timers are based on a 16-bit auto-reload up/down-counter and a 16-bit prescaler. They feature 4 independent channels each for input capture/output compare, PWM or one-pulse mode output. This gives up to 12 input captures/output compares/PWMs on the largest packages.

The TIM2, TIM3, TIM4 general-purpose timers can work together or with the TIM10, TIM11 and TIM9 general-purpose timers via the Timer Link feature for synchronization or event chaining. Their counter can be frozen in debug mode. Any of the general-purpose timers can be used to generate PWM outputs.

TIM2, TIM3, TIM4 all have independent DMA request generation.

These timers are capable of handling quadrature (incremental) encoder signals and the digital outputs from 1 to 3 hall-effect sensors.

#### TIM10, TIM11 and TIM9

TIM10 and TIM11 are based on a 16-bit auto-reload upcounter. TIM9 is based on a 16-bit auto-reload up/down counter. They include a 16-bit prescaler. TIM10 and TIM11 feature one independent channel, whereas TIM9 has two independent channels for input capture/output compare, PWM or one-pulse mode output. They can be synchronized with the TIM2, TIM3, TIM4 full-featured general-purpose timers.

They can also be used as simple time bases and be clocked by the LSE clock source (32.768 kHz) to provide time bases independent from the main CPU clock.

### 3.14.2 Basic timers (TIM6 and TIM7)

These timers are mainly used for DAC trigger generation. They can also be used as generic 16-bit time bases.

### 3.14.3 SysTick timer

This timer is dedicated to the OS, but could also be used as a standard downcounter. It is based on a 24-bit down-counter with autoreload capability and a programmable clock source. It features a maskable system interrupt generation when the counter reaches 0.

### 3.14.4 Independent watchdog (IWDG)

The independent watchdog is based on a 12-bit down-counter and 8-bit prescaler. It is clocked from an independent 37 kHz internal RC and, as it operates independently of the main clock, it can operate in Stop and Standby modes. It can be used either as a watchdog to reset the device when a problem occurs, or as a free-running timer for application timeout management. It is hardware- or software-configurable through the option bytes. The counter can be frozen in debug mode.

### 3.14.5 Window watchdog (WWDG)

The window watchdog is based on a 7-bit down-counter that can be set as free-running. It can be used as a watchdog to reset the device when a problem occurs. It is clocked from the main clock. It has an early warning interrupt capability and the counter can be frozen in debug mode.

## 3.15 Communication interfaces

### 3.15.1 I<sup>2</sup>C bus

Up to two I<sup>2</sup>C bus interfaces can operate in multimaster and slave modes. They can support standard and fast modes.

They support dual slave addressing (7-bit only) and both 7- and 10-bit addressing in master mode. A hardware CRC generation/verification is embedded.

They can be served by DMA and they support SM Bus 2.0/PM Bus.

### 3.15.2 Universal synchronous/asynchronous receiver transmitter (USART)

All USART interfaces are able to communicate at speeds of up to 4 Mbit/s. They provide hardware management of the CTS and RTS signals and are ISO 7816 compliant. They support IrDA SIR ENDEC and have LIN Master/Slave capability.

All USART interfaces can be served by the DMA controller.

### 3.15.3 Serial peripheral interface (SPI)

Up to two SPIs are able to communicate at up to 16 Mbits/s in slave and master modes in full-duplex and half-duplex communication modes. The 3-bit prescaler gives 8 master mode frequencies and the frame is configurable to 8 bits or 16 bits. The hardware CRC generation/verification supports basic SD Card/MMC modes.

Both SPIs can be served by the DMA controller.

### 3.15.4 Universal serial bus (USB)

The STM32L100x6/8/B-A devices embed a USB device peripheral compatible with the USB full speed 12 Mbit/s. The USB interface implements a full speed (12 Mbit/s) function interface. It has software-configurable endpoint setting and supports suspend/resume. The dedicated 48 MHz clock is generated from the internal main PLL (the clock source must use a HSE crystal oscillator).

### 3.16 CRC (cyclic redundancy check) calculation unit

The CRC (cyclic redundancy check) calculation unit is used to get a CRC code from a 32-bit data word and a fixed generator polynomial.

Among other applications, CRC-based techniques are used to verify data transmission or storage integrity. In the scope of the EN/IEC 60335-1 standard, they offer a means of verifying the Flash memory integrity. The CRC calculation unit helps compute a signature of the software during runtime, to be compared with a reference signature generated at link-time and stored at a given memory location.

### 3.17 Development support

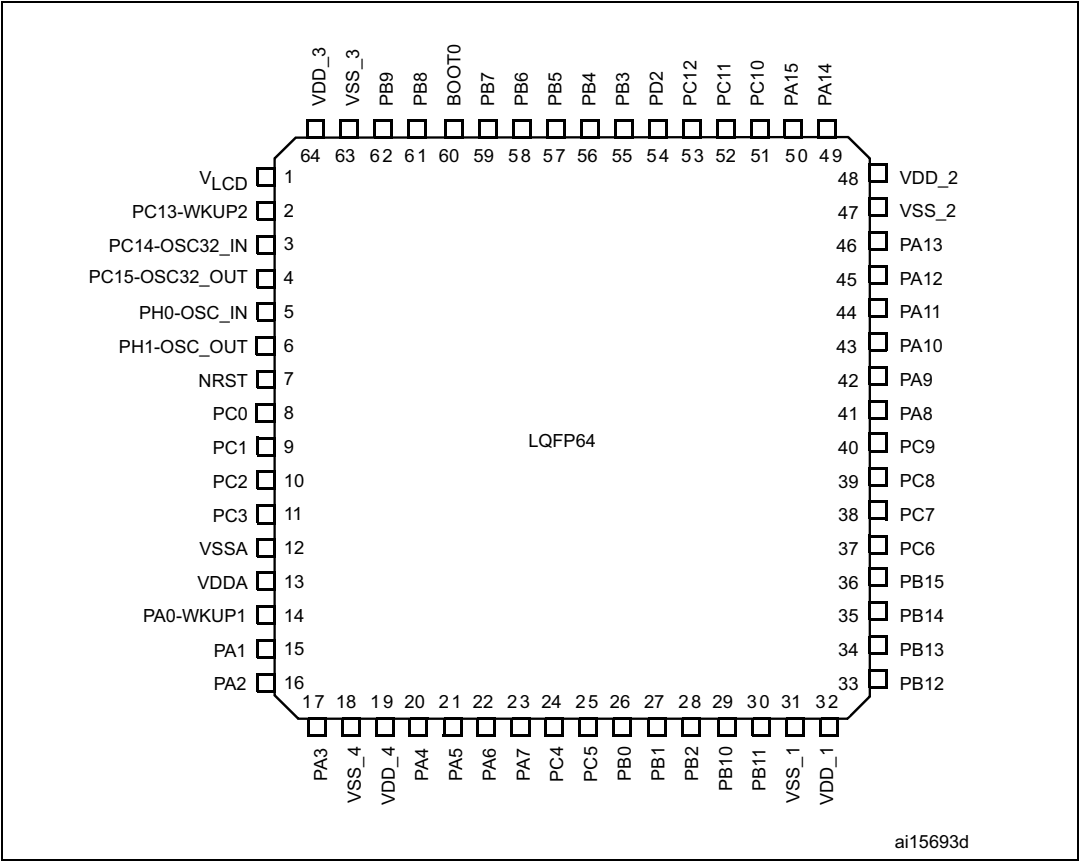
#### Serial wire JTAG debug port (SWJ-DP)

The ARM SWJ-DP interface is embedded, and is a combined JTAG and serial wire debug port that enables either a serial wire debug or a JTAG probe to be connected to the target. The JTAG JTMS and JTCK pins are shared with SWDAT and SWCLK, respectively, and a specific sequence on the JTMS pin is used to switch between JTAG-DP and SW-DP.

The JTAG port can be permanently disabled with a JTAG fuse.

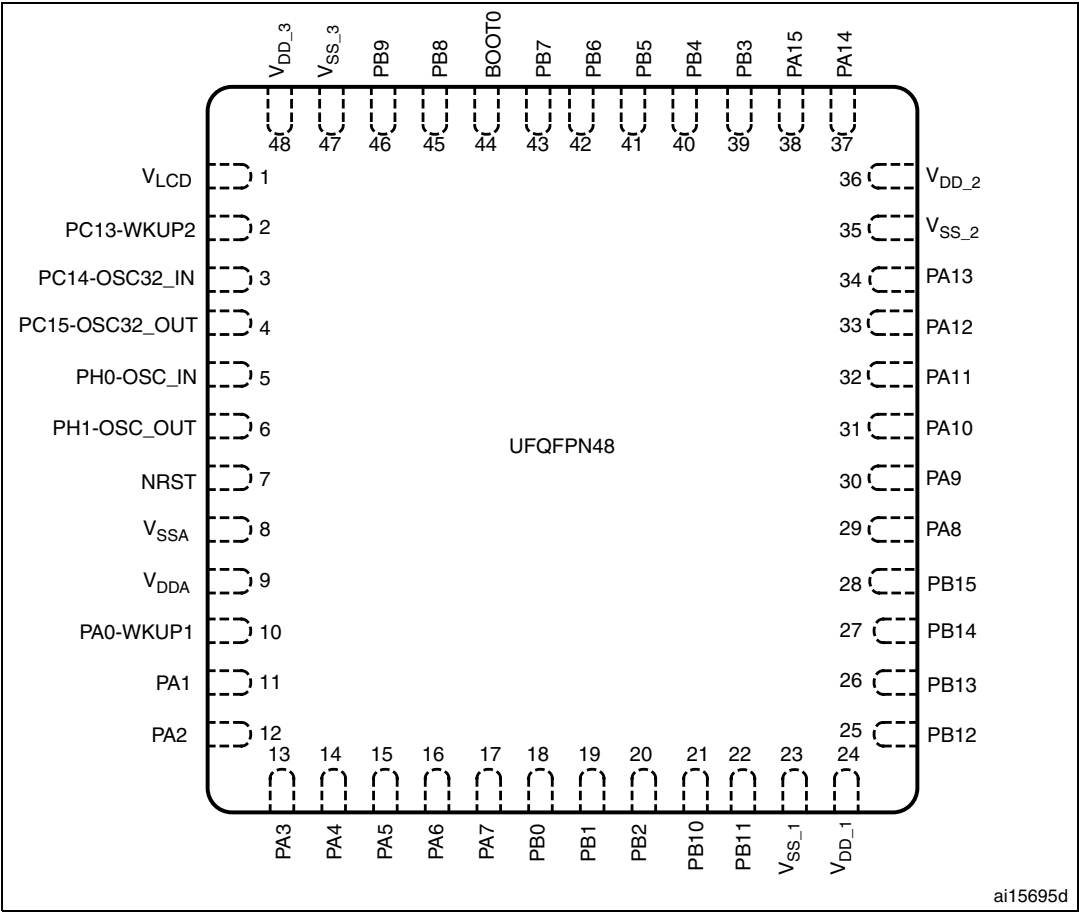
4 Pin descriptions

Figure 3. STM32L100RxxxA LQFP64 pinout



1. This figure shows the package top view.

Figure 4. STM32L100C6xxA UFQFPN48 pinout



1. This figure shows the package top view.

Table 8. Legend/abbreviations used in the pinout table

| Name          |                      | Abbreviation                                                                                                                          | Definition                                                  |
|---------------|----------------------|---------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------|
| Pin name      |                      | Unless otherwise specified in brackets below the pin name, the pin function during and after reset is the same as the actual pin name |                                                             |
| Pin type      |                      | S                                                                                                                                     | Supply pin                                                  |
|               |                      | I                                                                                                                                     | Input only pin                                              |
|               |                      | I/O                                                                                                                                   | Input / output pin                                          |
| I/O structure |                      | FT                                                                                                                                    | 5 V tolerant I/O                                            |
|               |                      | TC                                                                                                                                    | Standard 3.3 V I/O                                          |
|               |                      | B                                                                                                                                     | Dedicated BOOT0 pin                                         |
|               |                      | RST                                                                                                                                   | Bidirectional reset pin with embedded weak pull-up resistor |
| Notes         |                      | Unless otherwise specified by a note, all I/Os are set as floating inputs during and after reset                                      |                                                             |
| Pin functions | Alternate functions  | Functions selected through GPIOx_AFR registers                                                                                        |                                                             |
|               | Additional functions | Functions directly selected/enabled through peripheral registers                                                                      |                                                             |

Table 9. STM32L100x6/8/B-A pin definitions

| Pins   |          | Pin name                          | Pin type <sup>(1)</sup> | I/O structure | Main function <sup>(2)</sup><br>(after reset) | Pin functions                            |                                        |
|--------|----------|-----------------------------------|-------------------------|---------------|-----------------------------------------------|------------------------------------------|----------------------------------------|
| LQFP64 | UFQFPN48 |                                   |                         |               |                                               | Alternate functions                      | Additional functions                   |
| 1      | 1        | V <sub>LCD</sub>                  | S                       | -             | V <sub>LCD</sub>                              | -                                        | -                                      |
| 2      | 2        | PC13-WKUP2                        | I/O                     | FT            | PC13                                          | -                                        | RTC_TAMP1/<br>RTC_TS/<br>RTC_OUT/WKUP2 |
| 3      | 3        | PC14-<br>OSC32_IN <sup>(3)</sup>  | I/O                     | TC            | PC14                                          | -                                        | OSC32_IN                               |
| 4      | 4        | PC15-<br>OSC32_OUT <sup>(4)</sup> | I/O                     | TC            | PC15                                          | -                                        | OSC32_OUT                              |
| 5      | 5        | PH0-OSC_IN <sup>(4)</sup>         | I/O                     | TC            | PH0                                           | -                                        | OSC_IN                                 |
| 6      | 6        | PH1-OSC_OUT                       | I/O                     | TC            | PH1                                           | -                                        | OSC_OUT                                |
| 7      | 7        | NRST                              | I/O                     | RST           | NRST                                          | -                                        | -                                      |
| 8      | -        | PC0                               | I/O                     | FT            | PC0                                           | LCD_SEG18                                | ADC_IN10/<br>COMP1_INP                 |
| 9      | -        | PC1                               | I/O                     | FT            | PC1                                           | LCD_SEG19                                | ADC_IN11/<br>COMP1_INP                 |
| 10     | -        | PC2                               | I/O                     | FT            | PC2                                           | LCD_SEG20                                | ADC_IN12/<br>COMP1_INP                 |
| 11     | -        | PC3                               | I/O                     | TC            | PC3                                           | LCD_SEG21                                | ADC_IN13/<br>COMP1_INP                 |
| 12     | 8        | V <sub>SSA</sub>                  | S                       | -             | V <sub>SSA</sub>                              | -                                        | -                                      |
| 13     | 9        | V <sub>DDA</sub>                  | S                       | -             | V <sub>DDA</sub>                              | -                                        | -                                      |
| 14     | 10       | PA0-WKUP1                         | I/O                     | FT            | PA0                                           | USART2_CTS/<br>TIM2_CH1_ETR              | WKUP1/ADC_IN0/<br>COMP1_INP            |
| 15     | 11       | PA1                               | I/O                     | FT            | PA1                                           | USART2_RTS/TIM2_CH2/<br>LCD_SEG0         | ADC_IN1/<br>COMP1_INP                  |
| 16     | 12       | PA2                               | I/O                     | FT            | PA2                                           | USART2_TX/TIM2_CH3/<br>TIM9_CH1/LCD_SEG1 | ADC_IN2/<br>COMP1_INP                  |
| 17     | 13       | PA3                               | I/O                     | TC            | PA3                                           | USART2_RX/TIM2_CH4/<br>TIM9_CH2/LCD_SEG2 | ADC_IN3/<br>COMP1_INP                  |
| 18     | -        | V <sub>SS_4</sub>                 | S                       | -             | V <sub>SS_4</sub>                             | -                                        | -                                      |
| 19     | -        | V <sub>DD_4</sub>                 | S                       | -             | V <sub>DD_4</sub>                             | -                                        | -                                      |

Table 9. STM32L100x6/8/B-A pin definitions (continued)

| Pins   |          | Pin name          | Pin type <sup>(1)</sup> | I/O structure | Main function <sup>(2)</sup><br>(after reset) | Pin functions                                                |                                    |
|--------|----------|-------------------|-------------------------|---------------|-----------------------------------------------|--------------------------------------------------------------|------------------------------------|
| LQFP64 | UFQFPN48 |                   |                         |               |                                               | Alternate functions                                          | Additional functions               |
| 20     | 14       | PA4               | I/O                     | TC            | PA4                                           | SPI1_NSS/USART2_CK                                           | ADC_IN4/<br>DAC_OUT1/<br>COMP1_INP |
| 21     | 15       | PA5               | I/O                     | TC            | PA5                                           | SPI1_SCK/TIM2_CH1_ETR                                        | ADC_IN5/<br>DAC_OUT2/<br>COMP1_INP |
| 22     | 16       | PA6               | I/O                     | FT            | PA6                                           | SPI1_MISO/TIM3_CH1/<br>LCD_SEG3/TIM10_CH1                    | ADC_IN6/<br>COMP1_INP              |
| 23     | 17       | PA7               | I/O                     | FT            | PA7                                           | SPI1_MOSI/TIM3_CH2/<br>LCD_SEG4/TIM11_CH1                    | ADC_IN7/<br>COMP1_INP              |
| 24     | -        | PC4               | I/O                     | FT            | PC4                                           | LCD_SEG22                                                    | ADC_IN14/<br>COMP1_INP             |
| 25     | -        | PC5               | I/O                     | FT            | PC5                                           | LCD_SEG23                                                    | ADC_IN15/<br>COMP1_INP             |
| 26     | 18       | PB0               | I/O                     | TC            | PB0                                           | TIM3_CH3/LCD_SEG5                                            | ADC_IN8/<br>COMP1_INP/<br>VREF_OUT |
| 27     | 19       | PB1               | I/O                     | FT            | PB1                                           | TIM3_CH4/LCD_SEG6                                            | ADC_IN9/<br>COMP1_INP/<br>VREF_OUT |
| 28     | 20       | PB2               | I/O                     | FT            | PB2/BOOT1                                     | BOOT1                                                        | -                                  |
| 29     | 21       | PB10              | I/O                     | FT            | PB10                                          | I2C2_SCL/USART3_TX/<br>TIM2_CH3/<br>LCD_SEG10                | -                                  |
| 30     | 22       | PB11              | I/O                     | FT            | PB11                                          | I2C2_SDA/USART3_RX/<br>TIM2_CH4/LCD_SEG11                    | -                                  |
| 31     | 23       | V <sub>SS_1</sub> | S                       | -             | V <sub>SS_1</sub>                             | -                                                            | -                                  |
| 32     | 24       | V <sub>DD_1</sub> | S                       | -             | V <sub>DD_1</sub>                             | -                                                            | -                                  |
| 33     | 25       | PB12              | I/O                     | FT            | PB12                                          | SPI2_NSS/I2C2_SMBA/<br>USART3_CK/<br>LCD_SEG12/<br>TIM10_CH1 | ADC_IN18/<br>COMP1_INP/            |
| 34     | 26       | PB13              | I/O                     | FT            | PB13                                          | SPI2_SCK/USART3_CTS/<br>LCD_SEG13/TIM9_CH1                   | ADC_IN19/<br>COMP1_INP             |

Table 9. STM32L100x6/8/B-A pin definitions (continued)

| Pins   |          | Pin name          | Pin type <sup>(1)</sup> | I/O structure | Main function <sup>(2)</sup><br>(after reset) | Pin functions                                     |                                      |
|--------|----------|-------------------|-------------------------|---------------|-----------------------------------------------|---------------------------------------------------|--------------------------------------|
| LQFP64 | UFQFPN48 |                   |                         |               |                                               | Alternate functions                               | Additional functions                 |
| 35     | 27       | PB14              | I/O                     | FT            | PB14                                          | SPI2_MISO/USART3_RTS/<br>LCD_SEG14/TIM9_CH2       | ADC_IN20/<br>COMP1_INP               |
| 36     | 28       | PB15              | I/O                     | FT            | PB15                                          | SPI2_MOSI/LCD_SEG15/<br>TIM11_CH1                 | ADC_IN21/<br>COMP1_INP/<br>RTC_REFIN |
| 37     | -        | PC6               | I/O                     | FT            | PC6                                           | TIM3_CH1/LCD_SEG24                                | -                                    |
| 38     | -        | PC7               | I/O                     | FT            | PC7                                           | TIM3_CH2/LCD_SEG25                                | -                                    |
| 39     | -        | PC8               | I/O                     | FT            | PC8                                           | TIM3_CH3/LCD_SEG26                                | -                                    |
| 40     | -        | PC9               | I/O                     | FT            | PC9                                           | TIM3_CH4/LCD_SEG27                                | -                                    |
| 41     | 29       | PA8               | I/O                     | FT            | PA8                                           | USART1_CK/MCO/LCD_COM0                            | -                                    |
| 42     | 30       | PA9               | I/O                     | FT            | PA9                                           | USART1_TX/LCD_COM1                                | -                                    |
| 43     | 31       | PA10              | I/O                     | FT            | PA10                                          | USART1_RX/LCD_COM2                                | -                                    |
| 44     | 32       | PA11              | I/O                     | FT            | PA11                                          | USART1_CTS/SPI1_MISO                              | USB_DM                               |
| 45     | 33       | PA12              | I/O                     | FT            | PA12                                          | USART1_RTS/SPI1_MOSI                              | USB_DP                               |
| 46     | 34       | PA13              | I/O                     | FT            | JTMS-SWDIO                                    | JTMS-SWDIO                                        | -                                    |
| 47     | 35       | V <sub>SS_2</sub> | S                       | -             | V <sub>SS_2</sub>                             | -                                                 | -                                    |
| 48     | 36       | V <sub>DD_2</sub> | S                       | -             | V <sub>DD_2</sub>                             | -                                                 | -                                    |
| 49     | 37       | PA14              | I/O                     | FT            | JTCK-SWCLK                                    | JTCK-SWCLK                                        | -                                    |
| 50     | 38       | PA15              | I/O                     | FT            | JTDI                                          | TIM2_CH1_ETR/PA15/<br>SPI1_NSS/<br>LCD_SEG17/JTDI | -                                    |
| 51     | -        | PC10              | I/O                     | FT            | PC10                                          | USART3_TX/LCD_SEG28/<br>LCD_SEG40/<br>LCD_COM4    | -                                    |
| 52     | -        | PC11              | I/O                     | FT            | PC11                                          | USART3_RX/LCD_SEG29/<br>LCD_SEG41/<br>LCD_COM5    | -                                    |
| 53     | -        | PC12              | I/O                     | FT            | PC12                                          | USART3_CK/LCD_SEG30/<br>LCD_SEG42/<br>LCD_COM6    | -                                    |
| 54     | -        | PD2               | I/O                     | FT            | PD2                                           | TIM3_ETR/LCD_SEG31/<br>LCD_SEG43/<br>LCD_COM7     | -                                    |

Table 9. STM32L100x6/8/B-A pin definitions (continued)

| Pins   |          | Pin name          | Pin type <sup>(1)</sup> | I/O structure | Main function <sup>(2)</sup><br>(after reset) | Pin functions                                 |                      |
|--------|----------|-------------------|-------------------------|---------------|-----------------------------------------------|-----------------------------------------------|----------------------|
| LQFP64 | UFQFPN48 |                   |                         |               |                                               | Alternate functions                           | Additional functions |
| 55     | 39       | PB3               | I/O                     | FT            | JTDO                                          | TIM2_CH2/PB3/SPI1_SCK/<br>LCD_SEG7/JTDO       | COMP2_INM            |
| 56     | 40       | PB4               | I/O                     | FT            | NJTRST                                        | TIM3_CH1/PB4/SPI1_MISO/<br>LCD_SEG8/NJTRST    | COMP2_INP            |
| 57     | 41       | PB5               | I/O                     | FT            | PB5                                           | I2C1_SMBA/TIM3_CH2/<br>SPI1_MOSI/LCD_SEG9     | COMP2_INP            |
| 58     | 42       | PB6               | I/O                     | FT            | PB6                                           | I2C1_SCL/TIM4_CH1/<br>USART1_TX               | -                    |
| 59     | 43       | PB7               | I/O                     | FT            | PB7                                           | I2C1_SDA/TIM4_CH2/<br>USART1_RX               | PVD_IN               |
| 60     | 44       | BOOT0             | I                       | B             | BOOT0                                         | -                                             | -                    |
| 61     | 45       | PB8               | I/O                     | FT            | PB8                                           | TIM4_CH3/I2C1_SCL/<br>LCD_SEG16/<br>TIM10_CH1 | -                    |
| 62     | 46       | PB9               | I/O                     | FT            | PB9                                           | TIM4_CH4/I2C1_SDA/<br>LCD_COM3/<br>TIM11_CH1  | -                    |
| 63     | 47       | V <sub>SS_3</sub> | S                       | -             | V <sub>SS_3</sub>                             | -                                             | -                    |
| 64     | 48       | V <sub>DD_3</sub> | S                       | -             | V <sub>DD_3</sub>                             | -                                             | -                    |

1. I = input, O = output, S = supply.

2. Function availability depends on the chosen device. For devices having reduced peripheral counts, it is always the lower number of peripheral that is included. For example, if a device has only one SPI and two USARTs, they will be called SPI1 and USART1 & USART2, respectively. Refer to [Table 2 on page 10](#).

3. The PC14 and PC15 I/Os are only configured as OSC32\_IN/OSC32\_OUT when the LSE oscillator is on (by setting the LSEON bit in the RCC\_CSR register). The LSE oscillator pins OSC32\_IN/OSC32\_OUT can be used as general-purpose PC14/PC15 I/Os, respectively, when the LSE oscillator is off (after reset, the LSE oscillator is off). The LSE has priority over the GPIO function. For more details, refer to Using the OSC32\_IN/OSC32\_OUT pins as GPIO PC14/PC15 port pins section in the STM32L1xxx reference manual (RM0038).

4. The PH0 and PH1 I/Os are only configured as OSC\_IN/OSC\_OUT when the HSE oscillator is on (by setting the HSEON bit in the RCC\_CR register). The HSE oscillator pins OSC\_IN/OSC\_OUT can be used as general-purpose PH0/PH1 I/Os, respectively, when the HSE oscillator is off (after reset, the HSE oscillator is off). The HSE has priority over the GPIO function.

Table 10. Alternate function input/output

| Port name | Digital alternate function number |              |          |            |        |           |       |            |       |       |        |        |        |          |          |
|-----------|-----------------------------------|--------------|----------|------------|--------|-----------|-------|------------|-------|-------|--------|--------|--------|----------|----------|
|           | AFIO0                             | AFIO1        | AFIO2    | AFIO3      | AFIO4  | AFIO5     | AFIO6 | AFIO7      | AFIO8 | AFIO9 | AFIO11 | AFIO12 | AFIO13 | AFIO14   | AFIO15   |
|           | Alternate function                |              |          |            |        |           |       |            |       |       |        |        |        |          |          |
|           | SYSTEM                            | TIM2         | TIM3/4   | TIM9/10/11 | I2C1/2 | SPI1/2    | N/A   | USART1/2/3 | N/A   | N/A   | LCD    | N/A    | N/A    | RI       | SYSTEM   |
| BOOT0     | BOOT0                             | -            | -        | -          | -      | -         | -     | -          | -     | -     | -      | -      | -      | -        | -        |
| NRST      | NRST                              | -            | -        | -          | -      | -         | -     | -          | -     | -     | -      | -      | -      | -        | -        |
| PA0-WKUP1 | -                                 | TIM2_CH1_ETR | -        | -          | -      | -         | -     | USART2_CTS | -     | -     | -      | -      | -      | TIMx_IC1 | EVENTOUT |
| PA1       | -                                 | TIM2_CH2     | -        | -          | -      | -         | -     | USART2_RTS | -     | -     | [SEG0] | -      | -      | TIMx_IC2 | EVENTOUT |
| PA2       | -                                 | TIM2_CH3     | -        | TIM9_CH1   | -      | -         | -     | USART2_TX  | -     | -     | [SEG1] | -      | -      | TIMx_IC3 | EVENTOUT |
| PA3       | -                                 | TIM2_CH4     | -        | TIM9_CH2   | -      | -         | -     | USART2_RX  | -     | -     | [SEG2] | -      | -      | TIMx_IC4 | EVENTOUT |
| PA4       | -                                 | -            | -        | -          | -      | SPI1_NSS  | -     | USART2_CK  | -     | -     | -      | -      | -      | TIMx_IC1 | EVENTOUT |
| PA5       | -                                 | TIM2_CH1_ETR | -        | -          | -      | SPI1_SCK  | -     | -          | -     | -     | -      | -      | -      | TIMx_IC2 | EVENTOUT |
| PA6       | -                                 | -            | TIM3_CH1 | TIM10_CH1  | -      | SPI1_MISO | -     | -          | -     | -     | [SEG3] | -      | -      | TIMx_IC3 | EVENTOUT |
| PA7       | -                                 | -            | TIM3_CH2 | TIM11_CH1  | -      | SPI1_MOSI | -     | -          | -     | -     | [SEG4] | -      | -      | TIMx_IC4 | EVENTOUT |
| PA8       | MCO                               | -            | -        | -          | -      | -         | -     | USART1_CK  | -     | -     | [COM0] | -      | -      | TIMx_IC1 | EVENTOUT |
| PA9       | -                                 | -            | -        | -          | -      | -         | -     | USART1_TX  | -     | -     | [COM1] | -      | -      | TIMx_IC2 | EVENTOUT |
| PA10      | -                                 | -            | -        | -          | -      | -         | -     | USART1_RX  | -     | -     | [COM2] | -      | -      | TIMx_IC3 | EVENTOUT |
| PA11      | -                                 | -            | -        | -          | -      | SPI1_MISO | -     | USART1_CTS | -     | -     | -      | -      | -      | TIMx_IC4 | EVENTOUT |
| PA12      | -                                 | -            | -        | -          | -      | SPI1_MOSI | -     | USART1_RTS | -     | -     | -      | -      | -      | TIMx_IC1 | EVENTOUT |
| PA13      | JTMS-SWDIO                        | -            | -        | -          | -      | -         | -     | -          | -     | -     | -      | -      | -      | TIMx_IC2 | EVENTOUT |
| PA14      | JTCK-SWCLK                        | -            | -        | -          | -      | -         | -     | -          | -     | -     | -      | -      | -      | TIMx_IC3 | EVENTOUT |
| PA15      | JTDI                              | TIM2_CH1_ETR | -        | -          | -      | SPI1_NSS  | -     | -          | -     | -     | SEG17  | -      | -      | TIMx_IC4 | EVENTOUT |
| PB0       | -                                 | -            | TIM3_CH3 | -          | -      | -         | -     | -          | -     | -     | [SEG5] | -      | -      | -        | EVENTOUT |
| PB1       | -                                 | -            | TIM3_CH4 | -          | -      | -         | -     | -          | -     | -     | [SEG6] | -      | -      | -        | EVENTOUT |
| PB2       | BOOT1                             | -            | -        | -          | -      | -         | -     | -          | -     | -     | -      | -      | -      | -        | EVENTOUT |
| PB3       | JTDO                              | TIM2_CH2     | -        | -          | -      | SPI1_SCK  | -     | -          | -     | -     | [SEG7] | -      | -      | -        | EVENTOUT |



Table 10. Alternate function input/output (continued)

| Port name | Digital alternate function number |          |          |            |           |           |       |            |       |       |        |        |        |          |          |
|-----------|-----------------------------------|----------|----------|------------|-----------|-----------|-------|------------|-------|-------|--------|--------|--------|----------|----------|
|           | AFIO0                             | AFIO1    | AFIO2    | AFIO3      | AFIO4     | AFIO5     | AFIO6 | AFIO7      | AFIO8 | AFIO9 | AFIO11 | AFIO12 | AFIO13 | AFIO14   | AFIO15   |
|           | Alternate function                |          |          |            |           |           |       |            |       |       |        |        |        |          |          |
|           | SYSTEM                            | TIM2     | TIM3/4   | TIM9/10/11 | I2C1/2    | SPI1/2    | N/A   | USART1/2/3 | N/A   | N/A   | LCD    | N/A    | N/A    | RI       | SYSTEM   |
| PB4       | NJTRST                            | -        | TIM3_CH1 | -          | -         | SPI1_MISO | -     | -          | -     | -     | [SEG8] | -      | -      | -        | EVENTOUT |
| PB5       | -                                 | -        | TIM3_CH2 | -          | I2C1_SMBA | SPI1_MOSI | -     | -          | -     | -     | [SEG9] | -      | -      | -        | EVENTOUT |
| PB6       | -                                 | -        | TIM4_CH1 | -          | I2C1_SCL  | -         | -     | USART1_TX  | -     | -     | -      | -      | -      | -        | EVENTOUT |
| PB7       | -                                 | -        | TIM4_CH2 | -          | I2C1_SDA  | -         | -     | USART1_RX  | -     | -     | -      | -      | -      | -        | EVENTOUT |
| PB8       | -                                 | -        | TIM4_CH3 | TIM10_CH1* | I2C1_SCL  | -         | -     | -          | -     | -     | SEG16  | -      | -      | -        | EVENTOUT |
| PB9       | -                                 | -        | TIM4_CH4 | TIM11_CH1* | I2C1_SDA  | -         | -     | -          | -     | -     | [COM3] | -      | -      | -        | EVENTOUT |
| PB10      | -                                 | TIM2_CH3 | -        | -          | I2C2_SCL  | -         | -     | USART3_TX  | -     | -     | SEG10  | -      | -      | -        | EVENTOUT |
| PB11      | -                                 | TIM2_CH4 | -        | -          | I2C2_SDA  | -         | -     | USART3_RX  | -     | -     | SEG11  | -      | -      | -        | EVENTOUT |
| PB12      | -                                 | -        | -        | TIM10_CH1  | I2C2_SMBA | SPI2_NSS  | -     | USART3_CK  | -     | -     | SEG12  | -      | -      | -        | EVENTOUT |
| PB13      | -                                 | -        | -        | TIM9_CH1   | -         | SPI2_SCK  | -     | USART3_CTS | -     | -     | SEG13  | -      | -      | -        | EVENTOUT |
| PB14      | -                                 | -        | -        | TIM9_CH2   | -         | SPI2_MISO | -     | USART3_RTS | -     | -     | SEG14  | -      | -      | -        | EVENTOUT |
| PB15      | -                                 | -        | -        | TIM11_CH1  | -         | SPI2_MOSI | -     | -          | -     | -     | SEG15  | -      | -      | -        | EVENTOUT |
| PC0       | -                                 | -        | -        | -          | -         | -         | -     | -          | -     | -     | SEG18  | -      | -      | TIMx_IC1 | EVENTOUT |
| PC1       | -                                 | -        | -        | -          | -         | -         | -     | -          | -     | -     | SEG19  | -      | -      | TIMx_IC2 | EVENTOUT |
| PC2       | -                                 | -        | -        | -          | -         | -         | -     | -          | -     | -     | SEG20  | -      | -      | TIMx_IC3 | EVENTOUT |
| PC3       | -                                 | -        | -        | -          | -         | -         | -     | -          | -     | -     | SEG21  | -      | -      | TIMx_IC4 | EVENTOUT |
| PC4       | -                                 | -        | -        | -          | -         | -         | -     | -          | -     | -     | SEG22  | -      | -      | TIMx_IC1 | EVENTOUT |
| PC5       | -                                 | -        | -        | -          | -         | -         | -     | -          | -     | -     | SEG23  | -      | -      | TIMx_IC2 | EVENTOUT |
| PC6       | -                                 | -        | TIM3_CH1 | -          | -         | -         | -     | -          | -     | -     | SEG24  | -      | -      | TIMx_IC3 | EVENTOUT |
| PC7       | -                                 | -        | TIM3_CH2 | -          | -         | -         | -     | -          | -     | -     | SEG25  | -      | -      | TIMx_IC4 | EVENTOUT |
| PC8       | -                                 | -        | TIM3_CH3 | -          | -         | -         | -     | -          | -     | -     | SEG26  | -      | -      | TIMx_IC1 | EVENTOUT |
| PC9       | -                                 | -        | TIM3_CH4 | -          | -         | -         | -     | -          | -     | -     | SEG27  | -      | -      | TIMx_IC2 | EVENTOUT |

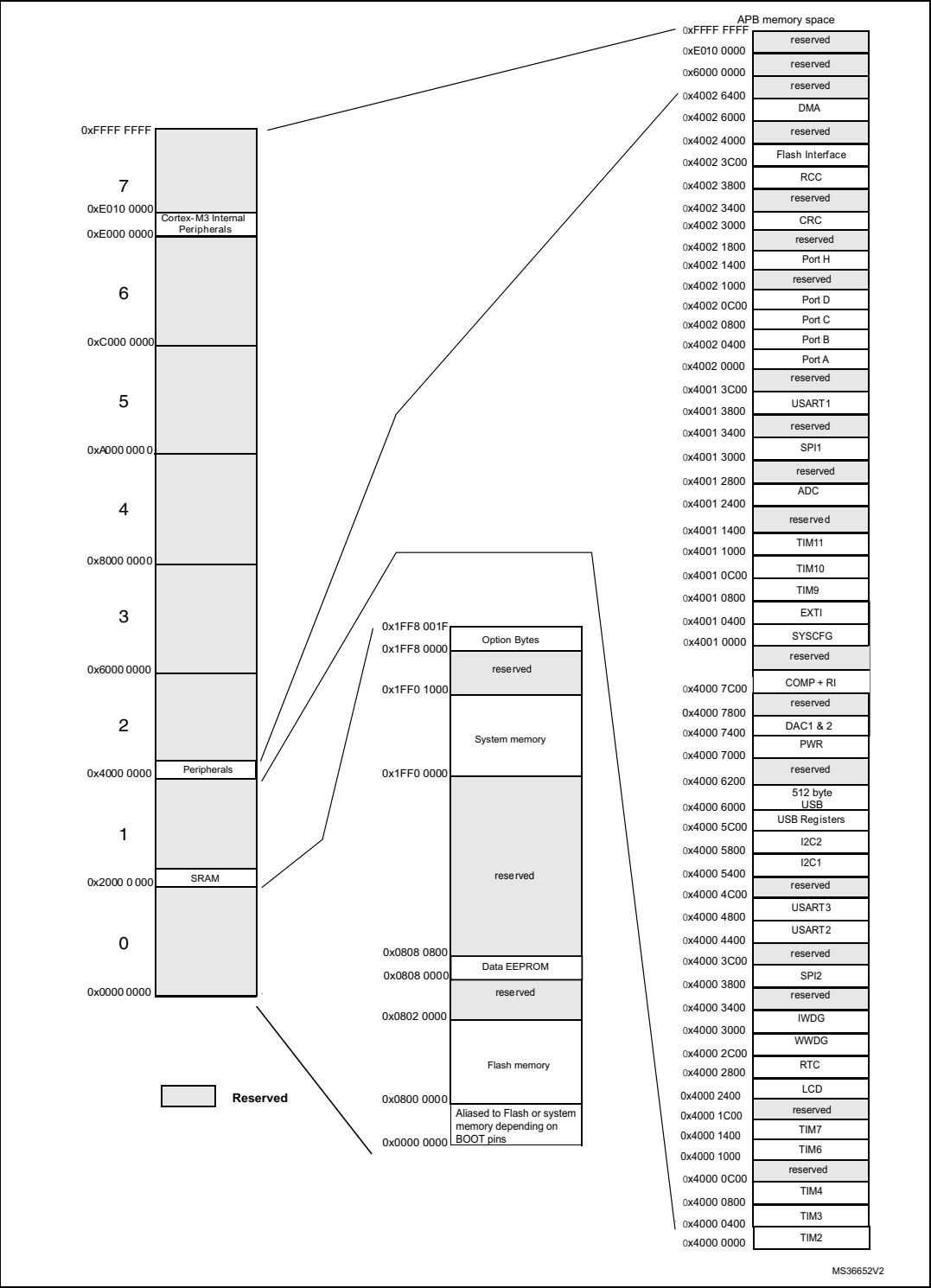
**Table 10. Alternate function input/output (continued)**

| Port name      | Digital alternate function number |       |          |            |        |        |       |            |       |       |                      |        |        |          |          |
|----------------|-----------------------------------|-------|----------|------------|--------|--------|-------|------------|-------|-------|----------------------|--------|--------|----------|----------|
|                | AFIO0                             | AFIO1 | AFIO2    | AFIO3      | AFIO4  | AFIO5  | AFIO6 | AFIO7      | AFIO8 | AFIO9 | AFIO11               | AFIO12 | AFIO13 | AFIO14   | AFIO15   |
|                | Alternate function                |       |          |            |        |        |       |            |       |       |                      |        |        |          |          |
|                | SYSTEM                            | TIM2  | TIM3/4   | TIM9/10/11 | I2C1/2 | SPI1/2 | N/A   | USART1/2/3 | N/A   | N/A   | LCD                  | N/A    | N/A    | RI       | SYSTEM   |
| PC10           | -                                 | -     | -        | -          | -      | -      | -     | USART3_TX  | -     | -     | COM4 / SEG28 / SEG40 | -      | -      | TIMx_IC3 | EVENTOUT |
| PC11           | -                                 | -     | -        | -          | -      | -      | -     | USART3_RX  | -     | -     | COM5 / SEG29 / SEG41 | -      | -      | TIMx_IC4 | EVENTOUT |
| PC12           | -                                 | -     | -        | -          | -      | -      | -     | USART3_CK  | -     | -     | COM6 / SEG30 / SEG42 | -      | -      | TIMx_IC1 | EVENTOUT |
| PC13-WKUP2     | -                                 | -     | -        | -          | -      | -      | -     | -          | -     | -     | -                    | -      | -      | TIMx_IC2 | EVENTOUT |
| PC14-OSC32_IN  | -                                 | -     | -        | -          | -      | -      | -     | -          | -     | -     | -                    | -      | -      | TIMx_IC3 | EVENTOUT |
| PC15-OSC32_OUT | -                                 | -     | -        | -          | -      | -      | -     | -          | -     | -     | -                    | -      | -      | TIMx_IC4 | EVENTOUT |
| PD2            | -                                 | -     | TIM3_ETR | -          | -      | -      | -     | -          | -     | -     | COM7 / SEG31 / SEG43 | -      | -      | TIMx_IC3 | EVENTOUT |
| PH0-OSC_IN     | -                                 | -     | -        | -          | -      | -      | -     | -          | -     | -     | -                    | -      | -      | -        | -        |
| PH1-OSC_OUT    | -                                 | -     | -        | -          | -      | -      | -     | -          | -     | -     | -                    | -      | -      | -        | -        |

# 5 Memory mapping

The memory map is shown in the following figure.

Figure 5. Memory map



## 6 Electrical characteristics

### 6.1 Parameter conditions

Unless otherwise specified, all voltages are referenced to  $V_{SS}$ .

#### 6.1.1 Minimum and maximum values

Unless otherwise specified the minimum and maximum values are guaranteed in the worst conditions of ambient temperature, supply voltage and frequencies by tests in production on 100% of the devices with an ambient temperature at  $T_A = 25\text{ }^{\circ}\text{C}$  and  $T_A = T_{A\text{max}}$  (given by the selected temperature range).

Data based on characterization results, design simulation and/or technology characteristics are indicated in the table footnotes. Based on characterization, the minimum and maximum values refer to sample tests and represent the mean value plus or minus three times the standard deviation ( $\text{mean} \pm 3\sigma$ ).

Please refer to device ErrataSheet for possible latest changes of electrical characteristics.

#### 6.1.2 Typical values

Unless otherwise specified, typical data are based on  $T_A = 25\text{ }^{\circ}\text{C}$ ,  $V_{DD} = 3.0\text{ V}$  (for the  $1.8\text{ V} \leq V_{DD} \leq 3.6\text{ V}$  voltage range). They are given only as design guidelines and are not tested.

Typical ADC accuracy values are determined by characterization of a batch of samples from a standard diffusion lot over the full temperature range, where 95% of the devices have an error less than or equal to the value indicated ( $\text{mean} \pm 2\sigma$ ).

#### 6.1.3 Typical curves

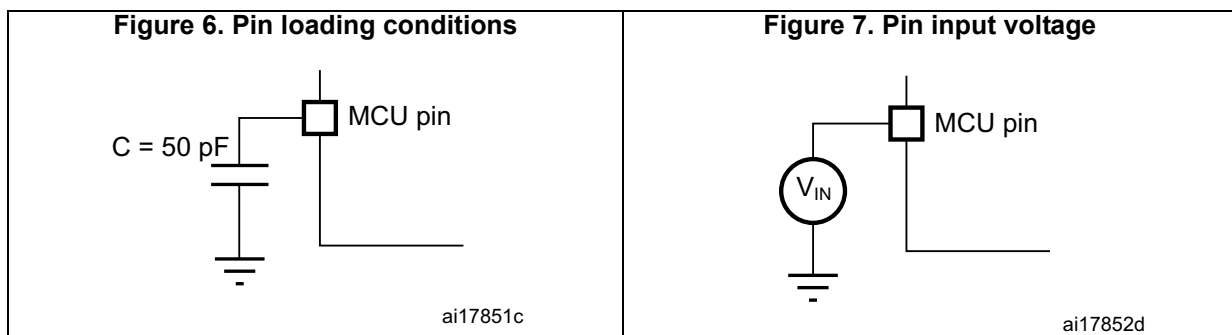
Unless otherwise specified, all typical curves are given only as design guidelines and are not tested.

#### 6.1.4 Loading capacitor

The loading conditions used for pin parameter measurement are shown in [Figure 6](#).

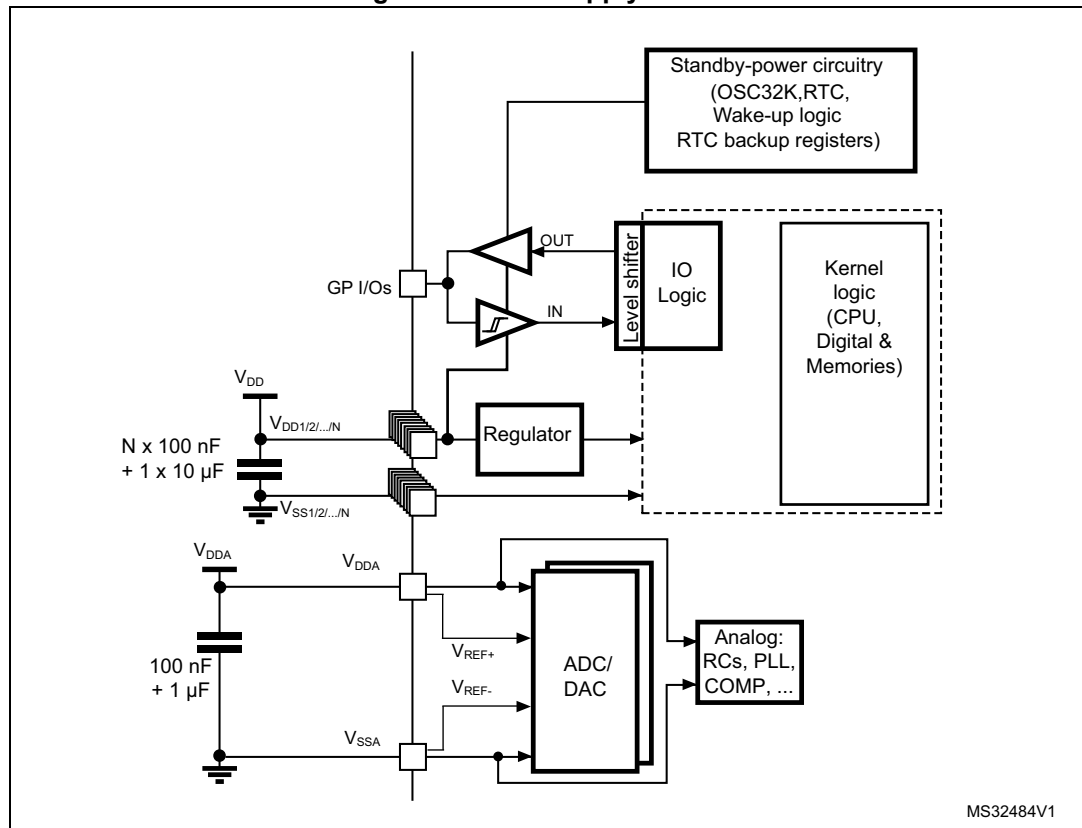
#### 6.1.5 Pin input voltage

The input voltage measurement on a pin of the device is described in [Figure 7](#).



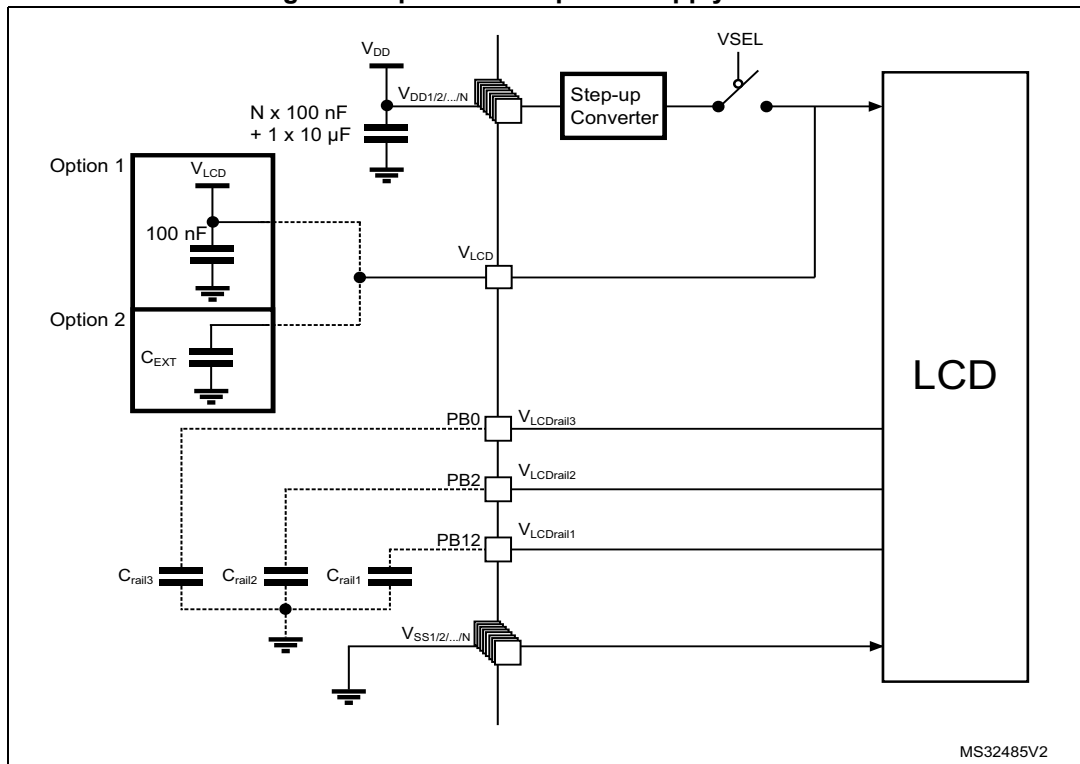
### 6.1.6 Power supply scheme

Figure 8. Power supply scheme



### 6.1.7 Optional LCD power supply scheme

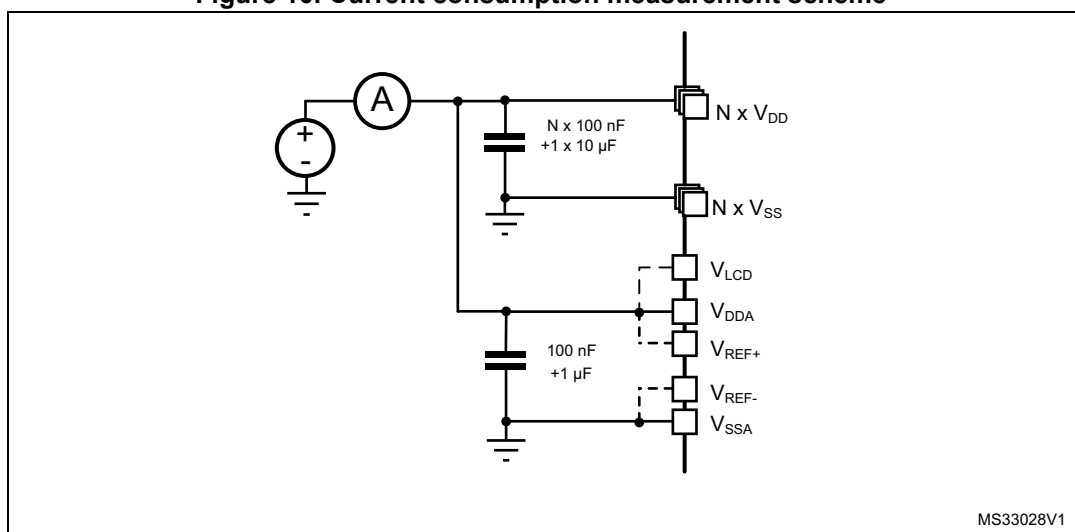
Figure 9. Optional LCD power supply scheme



1. Option 1: LCD power supply is provided by a dedicated V\_LCD supply source, V\_SEL switch is open.
2. Option 2: LCD power supply is provided by the internal step-up converter, V\_SEL switch is closed, an external capacitance is needed for correct behavior of this converter.

### 6.1.8 Current consumption measurement

Figure 10. Current consumption measurement scheme



## 6.2 Absolute maximum ratings

Stresses above the absolute maximum ratings listed in [Table 11: Voltage characteristics](#), [Table 12: Current characteristics](#), and [Table 13: Thermal characteristics](#) may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

**Table 11. Voltage characteristics**

| Symbol                  | Ratings                                                                         | Min                                | Max          | Unit |
|-------------------------|---------------------------------------------------------------------------------|------------------------------------|--------------|------|
| $V_{DD}-V_{SS}$         | External main supply voltage (including $V_{DDA}$ and $V_{DD}$ ) <sup>(1)</sup> | -0.3                               | 4.0          | V    |
| $V_{IN}$ <sup>(2)</sup> | Input voltage on five-volt tolerant pin                                         | $V_{SS}-0.3$                       | $V_{DD}+4.0$ |      |
|                         | Input voltage on any other pin                                                  | $V_{SS}-0.3$                       | 4.0          |      |
| $ \Delta V_{DDx} $      | Variations between different $V_{DD}$ power pins                                | -                                  | 50           | mV   |
| $ V_{SSx}-V_{SS} $      | Variations between all different ground pins <sup>(3)</sup>                     | -                                  | 50           |      |
| $V_{ESD}(HBM)$          | Electrostatic discharge voltage (human body model)                              | see <a href="#">Section 6.3.11</a> |              | -    |

1. All main power ( $V_{DD}$ ,  $V_{DDA}$ ) and ground ( $V_{SS}$ ,  $V_{SSA}$ ) pins must always be connected to the external power supply, in the permitted range.
2.  $V_{IN}$  maximum must always be respected. Refer to [Table 12](#) for maximum allowed injected current values.
3. Include  $V_{REF}$ -pin.

**Table 12. Current characteristics**

| Symbol                          | Ratings                                                                        | Max.     | Unit |
|---------------------------------|--------------------------------------------------------------------------------|----------|------|
| $\Sigma I_{VDD}$                | Total current into sum of all $V_{DD\_x}$ power lines (source) <sup>(1)</sup>  | 100      | mA   |
| $\Sigma I_{VSS}$ <sup>(2)</sup> | Total current out of sum of all $V_{SS\_x}$ ground lines (sink) <sup>(1)</sup> | 100      |      |
| $I_{VDD}(PIN)$                  | Maximum current into each $V_{DD\_x}$ power pin (source) <sup>(1)</sup>        | 70       |      |
| $I_{VSS}(PIN)$                  | Maximum current out of each $V_{SS\_x}$ ground pin (sink) <sup>(1)</sup>       | -70      |      |
| $I_{IO}$                        | Output current sunk by any I/O and control pin                                 | 25       |      |
|                                 | Output current sourced by any I/O and control pin                              | - 25     |      |
| $\Sigma I_{IO}(PIN)$            | Total output current sunk by sum of all IOs and control pins <sup>(2)</sup>    | 60       |      |
|                                 | Total output current sourced by sum of all IOs and control pins <sup>(2)</sup> | -60      |      |
| $I_{INJ}(PIN)$ <sup>(3)</sup>   | Injected current on five-volt tolerant I/O <sup>(4)</sup> RST and B pins       | -5/+0    |      |
|                                 | Injected current on any other pin <sup>(5)</sup>                               | $\pm 5$  |      |
| $\Sigma I_{INJ}(PIN)$           | Total injected current (sum of all I/O and control pins) <sup>(6)</sup>        | $\pm 25$ |      |

1. All main power ( $V_{DD}$ ,  $V_{DDA}$ ) and ground ( $V_{SS}$ ,  $V_{SSA}$ ) pins must always be connected to the external power supply, in the permitted range.
2. This current consumption must be correctly distributed over all I/Os and control pins. The total output current must not be sunk/sourced between two consecutive power supply pins referring to high pin count LQFP packages.
3. Negative injection disturbs the analog performance of the device. See note in [Section 6.3.17](#).

- Positive current injection is not possible on these I/Os. A negative injection is induced by  $V_{IN} < V_{SS}$ .  $I_{INJ(PIN)}$  must never be exceeded. Refer to [Table 11](#) for maximum allowed input voltage values.
- A positive injection is induced by  $V_{IN} > V_{DD}$  while a negative injection is induced by  $V_{IN} < V_{SS}$ .  $I_{INJ(PIN)}$  must never be exceeded. Refer to [Table 11: Voltage characteristics](#) for the maximum allowed input voltage values.
- When several inputs are submitted to a current injection, the maximum  $\Sigma I_{INJ(PIN)}$  is the absolute sum of the positive and negative injected currents (instantaneous values).

Table 13. Thermal characteristics

| Symbol     | Ratings                                   | Value                   | Unit |
|------------|-------------------------------------------|-------------------------|------|
| $T_{STG}$  | Storage temperature range                 | -65 to +150             | °C   |
| $T_J$      | Maximum junction temperature              | 105                     | °C   |
| $T_{LEAD}$ | Maximum lead temperature during soldering | see note <sup>(1)</sup> | °C   |

- Compliant with JEDEC Std J-STD-020D (for small body, Sn-Pb or Pb assembly), the ST ECOPACK® 7191395 specification, and the European directive on Restrictions on Hazardous Substances (ROHS directive 2011/65/EU, July 2011).

## 6.3 Operating conditions

### 6.3.1 General operating conditions

Table 14. General operating conditions

| Symbol          | Parameter                                       | Conditions                                 | Min  | Max          | Unit |
|-----------------|-------------------------------------------------|--------------------------------------------|------|--------------|------|
| $f_{HCLK}$      | Internal AHB clock frequency                    | -                                          | 0    | 32           | MHz  |
| $f_{PCLK1}$     | Internal APB1 clock frequency                   | -                                          | 0    | 32           |      |
| $f_{PCLK2}$     | Internal APB2 clock frequency                   | -                                          | 0    | 32           |      |
| $V_{DD}$        | Standard operating voltage                      | BOR detector enabled, at power on          | 1.8  | 3.6          | V    |
| $V_{DDA}^{(1)}$ | Analog operating voltage (ADC and DAC used)     | Must be the same voltage as $V_{DD}^{(2)}$ | 1.8  | 3.6          | V    |
| $V_{IN}$        | I/O input voltage                               | FT pins: $2.0\text{ V} \leq V_{DD}$        | -0.3 | $5.5^{(3)}$  | V    |
|                 |                                                 | FT pins: $V_{DD} < 2.0\text{ V}$           | -0.3 | $5.25^{(3)}$ |      |
|                 |                                                 | BOOT0                                      | 0    | 5.5          |      |
|                 |                                                 | Any other pin                              | -0.3 | $V_{DD}+0.3$ |      |
| $P_D$           | Power dissipation at $T_A = 85\text{ °C}^{(4)}$ | LQFP64 package                             | -    | 444          | mW   |
|                 |                                                 | UFQFPN48 package                           | -    | 606          |      |
| $T_A$           | Ambient temperature range                       | Maximum power dissipation                  | -40  | 85           |      |
| $T_J$           | Junction temperature range                      | $-40\text{ °C} \leq T_A \leq 85\text{ °C}$ | -40  | 105          | °C   |

- When the ADC is used, refer to [Table 55: ADC characteristics](#).
- It is recommended to power  $V_{DD}$  and  $V_{DDA}$  from the same source. A maximum difference of 300 mV between  $V_{DD}$  and  $V_{DDA}$  can be tolerated during power-up and operation.
- To sustain a voltage higher than  $V_{DD}+0.3\text{ V}$ , the internal pull-up/pull-down resistors must be disabled.

4. If  $T_A$  is lower, higher  $P_D$  values are allowed as long as  $T_J$  does not exceed  $T_{J\max}$  (see [Table 64: Thermal characteristics on page 98](#)).

### 6.3.2 Embedded reset and power control block characteristics

The parameters given in the following table are derived from the tests performed under the ambient temperature condition summarized in the following table.

**Table 15. Embedded reset and power control block characteristics**

| Symbol               | Parameter                           | Conditions                   | Min  | Typ  | Max      | Unit      |
|----------------------|-------------------------------------|------------------------------|------|------|----------|-----------|
| $t_{VDD}^{(1)}$      | $V_{DD}$ rise time rate             | BOR detector enabled         | 0    | -    | $\infty$ | $\mu s/V$ |
|                      | $V_{DD}$ fall time rate             | BOR detector enabled         | 20   | -    | $\infty$ |           |
|                      |                                     | BOR detector disabled        | 0    | -    | 1000     |           |
| $T_{RSTTEMPO}^{(1)}$ | Reset temporization                 | $V_{DD}$ rising, BOR enabled | -    | 2    | 3.3      | ms        |
| $V_{POR/PDR}$        | Power on/power down reset threshold | Falling edge                 | 1    | 1.5  | 1.65     | V         |
|                      |                                     | Rising edge                  | 1.3  | 1.5  | 1.65     |           |
| $V_{BOR0}$           | Brown-out reset threshold 0         | Falling edge                 | 1.67 | 1.7  | 1.74     | V         |
|                      |                                     | Rising edge                  | 1.69 | 1.76 | 1.8      |           |
| $V_{BOR1}$           | Brown-out reset threshold 1         | Falling edge                 | 1.87 | 1.93 | 1.97     |           |
|                      |                                     | Rising edge                  | 1.96 | 2.03 | 2.07     |           |
| $V_{BOR2}$           | Brown-out reset threshold 2         | Falling edge                 | 2.22 | 2.30 | 2.35     |           |
|                      |                                     | Rising edge                  | 2.31 | 2.41 | 2.44     |           |
| $V_{BOR3}$           | Brown-out reset threshold 3         | Falling edge                 | 2.45 | 2.55 | 2.60     |           |
|                      |                                     | Rising edge                  | 2.54 | 2.66 | 2.7      |           |
| $V_{BOR4}$           | Brown-out reset threshold 4         | Falling edge                 | 2.68 | 2.8  | 2.85     |           |
|                      |                                     | Rising edge                  | 2.78 | 2.9  | 2.95     |           |

Table 15. Embedded reset and power control block characteristics (continued)

| Symbol     | Parameter                                 | Conditions                                | Min  | Typ  | Max  | Unit |
|------------|-------------------------------------------|-------------------------------------------|------|------|------|------|
| $V_{PVD0}$ | Programmable voltage detector threshold 0 | Falling edge                              | 1.8  | 1.85 | 1.88 | V    |
|            |                                           | Rising edge                               | 1.88 | 1.94 | 1.99 |      |
| $V_{PVD1}$ | PVD threshold 1                           | Falling edge                              | 1.98 | 2.04 | 2.09 |      |
|            |                                           | Rising edge                               | 2.08 | 2.14 | 2.18 |      |
| $V_{PVD2}$ | PVD threshold 2                           | Falling edge                              | 2.20 | 2.24 | 2.28 |      |
|            |                                           | Rising edge                               | 2.28 | 2.34 | 2.38 |      |
| $V_{PVD3}$ | PVD threshold 3                           | Falling edge                              | 2.39 | 2.44 | 2.48 |      |
|            |                                           | Rising edge                               | 2.47 | 2.54 | 2.58 |      |
| $V_{PVD4}$ | PVD threshold 4                           | Falling edge                              | 2.57 | 2.64 | 2.69 |      |
|            |                                           | Rising edge                               | 2.68 | 2.74 | 2.79 |      |
| $V_{PVD5}$ | PVD threshold 5                           | Falling edge                              | 2.77 | 2.83 | 2.88 |      |
|            |                                           | Rising edge                               | 2.87 | 2.94 | 2.99 |      |
| $V_{PVD6}$ | PVD threshold 6                           | Falling edge                              | 2.97 | 3.05 | 3.09 |      |
|            |                                           | Rising edge                               | 3.08 | 3.15 | 3.20 |      |
| $V_{hyst}$ | Hysteresis voltage                        | BOR0 threshold                            | -    | 40   | -    | mV   |
|            |                                           | All BOR and PVD thresholds excepting BOR0 | -    | 100  | -    |      |

1. Guaranteed by characterization results.

### 6.3.3 Embedded internal reference voltage

The parameters given in the following table are based on characterization results, unless otherwise specified.

**Table 16. Embedded internal reference voltage calibration values**

| Calibration value name | Description                                                                                     | Memory address          |
|------------------------|-------------------------------------------------------------------------------------------------|-------------------------|
| VREFINT_CAL            | Raw data acquired at temperature of 30 °C $\pm$ 5 °C, $V_{DDA} = 3 \text{ V} \pm 10 \text{ mV}$ | 0x1FF8 0078-0x1FF8 0079 |

**Table 17. Embedded internal reference voltage**

| Symbol                          | Parameter                                                           | Conditions                                                     | Min   | Typ   | Max     | Unit                  |
|---------------------------------|---------------------------------------------------------------------|----------------------------------------------------------------|-------|-------|---------|-----------------------|
| $V_{\text{REFINT\_out}}^{(1)}$  | Internal reference voltage                                          | $-40\text{ °C} < T_J < +85\text{ °C}$                          | 1.202 | 1.224 | 1.242   | V                     |
| $I_{\text{REFINT}}$             | Internal reference current consumption                              | -                                                              | -     | 1.4   | 2.3     | $\mu\text{A}$         |
| $T_{\text{VREFINT}}$            | Internal reference startup time                                     | -                                                              | -     | 2     | 3       | ms                    |
| $V_{\text{VREF\_MEAS}}$         | $V_{\text{DDA}}$ voltage during $V_{\text{REFINT}}$ factory measure | -                                                              | 2.99  | 3     | 3.01    | V                     |
| $A_{\text{VREF\_MEAS}}$         | Accuracy of factory-measured $V_{\text{REF}}$ value <sup>(2)</sup>  | Including uncertainties due to ADC and $V_{\text{DDA}}$ values | -     | -     | $\pm 5$ | mV                    |
| $T_{\text{Ccoeff}}^{(3)}$       | Temperature coefficient                                             | $-40\text{ °C} < T_J < +85\text{ °C}$                          | -     | 25    | 100     | ppm/°C                |
| $A_{\text{Ccoeff}}^{(3)}$       | Long-term stability                                                 | 1000 hours, $T = 25\text{ °C}$                                 | -     | -     | 1000    | ppm                   |
| $V_{\text{DDCcoeff}}^{(3)(4)}$  | Voltage coefficient                                                 | $3.0\text{ V} < V_{\text{DDA}} < 3.6\text{ V}$                 | -     | -     | 2000    | ppm/V                 |
| $T_{\text{S\_vrefint}}^{(3)}$   | ADC sampling time when reading the internal reference voltage       | -                                                              | 4     | -     | -       | $\mu\text{s}$         |
| $T_{\text{ADC\_BUF}}^{(3)}$     | Startup time of reference voltage buffer for ADC                    | -                                                              | -     | -     | 10      | $\mu\text{s}$         |
| $I_{\text{BUF\_ADC}}^{(3)}$     | Consumption of reference voltage buffer for ADC                     | -                                                              | -     | 13.5  | 25      | $\mu\text{A}$         |
| $I_{\text{VREF\_OUT}}^{(3)}$    | VREF_OUT output current <sup>(5)</sup>                              | -                                                              | -     | -     | 1       | $\mu\text{A}$         |
| $C_{\text{VREF\_OUT}}^{(3)}$    | VREF_OUT output load                                                | -                                                              | -     | -     | 50      | pF                    |
| $I_{\text{LPBUF}}^{(3)}$        | Consumption of reference voltage buffer for VREF_OUT and COMP       | -                                                              | -     | 730   | 1200    | nA                    |
| $V_{\text{REFINT\_DIV1}}^{(3)}$ | 1/4 reference voltage                                               | -                                                              | 24    | 25    | 26      | % $V_{\text{REFINT}}$ |
| $V_{\text{REFINT\_DIV2}}^{(3)}$ | 1/2 reference voltage                                               | -                                                              | 49    | 50    | 51      |                       |
| $V_{\text{REFINT\_DIV3}}^{(3)}$ | 3/4 reference voltage                                               | -                                                              | 74    | 75    | 76      |                       |

1. Guaranteed by test in production.

2. The internal  $V_{\text{REF}}$  value is individually measured in production and stored in dedicated EEPROM bytes.

3. Guaranteed by characterization results.

4. Shortest sampling time can be determined in the application by multiple interactions.

5. To guarantee less than 1% VREF\_OUT deviation.

### 6.3.4 Supply current characteristics

The current consumption is a function of several parameters and factors such as the operating voltage, ambient temperature, I/O pin loading, device software configuration, operating frequencies, I/O pin switching rate, program location in memory and executed binary code. The current consumption is measured as described in [Figure 10: Current consumption measurement scheme](#).

All Run-mode current consumption measurements given in this section are performed with a reduced code that gives a consumption equivalent to Dhrystone 2.1 code, unless otherwise specified.

The current consumption values are derived from the tests performed under ambient temperature  $T_A=25^{\circ}\text{C}$  and  $V_{DD}$  supply voltage conditions summarized in [Table 14: General operating conditions](#), unless otherwise specified.

The MCU is placed under the following conditions:

- All I/O pins are configured in analog input mode.
- All peripherals are disabled except when explicitly mentioned.
- The Flash memory access time, 64-bit access and prefetch is adjusted depending on  $f_{HCLK}$  frequency and voltage range to provide the best CPU performance.
- When the peripherals are enabled  $f_{APB1} = f_{APB2} = f_{AHB}$ .
- When PLL is ON, the PLL inputs are equal to HSI = 16 MHz (if internal clock is used) or HSE = 16 MHz (if HSE bypass mode is used).
- The HSE user clock applied to OSC\_IN input follows the characteristics specified in [Table 27: High-speed external user clock characteristics](#).
- For maximum current consumption  $V_{DD} = V_{DDA} = 3.6\text{ V}$  is applied to all supply pins.
- For typical current consumption  $V_{DD} = V_{DDA} = 3.0\text{ V}$  is applied to all supply pins if not specified otherwise.

Table 18. Current consumption in Run mode, code with data processing running from Flash

| Symbol                           | Parameter                                            | Conditions                                                                                                                                  |                                                    | f <sub>HCLK</sub> | Typ   | Max <sup>(1)</sup> | Unit |
|----------------------------------|------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------|-------------------|-------|--------------------|------|
| I <sub>DD</sub> (Run from Flash) | Supply current in Run mode, code executed from Flash | f <sub>HSE</sub> = f <sub>HCLK</sub> up to 16 MHz, included<br>f <sub>HSE</sub> = f <sub>HCLK</sub> /2 above 16 MHz (PLL ON) <sup>(2)</sup> | Range 3, V <sub>CORE</sub> =1.2 V<br>VOS[1:0] = 11 | 1 MHz             | 215   | 285                | μA   |
|                                  |                                                      |                                                                                                                                             |                                                    | 2 MHz             | 400   | 490                |      |
|                                  |                                                      |                                                                                                                                             |                                                    | 4 MHz             | 725   | 1000               |      |
|                                  |                                                      |                                                                                                                                             | Range 2, V <sub>CORE</sub> =1.5 V<br>VOS[1:0] = 10 | 4 MHz             | 0.915 | 1.3                | mA   |
|                                  |                                                      |                                                                                                                                             |                                                    | 8 MHz             | 1.75  | 2.15               |      |
|                                  |                                                      |                                                                                                                                             |                                                    | 16 MHz            | 3.4   | 4                  |      |
|                                  |                                                      |                                                                                                                                             | Range 1, V <sub>CORE</sub> =1.8 V<br>VOS[1:0] = 01 | 8 MHz             | 2.1   | 2.9                |      |
|                                  |                                                      |                                                                                                                                             |                                                    | 16 MHz            | 4.2   | 5.2                |      |
|                                  |                                                      |                                                                                                                                             |                                                    | 32 MHz            | 8.25  | 9.6                |      |
|                                  |                                                      | HSI clock source (16 MHz)                                                                                                                   | Range 2, V <sub>CORE</sub> =1.5 V<br>VOS[1:0] = 10 | 16 MHz            | 3.5   | 4.4                |      |
|                                  |                                                      |                                                                                                                                             | Range 1, V <sub>CORE</sub> =1.8 V<br>VOS[1:0] = 01 | 32 MHz            | 8.2   | 10.2               |      |
|                                  |                                                      | MSI clock, 65 kHz                                                                                                                           | Range 3, V <sub>CORE</sub> =1.2 V<br>VOS[1:0] = 11 | 65 kHz            | 0.041 | 0.085              |      |
|                                  |                                                      | MSI clock, 524 kHz                                                                                                                          |                                                    | 524 kHz           | 0.125 | 0.180              |      |
|                                  |                                                      | MSI clock, 4.2 MHz                                                                                                                          |                                                    | 4.2 MHz           | 0.775 | 0.935              |      |

1. Guaranteed by characterization results, unless otherwise specified.

2. Oscillator bypassed (HSEBYP = 1 in RCC\_CR register).

Table 19. Current consumption in Run mode, code with data processing running from RAM

| Symbol                         | Parameter                                                              | Conditions                                                                                                                                  |                                                       | f <sub>HCLK</sub> | Typ   | Max <sup>(1)</sup> | Unit |
|--------------------------------|------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------|-------------------|-------|--------------------|------|
| I <sub>DD</sub> (Run from RAM) | Supply current in Run mode, code executed from RAM, Flash switched off | f <sub>HSE</sub> = f <sub>HCLK</sub> up to 16 MHz, included<br>f <sub>HSE</sub> = f <sub>HCLK</sub> /2 above 16 MHz (PLL ON) <sup>(2)</sup> | Range 3,<br>V <sub>CORE</sub> =1.2 V<br>VOS[1:0] = 11 | 1 MHz             | 185   | 255                | μA   |
|                                |                                                                        |                                                                                                                                             |                                                       | 2 MHz             | 345   | 435                |      |
|                                |                                                                        |                                                                                                                                             |                                                       | 4 MHz             | 645   | 930                |      |
|                                |                                                                        |                                                                                                                                             | Range 2,<br>V <sub>CORE</sub> =1.5 V<br>VOS[1:0] = 10 | 4 MHz             | 0.755 | 1.5                | mA   |
|                                |                                                                        |                                                                                                                                             |                                                       | 8 MHz             | 1.5   | 2.2                |      |
|                                |                                                                        |                                                                                                                                             |                                                       | 16 MHz            | 3.0   | 3.6                |      |
|                                |                                                                        |                                                                                                                                             | Range 1,<br>V <sub>CORE</sub> =1.8 V<br>VOS[1:0] = 01 | 8 MHz             | 1.8   | 2.9                |      |
|                                |                                                                        |                                                                                                                                             |                                                       | 16 MHz            | 3.6   | 4.3                |      |
|                                |                                                                        |                                                                                                                                             |                                                       | 32 MHz            | 7.15  | 8.5                |      |
|                                |                                                                        | HSI clock source (16 MHz)                                                                                                                   | Range 2,<br>V <sub>CORE</sub> =1.5 V<br>VOS[1:0] = 10 | 16 MHz            | 2.95  | 3.7                |      |
|                                |                                                                        |                                                                                                                                             | Range 1,<br>V <sub>CORE</sub> =1.8 V<br>VOS[1:0] = 01 | 32 MHz            | 7.15  | 8.7                |      |
|                                |                                                                        | MSI clock, 65 kHz                                                                                                                           | Range 3,<br>V <sub>CORE</sub> =1.2 V<br>VOS[1:0] = 11 | 65 kHz            | 39    | 115                | μA   |
|                                |                                                                        | MSI clock, 524 kHz                                                                                                                          |                                                       | 524 kHz           | 110   | 205                |      |
|                                |                                                                        | MSI clock, 4.2 MHz                                                                                                                          |                                                       | 4.2 MHz           | 690   | 870                |      |

1. Guaranteed by characterization results, unless otherwise specified.

2. Oscillator bypassed (HSEBYP = 1 in RCC\_CR register).

Table 20. Current consumption in Sleep mode

| Symbol                     | Parameter                               | Conditions                                                                                                                               |                                                 | f <sub>HCLK</sub> | Typ  | Max <sup>(1)</sup> | Unit |
|----------------------------|-----------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------|-------------------|------|--------------------|------|
| I <sub>DD</sub><br>(Sleep) | Supply current in Sleep mode, Flash OFF | f <sub>HSE</sub> = f <sub>HCLK</sub> up to 16 MHz included, f <sub>HSE</sub> = f <sub>HCLK</sub> /2 above 16 MHz (PLL ON) <sup>(2)</sup> | Range 3, V <sub>CORE</sub> =1.2 V VOS[1:0] = 11 | 1 MHz             | 50   | 155                | μA   |
|                            |                                         |                                                                                                                                          |                                                 | 2 MHz             | 78.5 | 235                |      |
|                            |                                         |                                                                                                                                          |                                                 | 4 MHz             | 140  | 370 <sup>(3)</sup> |      |
|                            |                                         |                                                                                                                                          | Range 2, V <sub>CORE</sub> =1.5 V VOS[1:0] = 10 | 4 MHz             | 165  | 375                |      |
|                            |                                         |                                                                                                                                          |                                                 | 8 MHz             | 310  | 530                |      |
|                            |                                         |                                                                                                                                          |                                                 | 16 MHz            | 590  | 1000               |      |
|                            |                                         |                                                                                                                                          | Range 1, V <sub>CORE</sub> =1.8 V VOS[1:0] = 01 | 8 MHz             | 350  | 615                |      |
|                            |                                         |                                                                                                                                          |                                                 | 16 MHz            | 680  | 1200               |      |
|                            |                                         |                                                                                                                                          |                                                 | 32 MHz            | 1600 | 2350               |      |
|                            |                                         | HSI clock source (16 MHz)                                                                                                                | Range 2, V <sub>CORE</sub> =1.5 V VOS[1:0] = 10 | 16 MHz            | 640  | 970                |      |
|                            |                                         |                                                                                                                                          | Range 1, V <sub>CORE</sub> =1.8 V VOS[1:0] = 01 | 32 MHz            | 1600 | 2350               |      |
|                            |                                         | MSI clock, 65 kHz                                                                                                                        | Range 3, V <sub>CORE</sub> =1.2 V VOS[1:0] = 11 | 65 kHz            | 19   | 60                 |      |
|                            |                                         | MSI clock, 524 kHz                                                                                                                       |                                                 | 524 kHz           | 33   | 90                 |      |
|                            |                                         | MSI clock, 4.2 MHz                                                                                                                       |                                                 | 4.2 MHz           | 145  | 210                |      |
|                            | Supply current in Sleep mode, Flash ON  | f <sub>HSE</sub> = f <sub>HCLK</sub> up to 16 MHz included, f <sub>HSE</sub> = f <sub>HCLK</sub> /2 above 16 MHz (PLL ON) <sup>(2)</sup> | Range 3, V <sub>CORE</sub> =1.2 V VOS[1:0] = 11 | 1 MHz             | 60.5 | 145                | μA   |
|                            |                                         |                                                                                                                                          |                                                 | 2 MHz             | 89.5 | 225                |      |
|                            |                                         |                                                                                                                                          |                                                 | 4 MHz             | 150  | 360                |      |
|                            |                                         |                                                                                                                                          | Range 2, V <sub>CORE</sub> =1.5 V VOS[1:0] = 10 | 4 MHz             | 180  | 370                |      |
|                            |                                         |                                                                                                                                          |                                                 | 8 MHz             | 320  | 490                |      |
|                            |                                         |                                                                                                                                          |                                                 | 16 MHz            | 605  | 895                |      |
|                            |                                         |                                                                                                                                          | Range 1, V <sub>CORE</sub> =1.8 V VOS[1:0] = 01 | 8 MHz             | 380  | 565                |      |
|                            |                                         |                                                                                                                                          |                                                 | 16 MHz            | 695  | 1070               |      |
|                            |                                         |                                                                                                                                          |                                                 | 32 MHz            | 1600 | 2200               |      |
|                            |                                         | HSI clock source (16 MHz)                                                                                                                | Range 2, V <sub>CORE</sub> =1.5 V VOS[1:0] = 10 | 16 MHz            | 650  | 970                |      |
|                            |                                         |                                                                                                                                          | Range 1, V <sub>CORE</sub> =1.8 V VOS[1:0] = 01 | 32 MHz            | 1600 | 2320               |      |
|                            |                                         | MSI clock, 65 kHz                                                                                                                        | Range 3, V <sub>CORE</sub> =1.2V VOS[1:0] = 11  | 65 kHz            | 29.5 | 65                 |      |
|                            |                                         | MSI clock, 524 kHz                                                                                                                       |                                                 | 524 kHz           | 44   | 80                 |      |
|                            |                                         | MSI clock, 4.2 MHz                                                                                                                       |                                                 | 4.2 MHz           | 155  | 220                |      |

1. Guaranteed by characterization results, unless otherwise specified.
2. Oscillator bypassed (HSEBYP = 1 in RCC\_CR register)
3. Guaranteed by test in production.

Table 21. Current consumption in Low power run mode

| Symbol                               | Parameter                                 | Conditions                                                                                    |                                            |                                       | Typ  | Max <sup>(1)</sup> | Unit    |
|--------------------------------------|-------------------------------------------|-----------------------------------------------------------------------------------------------|--------------------------------------------|---------------------------------------|------|--------------------|---------|
| $I_{DD}$ (LP Run)                    | Supply current in Low power run mode      | All peripherals OFF, code executed from RAM, Flash switched OFF, $V_{DD}$ from 1.8 V to 3.6 V | MSI clock, 65 kHz<br>$f_{HCLK} = 32$ kHz   | $T_A = -40\text{ °C to }25\text{ °C}$ | 10.9 | 12                 | $\mu A$ |
|                                      |                                           |                                                                                               |                                            | $T_A = 85\text{ °C}$                  | 16.5 | 23                 |         |
|                                      |                                           |                                                                                               | MSI clock, 65 kHz<br>$f_{HCLK} = 65$ kHz   | $T_A = -40\text{ °C to }25\text{ °C}$ | 15   | 16                 |         |
|                                      |                                           |                                                                                               |                                            | $T_A = 85\text{ °C}$                  | 22   | 29                 |         |
|                                      |                                           |                                                                                               | MSI clock, 131 kHz<br>$f_{HCLK} = 131$ kHz | $T_A = -40\text{ °C to }25\text{ °C}$ | 29   | 37                 |         |
|                                      |                                           |                                                                                               |                                            | $T_A = 55\text{ °C}$                  | 32.5 | 40                 |         |
|                                      |                                           |                                                                                               |                                            | $T_A = 85\text{ °C}$                  | 35.5 | 54                 |         |
|                                      |                                           | All peripherals OFF, code executed from Flash, $V_{DD}$ from 1.8 V to 3.6 V                   | MSI clock, 65 kHz<br>$f_{HCLK} = 32$ kHz   | $T_A = -40\text{ °C to }25\text{ °C}$ | 23   | 24                 |         |
|                                      |                                           |                                                                                               |                                            | $T_A = 85\text{ °C}$                  | 31   | 34                 |         |
|                                      |                                           |                                                                                               | MSI clock, 65 kHz<br>$f_{HCLK} = 65$ kHz   | $T_A = -40\text{ °C to }25\text{ °C}$ | 29   | 31                 |         |
|                                      |                                           |                                                                                               |                                            | $T_A = 85\text{ °C}$                  | 38   | 41                 |         |
|                                      |                                           |                                                                                               | MSI clock, 131 kHz<br>$f_{HCLK} = 131$ kHz | $T_A = -40\text{ °C to }25\text{ °C}$ | 46   | 55                 |         |
|                                      |                                           |                                                                                               |                                            | $T_A = 55\text{ °C}$                  | 48   | 59                 |         |
|                                      |                                           |                                                                                               |                                            | $T_A = 85\text{ °C}$                  | 53.5 | 72                 |         |
| $I_{DD}$ Max (LP Run) <sup>(2)</sup> | Max allowed current in Low power run mode | $V_{DD}$ from 1.8 V to 3.6 V                                                                  | -                                          | -                                     | -    | 200                |         |

1. Guaranteed by characterization results, unless otherwise specified.
2. This limitation is related to the consumption of the CPU core and the peripherals that are powered by the regulator. Consumption of the I/Os is not included in this limitation.

Table 22. Current consumption in Low power sleep mode

| Symbol                         | Parameter                                   | Conditions                                                             |                                                                   |                                  | Typ  | Max <sup>(1)</sup> | Unit |
|--------------------------------|---------------------------------------------|------------------------------------------------------------------------|-------------------------------------------------------------------|----------------------------------|------|--------------------|------|
| I <sub>DD</sub> (LP Sleep)     | Supply current in Low power sleep mode      | All peripherals OFF, V <sub>DD</sub> from 1.8 V to 3.6 V               | MSI clock, 65 kHz<br>f <sub>HCLK</sub> = 32 kHz<br>Flash OFF      | T <sub>A</sub> = -40 °C to 25 °C | 5.5  | -                  | μA   |
|                                |                                             |                                                                        | MSI clock, 65 kHz<br>f <sub>HCLK</sub> = 32 kHz<br>Flash ON       | T <sub>A</sub> = -40 °C to 25 °C | 15   | 16                 |      |
|                                |                                             |                                                                        |                                                                   | T <sub>A</sub> = 85 °C           | 20   | 23                 |      |
|                                |                                             |                                                                        | MSI clock, 65 kHz<br>f <sub>HCLK</sub> = 65 kHz,<br>Flash ON      | T <sub>A</sub> = -40 °C to 25 °C | 15   | 16                 |      |
|                                |                                             |                                                                        |                                                                   | T <sub>A</sub> = 85 °C           | 20.5 | 23                 |      |
|                                |                                             |                                                                        | MSI clock,<br>131 kHz<br>f <sub>HCLK</sub> = 131 kHz,<br>Flash ON | T <sub>A</sub> = -40 °C to 25 °C | 18   | 20                 |      |
|                                |                                             |                                                                        |                                                                   | T <sub>A</sub> = 55 °C           | 21   | 22                 |      |
|                                |                                             |                                                                        |                                                                   | T <sub>A</sub> = 85 °C           | 23   | 27                 |      |
|                                |                                             | TIM9 and USART1 enabled, Flash ON, V <sub>DD</sub> from 1.8 V to 3.6 V | MSI clock, 65 kHz<br>f <sub>HCLK</sub> = 32 kHz                   | T <sub>A</sub> = -40 °C to 25 °C | 15   | 16                 |      |
|                                |                                             |                                                                        |                                                                   | T <sub>A</sub> = 85 °C           | 20   | 22                 |      |
|                                |                                             |                                                                        | MSI clock, 65 kHz<br>f <sub>HCLK</sub> = 65 kHz                   | T <sub>A</sub> = -40 °C to 25 °C | 15   | 16                 |      |
|                                |                                             |                                                                        |                                                                   | T <sub>A</sub> = 85 °C           | 20.5 | 23                 |      |
|                                |                                             |                                                                        | MSI clock,<br>131 kHz<br>f <sub>HCLK</sub> = 131 kHz              | T <sub>A</sub> = -40 °C to 25 °C | 18   | 20                 |      |
|                                |                                             |                                                                        |                                                                   | T <sub>A</sub> = 55 °C           | 21   | 22                 |      |
|                                |                                             |                                                                        |                                                                   | T <sub>A</sub> = 85 °C           | 23   | 27                 |      |
| I <sub>DD</sub> Max (LP Sleep) | Max allowed current in Low power Sleep mode | V <sub>DD</sub> from 1.8 V to 3.6 V                                    | -                                                                 | -                                | -    | 200                |      |

1. Guaranteed by characterization results, unless otherwise specified.

Table 23. Typical and maximum current consumptions in Stop mode

| Symbol                             | Parameter                                                                                           | Conditions                                                                                                                     |                                           |                                                           | Typ <sup>(1)</sup> | Max<br>(1)(2) | Unit |
|------------------------------------|-----------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------|-----------------------------------------------------------|--------------------|---------------|------|
| I <sub>DD</sub> (Stop<br>with RTC) | Supply current in<br>Stop mode with<br>RTC enabled                                                  | RTC clocked by LSI,<br>regulator in LP mode, HSI<br>and HSE OFF<br>(no independent<br>watchdog)                                | LCD OFF                                   | T <sub>A</sub> = -40°C to 25°C<br>V <sub>DD</sub> = 1.8 V | 1.13               | -             | μA   |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = -40°C to 25°C                            | 1.38               | 4             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 55°C                                     | 1.70               | 6             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 85°C                                     | 3.30               | 10            |      |
|                                    |                                                                                                     |                                                                                                                                | LCD ON<br>(static<br>duty) <sup>(3)</sup> | T <sub>A</sub> = -40°C to 25°C                            | 1.50               | 6             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 55°C                                     | 1.80               | 7             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 85°C                                     | 3.45               | 12            |      |
|                                    |                                                                                                     |                                                                                                                                | LCD ON<br>(1/8<br>duty) <sup>(4)</sup>    | T <sub>A</sub> = -40°C to 25°C                            | 3.80               | 10            |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 55°C                                     | 4.30               | 11            |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 85°C                                     | 6.10               | 16            |      |
|                                    |                                                                                                     | RTC clocked by LSE<br>external clock (32.768<br>kHz), regulator in LP<br>mode, HSI and HSE OFF<br>(no independent<br>watchdog) | LCD OFF                                   | T <sub>A</sub> = -40°C to 25°C                            | 1.50               | -             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 55°C                                     | 1.90               | -             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 85°C                                     | 3.65               | -             |      |
|                                    |                                                                                                     |                                                                                                                                | LCD ON<br>(static<br>duty) <sup>(3)</sup> | T <sub>A</sub> = -40°C to 25°C                            | 1.60               | -             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 55°C                                     | 2.05               | -             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 85°C                                     | 3.75               | -             |      |
|                                    |                                                                                                     |                                                                                                                                | LCD ON<br>(1/8<br>duty) <sup>(1)</sup>    | T <sub>A</sub> = -40°C to 25°C                            | 3.90               | -             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 55°C                                     | 4.55               | -             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 85°C                                     | 6.35               | -             |      |
|                                    |                                                                                                     | RTC clocked by LSE (no<br>independent watchdog) <sup>(5)</sup>                                                                 | LCD OFF                                   | T <sub>A</sub> = -40°C to 25°C<br>V <sub>DD</sub> = 1.8 V | 1.23               | -             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = -40°C to 25°C<br>V <sub>DD</sub> = 3.0 V | 1.50               | -             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = -40°C to 25°C<br>V <sub>DD</sub> = 3.6 V | 1.75               | -             |      |
| I <sub>DD</sub> (Stop)             | Supply current in<br>Stop mode (<br>RTC disabled)                                                   | Regulator in LP mode, HSI and HSE<br>OFF, independent watchdog and LSI<br>enabled                                              |                                           | T <sub>A</sub> = -40°C to 25°C                            | 1.80               | 2.2           |      |
|                                    |                                                                                                     | Regulator in LP mode, LSI, HSI and<br>HSE OFF (no independent watchdog)                                                        |                                           | T <sub>A</sub> = -40°C to 25°C                            | 0.434              | 1             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 55°C                                     | 0.735              | 3             |      |
|                                    |                                                                                                     |                                                                                                                                |                                           | T <sub>A</sub> = 85°C                                     | 2.350              | 9             |      |
| I <sub>DD</sub> (WU<br>from Stop)  | RMS (root mean<br>square) supply<br>current during<br>wakeup time<br>when exiting<br>from Stop mode | MSI = 4.2 MHz                                                                                                                  |                                           | V <sub>DD</sub> = 3.0 V<br>T <sub>A</sub> = -40°C to 25°C | 2                  | -             | mA   |
|                                    |                                                                                                     | MSI = 1.05 MHz                                                                                                                 |                                           |                                                           | 1.45               | -             |      |
|                                    |                                                                                                     | MSI = 65 kHz <sup>(6)</sup>                                                                                                    |                                           |                                                           | 1.45               | -             |      |

1. The typical values are given for  $V_{DD} = 3.0\text{ V}$  and max values are given for  $V_{DD} = 3.6\text{ V}$ , unless otherwise specified.
2. Guaranteed by characterization results, unless otherwise specified.
3. LCD enabled with external VLCD, static duty, division ratio = 256, all pixels active, no LCD connected.
4. LCD enabled with external VLCD, 1/8 duty, 1/3 bias, division ratio = 64, all pixels active, no LCD connected.
5. Based on characterization done with a 32.768 kHz crystal (MC306-G-06Q-32.768, manufacturer JFVNY) with two 6.8pF loading capacitors.
6. When  $MSI = 64\text{ kHz}$ , the RMS current is measured over the first 15  $\mu\text{s}$  following the wakeup event. For the remaining time of the wakeup period, the current is similar to the Run mode current.

Table 24. Typical and maximum current consumptions in Standby mode

| Symbol                            | Parameter                                                            | Conditions                                                  |                                                                                                | Typ <sup>(1)</sup> | Max <sup>(1)(2)</sup> | Unit          |
|-----------------------------------|----------------------------------------------------------------------|-------------------------------------------------------------|------------------------------------------------------------------------------------------------|--------------------|-----------------------|---------------|
| $I_{DD}$<br>(Standby<br>with RTC) | Supply current in Standby mode with RTC enabled                      | RTC clocked by LSI (no independent watchdog)                | $T_A = -40\text{ }^{\circ}\text{C}$ to $25\text{ }^{\circ}\text{C}$<br>$V_{DD} = 1.8\text{ V}$ | 0.865              | -                     | $\mu\text{A}$ |
|                                   |                                                                      |                                                             | $T_A = -40\text{ }^{\circ}\text{C}$ to $25\text{ }^{\circ}\text{C}$                            | 1.11               | 1.9                   |               |
|                                   |                                                                      |                                                             | $T_A = 55\text{ }^{\circ}\text{C}$                                                             | 1.15               | 2.2                   |               |
|                                   |                                                                      |                                                             | $T_A = 85\text{ }^{\circ}\text{C}$                                                             | 1.35               | 4                     |               |
|                                   |                                                                      | RTC clocked by LSE (no independent watchdog) <sup>(3)</sup> | $T_A = -40\text{ }^{\circ}\text{C}$ to $25\text{ }^{\circ}\text{C}$<br>$V_{DD} = 1.8\text{ V}$ | 0.97               | -                     |               |
|                                   |                                                                      |                                                             | $T_A = -40\text{ }^{\circ}\text{C}$ to $25\text{ }^{\circ}\text{C}$                            | 1.28               | -                     |               |
|                                   |                                                                      |                                                             | $T_A = 55\text{ }^{\circ}\text{C}$                                                             | 1.4                | -                     |               |
|                                   |                                                                      |                                                             | $T_A = 85\text{ }^{\circ}\text{C}$                                                             | 1.7                | -                     |               |
| $I_{DD}$<br>(Standby)             | Supply current in Standby mode with RTC disabled                     | Independent watchdog and LSI enabled                        | $T_A = -40\text{ }^{\circ}\text{C}$ to $25\text{ }^{\circ}\text{C}$                            | 1.0                | 1.7                   | $\mu\text{A}$ |
|                                   |                                                                      | Independent watchdog and LSI OFF                            | $T_A = -40\text{ }^{\circ}\text{C}$ to $25\text{ }^{\circ}\text{C}$                            | 0.277              | 0.6                   |               |
|                                   |                                                                      |                                                             | $T_A = 55\text{ }^{\circ}\text{C}$                                                             | 0.31               | 0.9                   |               |
|                                   |                                                                      |                                                             | $T_A = 85\text{ }^{\circ}\text{C}$                                                             | 0.52               | 2.75                  |               |
| $I_{DD}$ (WU from Standby)        | RMS supply current during wakeup time when exiting from Standby mode | -                                                           | $V_{DD} = 3.0\text{ V}$<br>$T_A = -40\text{ }^{\circ}\text{C}$ to $25\text{ }^{\circ}\text{C}$ | 1                  | -                     | $\text{mA}$   |

1. The typical values are given for  $V_{DD} = 3.0\text{ V}$  and max values are given for  $V_{DD} = 3.6\text{ V}$ , unless otherwise specified.
2. Guaranteed by characterization results, unless otherwise specified.
3. Based on characterization done with a 32.768 kHz crystal (MC306-G-06Q-32.768, manufacturer JFVNY) with two 6.8pF loading capacitors.

### On-chip peripheral current consumption

The current consumption of the on-chip peripherals is given in the following table. The MCU is placed under the following conditions:

- all I/O pins are in input mode with a static value at  $V_{DD}$  or  $V_{SS}$  (no load)
- all peripherals are disabled unless otherwise mentioned
- the given value is calculated by measuring the current consumption
  - with all peripherals clocked off
  - with only one peripheral clocked on

**Table 25. Peripheral current consumption<sup>(1)</sup>**

| Peripheral |        | Typical consumption, $V_{DD} = 3.0\text{ V}$ , $T_A = 25\text{ °C}$ |                                                          |                                                          |                            | Unit                                       |
|------------|--------|---------------------------------------------------------------------|----------------------------------------------------------|----------------------------------------------------------|----------------------------|--------------------------------------------|
|            |        | Range 1,<br>$V_{CORE} = 1.8\text{ V}$<br>$VOS[1:0] = 01$            | Range 2,<br>$V_{CORE} = 1.5\text{ V}$<br>$VOS[1:0] = 10$ | Range 3,<br>$V_{CORE} = 1.2\text{ V}$<br>$VOS[1:0] = 11$ | Low-power<br>sleep and run |                                            |
| APB1       | TIM2   | 11.3                                                                | 9.0                                                      | 7.3                                                      | 9.0                        | $\mu\text{A}/\text{MHz}$<br>( $f_{HCLK}$ ) |
|            | TIM3   | 11.4                                                                | 9.1                                                      | 7.1                                                      | 9.1                        |                                            |
|            | TIM4   | 11.3                                                                | 9.0                                                      | 7.3                                                      | 9.0                        |                                            |
|            | TIM6   | 3.9                                                                 | 3.1                                                      | 2.5                                                      | 3.1                        |                                            |
|            | TIM7   | 4.2                                                                 | 3.3                                                      | 2.6                                                      | 3.3                        |                                            |
|            | LCD    | 4.7                                                                 | 3.6                                                      | 2.9                                                      | 3.6                        |                                            |
|            | WWDG   | 3.7                                                                 | 2.9                                                      | 2.4                                                      | 2.9                        |                                            |
|            | SPI2   | 5.9                                                                 | 4.8                                                      | 3.9                                                      | 4.8                        |                                            |
|            | USART2 | 8.1                                                                 | 6.6                                                      | 5.1                                                      | 6.6                        |                                            |
|            | USART3 | 7.9                                                                 | 6.4                                                      | 5.0                                                      | 6.4                        |                                            |
|            | I2C1   | 7.8                                                                 | 6.1                                                      | 4.9                                                      | 6.1                        |                                            |
|            | I2C2   | 7.2                                                                 | 5.7                                                      | 4.6                                                      | 5.7                        |                                            |
|            | USB    | 12.7                                                                | 10.3                                                     | 8.1                                                      | 10.3                       |                                            |
|            | PWR    | 3.1                                                                 | 2.4                                                      | 2.0                                                      | 2.4                        |                                            |
|            | DAC    | 6.6                                                                 | 5.3                                                      | 4.3                                                      | 5.3                        |                                            |
|            | COMP   | 5.3                                                                 | 4.3                                                      | 3.4                                                      | 4.3                        |                                            |

Table 25. Peripheral current consumption<sup>(1)</sup> (continued)

| Peripheral                                 |                    | Typical consumption, V <sub>DD</sub> = 3.0 V, T <sub>A</sub> = 25 °C |                                                           |                                                           |                            | Unit                           |
|--------------------------------------------|--------------------|----------------------------------------------------------------------|-----------------------------------------------------------|-----------------------------------------------------------|----------------------------|--------------------------------|
|                                            |                    | Range 1,<br>V <sub>CORE</sub> =<br>1.8 V<br>VOS[1:0] = 01            | Range 2,<br>V <sub>CORE</sub> =<br>1.5 V<br>VOS[1:0] = 10 | Range 3,<br>V <sub>CORE</sub> =<br>1.2 V<br>VOS[1:0] = 11 | Low-power<br>sleep and run |                                |
| APB2                                       | SYSCFG & RI        | 2.2                                                                  | 1.9                                                       | 1.6                                                       | 1.9                        | μA/MHz<br>(f <sub>HCLK</sub> ) |
|                                            | TIM9               | 9.1                                                                  | 7.3                                                       | 5.9                                                       | 7.3                        |                                |
|                                            | TIM10              | 6.0                                                                  | 4.9                                                       | 3.9                                                       | 4.9                        |                                |
|                                            | TIM11              | 5.8                                                                  | 4.6                                                       | 3.8                                                       | 4.6                        |                                |
|                                            | ADC <sup>(2)</sup> | 8.7                                                                  | 7.0                                                       | 5.6                                                       | 7.0                        |                                |
|                                            | SPI1               | 4.4                                                                  | 3.4                                                       | 2.8                                                       | 3.4                        |                                |
|                                            | USART1             | 8.1                                                                  | 6.5                                                       | 5.2                                                       | 6.5                        |                                |
| AHB                                        | GPIOA              | 4.4                                                                  | 3.5                                                       | 2.9                                                       | 3.5                        |                                |
|                                            | GPIOB              | 4.4                                                                  | 3.5                                                       | 2.9                                                       | 3.5                        |                                |
|                                            | GPIOC              | 3.7                                                                  | 3.0                                                       | 2.5                                                       | 3.0                        |                                |
|                                            | GPIOD              | 3.6                                                                  | 2.8                                                       | 2.4                                                       | 2.8                        |                                |
|                                            | GPIOH              | 3.7                                                                  | 2.9                                                       | 2.4                                                       | 2.9                        |                                |
|                                            | CRC                | 0.6                                                                  | 0.4                                                       | 0.4                                                       | 0.4                        |                                |
|                                            | FLASH              | 12.2                                                                 | 10.2                                                      | 7.8                                                       | _( <sup>3</sup> )          |                                |
|                                            | DMA1               | 12.4                                                                 | 10.1                                                      | 8.2                                                       | 10.1                       |                                |
| All enabled                                |                    | 160                                                                  | 135                                                       | 103                                                       | 124.8                      |                                |
| I <sub>DD</sub> (RTC)                      |                    | 0.4                                                                  |                                                           |                                                           |                            | μA                             |
| I <sub>DD</sub> (LCD)                      |                    | 3.1                                                                  |                                                           |                                                           |                            |                                |
| I <sub>DD</sub> (ADC) <sup>(4)</sup>       |                    | 1450                                                                 |                                                           |                                                           |                            |                                |
| I <sub>DD</sub> (DAC) <sup>(5)</sup>       |                    | 340                                                                  |                                                           |                                                           |                            |                                |
| I <sub>DD</sub> (COMP1)                    |                    | 0.16                                                                 |                                                           |                                                           |                            |                                |
| I <sub>DD</sub> (COMP2)                    | Slow mode          | 2                                                                    |                                                           |                                                           |                            |                                |
|                                            | Fast mode          | 5                                                                    |                                                           |                                                           |                            |                                |
| I <sub>DD</sub> (PVD / BOR) <sup>(6)</sup> |                    | 2.6                                                                  |                                                           |                                                           |                            |                                |
| I <sub>DD</sub> (IWDG)                     |                    | 0.25                                                                 |                                                           |                                                           |                            |                                |

1. Data based on differential I<sub>DD</sub> measurement between all peripherals OFF and one peripheral with clock enabled, in the following conditions: f<sub>HCLK</sub> = 32 MHz (Range 1), f<sub>HCLK</sub> = 16 MHz (Range 2), f<sub>HCLK</sub> = 4 MHz (Range 3), f<sub>HCLK</sub> = 64kHz (Low-power run/sleep), f<sub>APB1</sub> = f<sub>HCLK</sub>, f<sub>APB2</sub> = f<sub>HCLK</sub>, default prescaler value for each peripheral. The CPU is in Sleep mode in both cases. No I/O pins toggling.
2. HSI oscillator is OFF for this measure.
3. In low-power sleep and run mode, the Flash memory must always be in power-down mode.
4. Data based on a differential I<sub>DD</sub> measurement between ADC in reset configuration and continuous ADC conversion (HSI consumption not included).
5. Data based on a differential I<sub>DD</sub> measurement between DAC in reset configuration and continuous DAC conversion of V<sub>DD</sub>/2. DAC is in buffered mode, output is left floating.
6. Including supply current of internal reference voltage.

### 6.3.5 Wakeup time from Low-power mode

The wakeup times given in the following table are measured with the MSI RC oscillator. The clock source used to wake up the device depends on the current operating mode:

- Sleep mode: the clock source is the clock that was set before entering Sleep mode
- Stop mode: the clock source is the MSI oscillator in the range configured before entering Stop mode
- Standby mode: the clock source is the MSI oscillator running at 2.1 MHz

All timings are derived from tests performed under ambient temperature and  $V_{DD}$  supply voltage conditions summarized in [Table 14](#).

**Table 26. Low-power mode wakeup timings**

| Symbol            | Parameter                                                        | Conditions                                                       | Typ  | Max <sup>(1)</sup> | Unit          |
|-------------------|------------------------------------------------------------------|------------------------------------------------------------------|------|--------------------|---------------|
| $t_{WUSLEEP}$     | Wakeup from Sleep mode                                           | $f_{HCLK} = 32 \text{ MHz}$                                      | 0.4  | -                  | $\mu\text{s}$ |
| $t_{WUSLEEP\_LP}$ | Wakeup from Low-power sleep mode<br>$f_{HCLK} = 262 \text{ kHz}$ | $f_{HCLK} = 262 \text{ kHz}$<br>Flash enabled                    | 46   | -                  |               |
|                   |                                                                  | $f_{HCLK} = 262 \text{ kHz}$<br>Flash switched OFF               | 46   | -                  |               |
| $t_{WUSTOP}$      | Wakeup from Stop mode, regulator in Run mode                     | $f_{HCLK} = f_{MSI} = 4.2 \text{ MHz}$                           | 8.2  | -                  |               |
|                   | Wakeup from Stop mode, regulator in low-power mode               | $f_{HCLK} = f_{MSI} = 4.2 \text{ MHz}$<br>Voltage Ranges 1 and 2 | 7.7  | 8.9                |               |
|                   |                                                                  | $f_{HCLK} = f_{MSI} = 4.2 \text{ MHz}$<br>Voltage Range 3        | 8.2  | 13.1               |               |
|                   |                                                                  | $f_{HCLK} = f_{MSI} = 2.1 \text{ MHz}$                           | 10.2 | 13.4               |               |
|                   |                                                                  | $f_{HCLK} = f_{MSI} = 1.05 \text{ MHz}$                          | 16   | 20                 |               |
|                   |                                                                  | $f_{HCLK} = f_{MSI} = 524 \text{ kHz}$                           | 31   | 37                 |               |
|                   |                                                                  | $f_{HCLK} = f_{MSI} = 262 \text{ kHz}$                           | 57   | 66                 |               |
|                   |                                                                  | $f_{HCLK} = f_{MSI} = 131 \text{ kHz}$                           | 112  | 123                |               |
|                   |                                                                  | $f_{HCLK} = \text{MSI} = 65 \text{ kHz}$                         | 221  | 236                |               |
| $t_{WUSTDBY}$     | Wakeup from Standby mode<br>FWU bit = 1                          | $f_{HCLK} = \text{MSI} = 2.1 \text{ MHz}$                        | 58   | 104                |               |
|                   | Wakeup from Standby mode<br>FWU bit = 0                          | $f_{HCLK} = \text{MSI} = 2.1 \text{ MHz}$                        | 2.6  | 3.25               | ms            |

1. Guaranteed by characterization results, unless otherwise specified

### 6.3.6 External clock source characteristics

#### High-speed external user clock generated from an external source

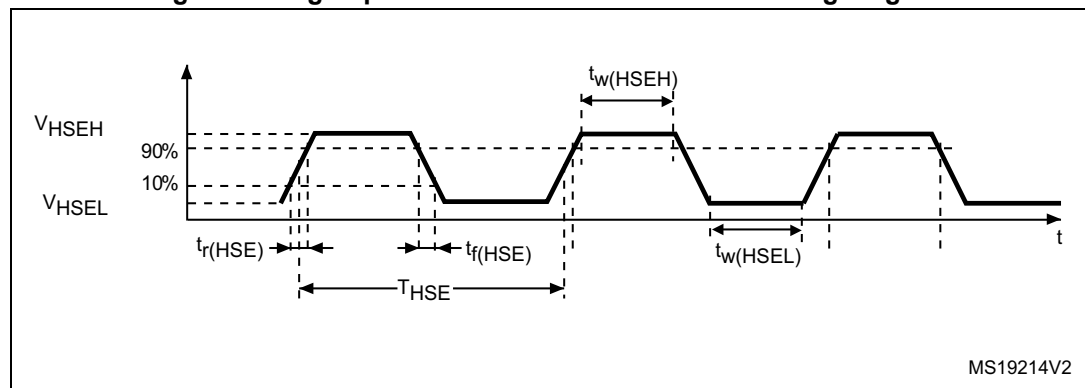
In bypass mode the HSE oscillator is switched off and the input pin is a standard GPIO. The external clock signal has to respect the I/O characteristics in [Section 6.3.13](#). However, the recommended clock input waveform is shown in [Figure 11](#).

**Table 27. High-speed external user clock characteristics<sup>(1)</sup>**

| Symbol                                                     | Parameter                            | Conditions               | Min                | Typ | Max                | Unit |
|------------------------------------------------------------|--------------------------------------|--------------------------|--------------------|-----|--------------------|------|
| $f_{\text{HSE\_ext}}$                                      | User external clock source frequency | CSS is on or PLL is used | 1                  | 8   | 32                 | MHz  |
|                                                            |                                      | CSS is off, PLL not used | 0                  |     |                    |      |
| $V_{\text{HSEH}}$                                          | OSC_IN input pin high level voltage  | -                        | $0.7V_{\text{DD}}$ | -   | $V_{\text{DD}}$    | ns   |
| $V_{\text{HSEL}}$                                          | OSC_IN input pin low level voltage   |                          | $V_{\text{SS}}$    | -   | $0.3V_{\text{DD}}$ |      |
| $t_{\text{w}}(\text{HSEH})$<br>$t_{\text{w}}(\text{HSEL})$ | OSC_IN high or low time              |                          | 12                 | -   | -                  |      |
| $t_{\text{r}}(\text{HSE})$<br>$t_{\text{f}}(\text{HSE})$   | OSC_IN rise or fall time             |                          | -                  | -   | 20                 |      |
| $C_{\text{in}}(\text{HSE})$                                | OSC_IN input capacitance             | -                        | -                  | 2.6 | -                  | pF   |

1. Guaranteed by design.

**Figure 11. High-speed external clock source AC timing diagram**



### Low-speed external user clock generated from an external source

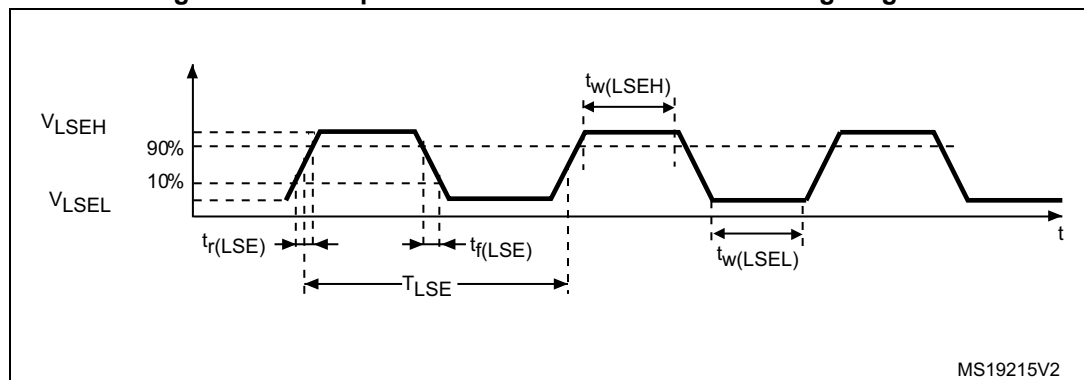
The characteristics given in the following table result from tests performed using a low-speed external clock source, and under ambient temperature and supply voltage conditions summarized in [Table 14](#).

**Table 28. Low-speed external user clock characteristics<sup>(1)</sup>**

| Symbol                         | Parameter                             | Min         | Typ    | Max         | Unit |
|--------------------------------|---------------------------------------|-------------|--------|-------------|------|
| $f_{LSE\_ext}$                 | User external clock source frequency  | 1           | 32.768 | 1000        | kHz  |
| $V_{LSEH}$                     | OSC32_IN input pin high level voltage | $0.7V_{DD}$ | -      | $V_{DD}$    | -    |
| $V_{LSEL}$                     | OSC32_IN input pin low level voltage  | $V_{SS}$    | -      | $0.3V_{DD}$ | -    |
| $t_{w(LSEH)}$<br>$t_{w(LSEL)}$ | OSC32_IN high or low time             | 465         | -      | -           | ns   |
| $t_{r(LSE)}$<br>$t_{f(LSE)}$   | OSC32_IN rise or fall time            | -           | -      | 10          |      |
| $C_{IN(LSE)}$                  | OSC32_IN input capacitance            | -           | 0.6    | -           | pF   |

1. Guaranteed by design.

**Figure 12. Low-speed external clock source AC timing diagram**



### High-speed external clock generated from a crystal/ceramic resonator

The high-speed external (HSE) clock can be supplied with a 1 to 24 MHz crystal/ceramic resonator oscillator. All the information given in this paragraph are based on characterization results obtained with typical external components specified in [Table 29](#). In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details on the resonator characteristics (frequency, package, accuracy).

**Table 29. HSE oscillator characteristics<sup>(1)(2)</sup>**

| Symbol        | Parameter            | Conditions | Min | Typ | Max | Unit       |
|---------------|----------------------|------------|-----|-----|-----|------------|
| $f_{OSC\_IN}$ | Oscillator frequency | -          | 1   |     | 24  | MHz        |
| $R_F$         | Feedback resistor    | -          |     | 200 | -   | k $\Omega$ |

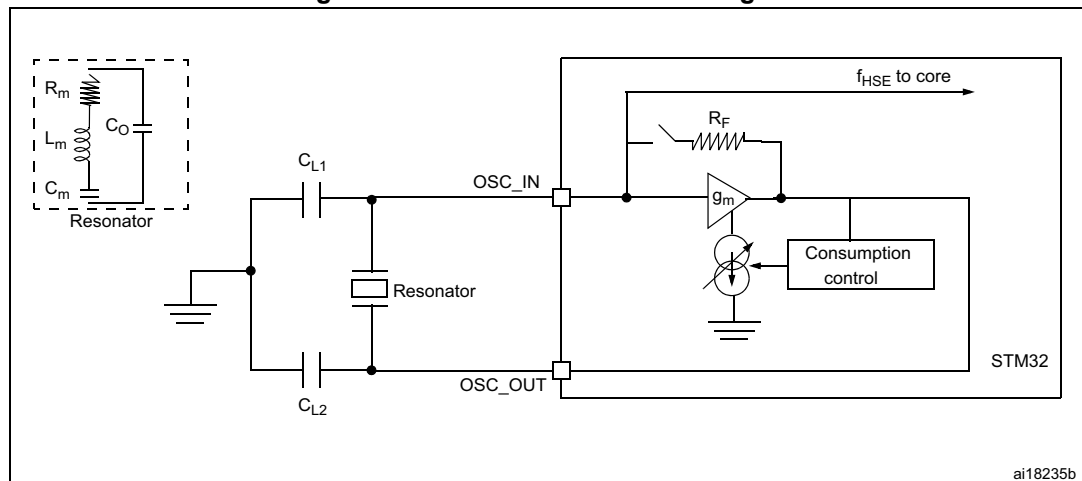
Table 29. HSE oscillator characteristics<sup>(1)(2)</sup> (continued)

| Symbol              | Parameter                                                                                                | Conditions                                                      | Min | Typ | Max                                | Unit |
|---------------------|----------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------|-----|-----|------------------------------------|------|
| C                   | Recommended load capacitance versus equivalent serial resistance of the crystal ( $R_S$ ) <sup>(3)</sup> | $R_S = 30 \Omega$                                               | -   | 20  | -                                  | pF   |
| $I_{HSE}$           | HSE driving current                                                                                      | $V_{DD} = 3.3 \text{ V}$ , $V_{IN} = V_{SS}$<br>with 30 pF load | -   | -   | 3                                  | mA   |
| $I_{DD(HSE)}$       | HSE oscillator power consumption                                                                         | $C = 20 \text{ pF}$<br>$f_{OSC} = 16 \text{ MHz}$               | -   | -   | 2.5 (startup)<br>0.7 (stabilized)  | mA   |
|                     |                                                                                                          | $C = 10 \text{ pF}$<br>$f_{OSC} = 16 \text{ MHz}$               | -   | -   | 2.5 (startup)<br>0.46 (stabilized) |      |
| $g_m$               | Oscillator transconductance                                                                              | Startup                                                         | 3.5 | -   | -                                  | mA/V |
| $t_{SU(HSE)}^{(4)}$ | Startup time                                                                                             | $V_{DD}$ is stabilized                                          | -   | 1   | -                                  | ms   |

1. Resonator characteristics given by the crystal/ceramic resonator manufacturer.
2. Guaranteed by characterization results.
3. The relatively low value of the RF resistor offers a good protection against issues resulting from use in a humid environment, due to the induced leakage and the bias condition change. However, it is recommended to take this point into account if the MCU is used in tough humidity conditions.
4.  $t_{SU(HSE)}$  is the startup time measured from the moment it is enabled (by software) to a stabilized 8 MHz oscillation is reached. This value is measured for a standard crystal resonator and it can vary significantly with the crystal manufacturer.

For  $C_{L1}$  and  $C_{L2}$ , it is recommended to use high-quality external ceramic capacitors in the 5 pF to 25 pF range (typ.), designed for high-frequency applications, and selected to match the requirements of the crystal or resonator (see [Figure 13](#)).  $C_{L1}$  and  $C_{L2}$  are usually the same size. The crystal manufacturer typically specifies a load capacitance which is the series combination of  $C_{L1}$  and  $C_{L2}$ . PCB and MCU pin capacitance must be included (10 pF can be used as a rough estimate of the combined pin and board capacitance) when sizing  $C_{L1}$  and  $C_{L2}$ . Refer to the application note AN2867 "Oscillator design guide for ST microcontrollers" available from the ST website [www.st.com](http://www.st.com).

Figure 13. HSE oscillator circuit diagram



### Low-speed external clock generated from a crystal/ceramic resonator

The low-speed external (LSE) clock can be supplied with a 32.768 kHz crystal/ceramic resonator oscillator. All the information given in this paragraph are based on characterization results obtained with typical external components specified in [Table 14](#). In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details on the resonator characteristics (frequency, package, accuracy).

**Table 30. LSE oscillator characteristics ( $f_{LSE} = 32.768 \text{ kHz}$ )<sup>(1)</sup>**

| Symbol                 | Parameter                                                                                                | Conditions                                   | Min | Typ    | Max | Unit |
|------------------------|----------------------------------------------------------------------------------------------------------|----------------------------------------------|-----|--------|-----|------|
| $f_{LSE}$              | Low speed external oscillator frequency                                                                  | -                                            | -   | 32.768 | -   | kHz  |
| $R_F$                  | Feedback resistor                                                                                        | -                                            | -   | 1.2    | -   | MΩ   |
| $C^{(2)}$              | Recommended load capacitance versus equivalent serial resistance of the crystal ( $R_S$ ) <sup>(3)</sup> | $R_S = 30 \text{ k}\Omega$                   | -   | 8      | -   | pF   |
| $I_{LSE}$              | LSE driving current                                                                                      | $V_{DD} = 3.3 \text{ V}$ , $V_{IN} = V_{SS}$ | -   | -      | 1.1 | μA   |
| $I_{DD} \text{ (LSE)}$ | LSE oscillator current consumption                                                                       | $V_{DD} = 1.8 \text{ V}$                     | -   | 450    | -   | nA   |
|                        |                                                                                                          | $V_{DD} = 3.0 \text{ V}$                     | -   | 600    | -   |      |
|                        |                                                                                                          | $V_{DD} = 3.6 \text{ V}$                     | -   | 750    | -   |      |
| $g_m$                  | Oscillator transconductance                                                                              | -                                            | 3   | -      | -   | μA/V |
| $t_{SU(LSE)}^{(4)}$    | Startup time                                                                                             | $V_{DD}$ is stabilized                       | -   | 1      | -   | s    |

1. Guaranteed by characterization results.
2. Refer to the note and caution paragraphs below the table, and to the application note AN2867 "Oscillator design guide for ST microcontrollers".
3. The oscillator selection can be optimized in terms of supply current using an high quality resonator with small  $R_S$  value for example MSIV-TIN32.768kHz. Refer to crystal manufacturer for more details.
4.  $t_{SU(LSE)}$  is the startup time measured from the moment it is enabled (by software) to a stabilized 32.768 kHz oscillation is reached. This value is measured for a standard crystal resonator and it can vary significantly with the crystal manufacturer.

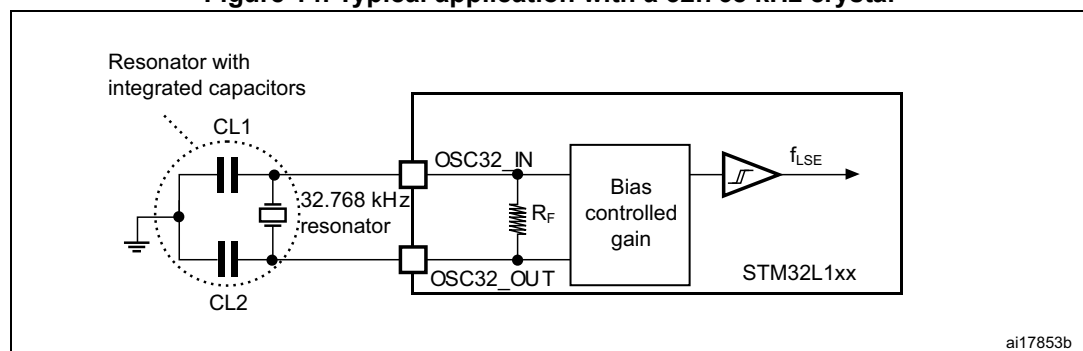
**Note:** For CL1 and CL2, it is recommended to use high-quality ceramic capacitors in the 5 pF to 15 pF range selected to match the requirements of the crystal or resonator (see [Figure 14](#)). CL1 and CL2, are usually the same size. The crystal manufacturer typically specifies a load capacitance which is the series combination of CL1 and CL2.

Load capacitance CL has the following formula:  $CL = CL1 \times CL2 / (CL1 + CL2) + C_{stray}$  where  $C_{stray}$  is the pin capacitance and board or trace PCB-related capacitance. Typically, it is between 2 pF and 7 pF.

**Caution:** To avoid exceeding the maximum value of CL1 and CL2 (15 pF) it is strongly recommended to use a resonator with a load capacitance  $CL \leq 7$  pF. Never use a resonator with a load capacitance of 12.5 pF.

Example: if the user chooses a resonator with a load capacitance of  $CL = 6$  pF and  $C_{stray} = 2$  pF, then  $CL1 = CL2 = 8$  pF.

**Figure 14. Typical application with a 32.768 kHz crystal**



ai17853b

### 6.3.7 Internal clock source characteristics

The parameters given in the following table are derived from tests performed under ambient temperature and  $V_{DD}$  supply voltage conditions summarized in [Table 14](#).

#### High-speed internal (HSI) RC oscillator

**Table 31. HSI oscillator characteristics**

| Symbol              | Parameter                        | Conditions                                                                                   | Min | Typ       | Max       | Unit          |
|---------------------|----------------------------------|----------------------------------------------------------------------------------------------|-----|-----------|-----------|---------------|
| $f_{HSI}$           | Frequency                        | $V_{DD} = 3.0\text{ V}$                                                                      | -   | 16        | -         | MHz           |
| $TRIM^{(1)(2)}$     | HSI user-trimmed resolution      | Trimming code is not a multiple of 16                                                        | -   | $\pm 0.4$ | 0.7       | %             |
|                     |                                  | Trimming code is a multiple of 16                                                            | -   | -         | $\pm 1.5$ | %             |
| $ACC_{HSI}^{(2)}$   | -                                | $V_{DDA} = 1.8\text{ V to }3.6\text{ V}$<br>$T_A = -40\text{ to }85\text{ }^{\circ}\text{C}$ | -10 | -         | +10       | %             |
| $t_{SU(HSI)}^{(2)}$ | HSI oscillator startup time      | -                                                                                            | -   | 3.7       | 6         | $\mu\text{s}$ |
| $I_{DD(HSI)}^{(2)}$ | HSI oscillator power consumption | -                                                                                            | -   | 100       | 140       | $\mu\text{A}$ |

1. The trimming step differs depending on the trimming code. It is usually negative on the codes which are multiples of 16 (0x00, 0x10, 0x20, 0x30...0xE0).
2. Guaranteed by characterization results.

#### Low-speed internal (LSI) RC oscillator

**Table 32. LSI oscillator characteristics**

| Symbol              | Parameter                                                                              | Min | Typ | Max | Unit          |
|---------------------|----------------------------------------------------------------------------------------|-----|-----|-----|---------------|
| $f_{LSI}^{(1)}$     | LSI frequency                                                                          | 26  | 38  | 56  | kHz           |
| $D_{LSI}^{(2)}$     | LSI oscillator frequency drift<br>$0^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ | -10 | -   | 4   | %             |
| $t_{SU(LSI)}^{(3)}$ | LSI oscillator startup time                                                            | -   | -   | 200 | $\mu\text{s}$ |
| $I_{DD(LSI)}^{(3)}$ | LSI oscillator power consumption                                                       | -   | 400 | 510 | nA            |

1. Guaranteed by test in production.
2. This is a deviation for an individual part, once the initial frequency has been measured.
3. Guaranteed by design.

## Multi-speed internal (MSI) RC oscillator

Table 33. MSI oscillator characteristics

| Symbol                              | Parameter                                                                                                                              | Condition                                | Typ       | Max | Unit          |
|-------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------|-----------|-----|---------------|
| $f_{\text{MSI}}$                    | Frequency after factory calibration, done at $V_{\text{DD}} = 3.3 \text{ V}$ and $T_{\text{A}} = 25 \text{ }^{\circ}\text{C}$          | MSI range 0                              | 65.5      | -   | kHz           |
|                                     |                                                                                                                                        | MSI range 1                              | 131       | -   |               |
|                                     |                                                                                                                                        | MSI range 2                              | 262       | -   |               |
|                                     |                                                                                                                                        | MSI range 3                              | 524       | -   |               |
|                                     |                                                                                                                                        | MSI range 4                              | 1.05      | -   | MHz           |
|                                     |                                                                                                                                        | MSI range 5                              | 2.1       | -   |               |
|                                     |                                                                                                                                        | MSI range 6                              | 4.2       | -   |               |
| $\text{ACC}_{\text{MSI}}$           | Frequency error after factory calibration                                                                                              | -                                        | $\pm 0.5$ | -   | %             |
| $D_{\text{TEMP}(\text{MSI})}^{(1)}$ | MSI oscillator frequency drift<br>$0 \text{ }^{\circ}\text{C} \leq T_{\text{A}} \leq 85 \text{ }^{\circ}\text{C}$                      | -                                        | $\pm 10$  | -   | %             |
| $D_{\text{VOLT}(\text{MSI})}^{(1)}$ | MSI oscillator frequency drift<br>$1.8 \text{ V} \leq V_{\text{DD}} \leq 3.6 \text{ V}$ , $T_{\text{A}} = 25 \text{ }^{\circ}\text{C}$ | -                                        | -         | 2.5 | %/V           |
| $I_{\text{DD}(\text{MSI})}^{(2)}$   | MSI oscillator power consumption                                                                                                       | MSI range 0                              | 0.75      | -   | $\mu\text{A}$ |
|                                     |                                                                                                                                        | MSI range 1                              | 1         | -   |               |
|                                     |                                                                                                                                        | MSI range 2                              | 1.5       | -   |               |
|                                     |                                                                                                                                        | MSI range 3                              | 2.5       | -   |               |
|                                     |                                                                                                                                        | MSI range 4                              | 4.5       | -   |               |
|                                     |                                                                                                                                        | MSI range 5                              | 8         | -   |               |
|                                     |                                                                                                                                        | MSI range 6                              | 15        | -   |               |
| $t_{\text{SU}(\text{MSI})}$         | MSI oscillator startup time                                                                                                            | MSI range 0                              | 30        | -   | $\mu\text{s}$ |
|                                     |                                                                                                                                        | MSI range 1                              | 20        | -   |               |
|                                     |                                                                                                                                        | MSI range 2                              | 15        | -   |               |
|                                     |                                                                                                                                        | MSI range 3                              | 10        | -   |               |
|                                     |                                                                                                                                        | MSI range 4                              | 6         | -   |               |
|                                     |                                                                                                                                        | MSI range 5                              | 5         | -   |               |
|                                     |                                                                                                                                        | MSI range 6,<br>Voltage range 1<br>and 2 | 3.5       | -   |               |
|                                     |                                                                                                                                        | MSI range 6,<br>Voltage range 3          | 5         | -   |               |

Table 33. MSI oscillator characteristics (continued)

| Symbol                       | Parameter                          | Condition                                | Typ | Max | Unit          |
|------------------------------|------------------------------------|------------------------------------------|-----|-----|---------------|
| $t_{\text{STAB(MSI)}}^{(2)}$ | MSI oscillator stabilization time  | MSI range 0                              | -   | 40  | $\mu\text{s}$ |
|                              |                                    | MSI range 1                              | -   | 20  |               |
|                              |                                    | MSI range 2                              | -   | 10  |               |
|                              |                                    | MSI range 3                              | -   | 4   |               |
|                              |                                    | MSI range 4                              | -   | 2.5 |               |
|                              |                                    | MSI range 5                              | -   | 2   |               |
|                              |                                    | MSI range 6,<br>Voltage range 1<br>and 2 | -   | 2   |               |
|                              |                                    | MSI range 3,<br>Voltage Range 3          | -   | 3   |               |
| $f_{\text{OVER(MSI)}}$       | MSI oscillator frequency overshoot | Any range to<br>range 5                  | -   | 4   | MHz           |
|                              |                                    | Any range to<br>range 6                  | -   | 6   |               |

1. This is a deviation for an individual part, once the initial frequency has been measured.
2. Guaranteed by characterization results.

### 6.3.8 PLL characteristics

The parameters given in [Table 34](#) are derived from tests performed under ambient temperature and  $V_{\text{DD}}$  supply voltage conditions summarized in [Table 14](#).

Table 34. PLL characteristics

| Symbol                | Parameter                                               | Value |     |                    | Unit          |
|-----------------------|---------------------------------------------------------|-------|-----|--------------------|---------------|
|                       |                                                         | Min   | Typ | Max <sup>(1)</sup> |               |
| $f_{\text{PLL\_IN}}$  | PLL input clock <sup>(2)</sup>                          | 2     | -   | 24                 | MHz           |
|                       | PLL input clock duty cycle                              | 45    | -   | 55                 | %             |
| $f_{\text{PLL\_OUT}}$ | PLL output clock                                        | 2     | -   | 32                 | MHz           |
| $t_{\text{LOCK}}$     | PLL lock time<br>PLL input = 16 MHz<br>PLL VCO = 96 MHz | -     | 115 | 160                | $\mu\text{s}$ |
| Jitter                | Cycle-to-cycle jitter                                   | -     | -   | $\pm 600$          | ps            |
| $I_{\text{DDA(PLL)}}$ | Current consumption on $V_{\text{DDA}}$                 | -     | 220 | 450                | $\mu\text{A}$ |
| $I_{\text{DD(PLL)}}$  | Current consumption on $V_{\text{DD}}$                  | -     | 120 | 150                |               |

1. Guaranteed by characterization results.
2. Take care of using the appropriate multiplier factors so as to have PLL input clock values compatible with the range defined by  $f_{\text{PLL\_OUT}}$ .

### 6.3.9 Memory characteristics

The characteristics are given at  $T_A = -40$  to  $85$  °C unless otherwise specified.

#### RAM memory

**Table 35. RAM and hardware registers**

| Symbol | Parameter                          | Conditions           | Min | Typ | Max | Unit |
|--------|------------------------------------|----------------------|-----|-----|-----|------|
| VRM    | Data retention mode <sup>(1)</sup> | STOP mode (or RESET) | 1.8 | -   | -   | V    |

1. Minimum supply voltage without losing data stored in RAM (in Stop mode or under Reset) or in hardware registers (only in Stop mode).

#### Flash memory and data EEPROM

**Table 36. Flash memory and data EEPROM characteristics**

| Symbol     | Parameter                                                                   | Conditions                      | Min | Typ  | Max <sup>(1)</sup> | Unit    |
|------------|-----------------------------------------------------------------------------|---------------------------------|-----|------|--------------------|---------|
| $V_{DD}$   | Operating voltage<br>Read / Write / Erase                                   | -                               | 1.8 | -    | 3.6                | V       |
| $t_{prog}$ | Programming / erasing time for<br>byte / word / double word / half-<br>page | Erasing                         | -   | 3.28 | 3.94               | ms      |
|            |                                                                             | Programming                     | -   | 3.28 | 3.94               |         |
| $I_{DD}$   | Average current during whole<br>program/erase operation                     | $T_A = 25$ °C, $V_{DD} = 3.6$ V | -   | 300  | -                  | $\mu$ A |
|            | Maximum current (peak) during<br>program/erase operation                    |                                 | -   | 1.5  | 2.5                | mA      |

1. Guaranteed by design.

**Table 37. Flash memory, data EEPROM endurance and data retention**

| Symbol          | Parameter                                                                 | Conditions                   | Value              |     |     | Unit    |
|-----------------|---------------------------------------------------------------------------|------------------------------|--------------------|-----|-----|---------|
|                 |                                                                           |                              | Min <sup>(1)</sup> | Typ | Max |         |
| $N_{CYC}^{(2)}$ | Cycling (erase / write)<br>Program memory                                 | $T_A = -40$ °C to<br>$85$ °C | 1                  | -   | -   | kcycles |
|                 | Cycling (erase / write)<br>EEPROM data memory                             |                              | 100                | -   | -   |         |
| $t_{RET}^{(2)}$ | Data retention (program memory) after<br>1 kcycle at $T_A = 85$ °C        | $T_{RET} = +85$ °C           | 10                 | -   | -   | years   |
|                 | Data retention (EEPROM data memory)<br>after 100 kcycles at $T_A = 85$ °C |                              | 10                 | -   | -   |         |

1. Guaranteed by characterization results.

2. Characterization is done according to JEDEC JESD22-A117.

### 6.3.10 EMC characteristics

Susceptibility tests are performed on a sample basis during the device characterization.

#### Functional EMS (electromagnetic susceptibility)

While a simple application is executed on the device (toggling 2 LEDs through I/O ports), the device is stressed by two electromagnetic events until a failure occurs. The failure is indicated by the LEDs:

- **Electrostatic discharge (ESD)** (positive and negative) is applied to all device pins until a functional disturbance occurs. This test is compliant with the IEC 61000-4-2 standard.
- **FTB: A Burst of Fast Transient voltage** (positive and negative) is applied to  $V_{DD}$  and  $V_{SS}$  through a 100 pF capacitor, until a functional disturbance occurs. This test is compliant with the IEC 61000-4-4 standard.

A device reset allows normal operations to be resumed.

The test results are given in [Table 38](#). They are based on the EMS levels and classes defined in application note AN1709.

**Table 38. EMS characteristics**

| Symbol     | Parameter                                                                                                                         | Conditions                                                                                                            | Level/Class |
|------------|-----------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------|-------------|
| $V_{FESD}$ | Voltage limits to be applied on any I/O pin to induce a functional disturbance                                                    | $V_{DD} = 3.3\text{ V}$ , LQFP100, $T_A = +25\text{ °C}$ ,<br>$f_{HCLK} = 32\text{ MHz}$<br>conforms to IEC 61000-4-2 | 3B          |
| $V_{EFTB}$ | Fast transient voltage burst limits to be applied through 100 pF on $V_{DD}$ and $V_{SS}$ pins to induce a functional disturbance | $V_{DD} = 3.3\text{ V}$ , LQFP100, $T_A = +25\text{ °C}$ ,<br>$f_{HCLK} = 32\text{ MHz}$<br>conforms to IEC 61000-4-4 | 4A          |

#### Designing hardened software to avoid noise problems

EMC characterization and optimization are performed at component level with a typical application environment and simplified MCU software. It should be noted that good EMC performance is highly dependent on the user application and the software in particular.

Therefore it is recommended that the user applies EMC software optimization and prequalification tests in relation with the EMC level requested for his application.

##### Software recommendations

The software flowchart must include the management of runaway conditions such as:

- Corrupted program counter
- Unexpected reset
- Critical data corruption (control registers...)

##### Prequalification trials

Most of the common failures (unexpected reset and program counter corruption) can be reproduced by manually forcing a low state on the NRST pin or the oscillator pins for 1 second.

To complete these trials, ESD stress can be applied directly on the device, over the range of specification values. When unexpected behavior is detected, the software can be hardened to prevent unrecoverable errors occurring (see application note AN1015).

### Electromagnetic Interference (EMI)

The electromagnetic field emitted by the device are monitored while a simple application is executed (toggling 2 LEDs through the I/O ports). This emission test is compliant with IEC 61967-2 standard which specifies the test board and the pin loading.

**Table 39. EMI characteristics**

| Symbol           | Parameter  | Conditions                                                                                           | Monitored frequency band | Max vs. frequency range |                        |                        | Unit |
|------------------|------------|------------------------------------------------------------------------------------------------------|--------------------------|-------------------------|------------------------|------------------------|------|
|                  |            |                                                                                                      |                          | 4 MHz voltage Range 3   | 16 MHz voltage Range 2 | 32 MHz voltage Range 1 |      |
| S <sub>EMI</sub> | Peak level | V <sub>DD</sub> = 3.3 V,<br>T <sub>A</sub> = 25 °C,<br>LQFP100 package<br>compliant with IEC 61967-2 | 0.1 to 30 MHz            | -16                     | -7                     | -3                     | dBμV |
|                  |            |                                                                                                      | 30 to 130 MHz            | -12                     | 2                      | 12                     |      |
|                  |            |                                                                                                      | 130 MHz to 1GHz          | -11                     | 0                      | 8                      |      |
|                  |            |                                                                                                      | SAE EMI Level            | 1                       | 1.5                    | 2                      | -    |

### 6.3.11 Electrical sensitivity characteristics

Based on three different tests (ESD, LU) using specific measurement methods, the device is stressed in order to determine its performance in terms of electrical sensitivity.

#### Electrostatic discharge (ESD)

Electrostatic discharges (a positive then a negative pulse separated by 1 second) are applied to the pins of each sample according to each pin combination. The sample size depends on the number of supply pins in the device (3 parts × (n+1) supply pins). This test conforms to the JESD22-A114, ANSI/ESD STM5.3.1 standard.

**Table 40. ESD absolute maximum ratings**

| Symbol                | Ratings                                               | Conditions                                               | Packages | Class | Maximum value <sup>(1)</sup> | Unit |
|-----------------------|-------------------------------------------------------|----------------------------------------------------------|----------|-------|------------------------------|------|
| V <sub>ESD(HBM)</sub> | Electrostatic discharge voltage (human body model)    | T <sub>A</sub> = +25 °C, conforming to JESD22-A114       | All      | 2     | 2000                         | V    |
| V <sub>ESD(CDM)</sub> | Electrostatic discharge voltage (charge device model) | T <sub>A</sub> = +25 °C, conforming to ANSI/ESD STM5.3.1 | All      | C4    | 500                          | V    |

1. Guaranteed by characterization results.

### Static latch-up

Two complementary static tests are required on six parts to assess the latch-up performance:

- A supply overvoltage is applied to each power supply pin
- A current injection is applied to each input, output and configurable I/O pin

These tests are compliant with EIA/JESD 78A IC latch-up standard.

**Table 41. Electrical sensitivities**

| Symbol | Parameter             | Conditions                                                | Class      |
|--------|-----------------------|-----------------------------------------------------------|------------|
| LU     | Static latch-up class | $T_A = +85\text{ }^{\circ}\text{C}$ conforming to JESD78A | II level A |

### 6.3.12 I/O current injection characteristics

As a general rule, current injection to the I/O pins, due to external voltage below  $V_{SS}$  or above  $V_{DD}$  (for standard pins) should be avoided during normal product operation. However, in order to give an indication of the robustness of the microcontroller in cases when abnormal injection accidentally happens, susceptibility tests are performed on a sample basis during device characterization.

#### Functional susceptibility to I/O current injection

While a simple application is executed on the device, the device is stressed by injecting current into the I/O pins programmed in floating input mode. While current is injected into the I/O pin, one at a time, the device is checked for functional failures.

The failure is indicated by an out of range parameter: ADC error above a certain limit (higher than 5 LSB TUE), out of conventional limits of induced leakage current on adjacent pins (out of  $-5\text{ }\mu\text{A}/+0\text{ }\mu\text{A}$  range), or other functional failure (for example reset occurrence, oscillator frequency deviation, LCD levels).

The test results are given in [Table 42](#).

**Table 42. I/O current injection susceptibility**

| Symbol    | Description                                    | Functional susceptibility |                    | Unit |
|-----------|------------------------------------------------|---------------------------|--------------------|------|
|           |                                                | Negative injection        | Positive injection |      |
| $I_{INJ}$ | Injected current on all 5 V tolerant (FT) pins | -5                        | NA <sup>(1)</sup>  | mA   |
|           | Injected current on BOOT0                      | -0                        | NA <sup>(1)</sup>  |      |
|           | Injected current on any other pin              | -5                        | +5                 |      |

1. Injection is not possible.

**Note:** *It is recommended to add a Schottky diode (pin to ground) to analog pins which may potentially inject negative currents.*

### 6.3.13 I/O port characteristics

#### General input/output characteristics

Unless otherwise specified, the parameters given in [Table 43](#) are derived from tests performed under conditions summarized in [Table 14](#). All I/Os are CMOS and TTL compliant.

**Table 43. I/O static characteristics**

| Symbol    | Parameter                                             | Conditions                                                            | Min                        | Typ                 | Max                   | Unit       |
|-----------|-------------------------------------------------------|-----------------------------------------------------------------------|----------------------------|---------------------|-----------------------|------------|
| $V_{IL}$  | Input low level voltage                               | TC and FT I/O                                                         | -                          | -                   | $0.3 V_{DD}^{(1)(2)}$ | V          |
|           |                                                       | BOOT0                                                                 | -                          | -                   | $0.14 V_{DD}^{(2)}$   |            |
| $V_{IH}$  | Input high level voltage                              | TC I/O                                                                | $0.45 V_{DD} + 0.38^{(2)}$ | -                   | -                     |            |
|           |                                                       | FT I/O                                                                | $0.39 V_{DD} + 0.59^{(2)}$ | -                   | -                     |            |
|           |                                                       | BOOT0                                                                 | $0.15 V_{DD} + 0.56^{(2)}$ | -                   | -                     |            |
| $V_{hys}$ | I/O Schmitt trigger voltage hysteresis <sup>(2)</sup> | TC and FT I/O                                                         | -                          | $10\% V_{DD}^{(3)}$ | -                     |            |
|           |                                                       | BOOT0                                                                 | -                          | 0.01                | -                     |            |
| $I_{lkg}$ | Input leakage current <sup>(4)</sup>                  | $V_{SS} \leq V_{IN} \leq V_{DD}$<br>I/Os with LCD                     | -                          | -                   | $\pm 50$              | nA         |
|           |                                                       | $V_{SS} \leq V_{IN} \leq V_{DD}$<br>I/Os with analog switches         | -                          | -                   | $\pm 50$              |            |
|           |                                                       | $V_{SS} \leq V_{IN} \leq V_{DD}$<br>I/Os with analog switches and LCD | -                          | -                   | $\pm 50$              |            |
|           |                                                       | $V_{SS} \leq V_{IN} \leq V_{DD}$<br>I/Os with USB                     | -                          | -                   | $\pm 250$             |            |
|           |                                                       | $V_{SS} \leq V_{IN} \leq V_{DD}$<br>TC and FT I/O                     | -                          | -                   | $\pm 50$              |            |
|           |                                                       | FT I/O<br>$V_{DD} \leq V_{IN} \leq 5V$                                | -                          | -                   | $\pm 10$              | uA         |
| $R_{PU}$  | Weak pull-up equivalent resistor <sup>(5)(1)</sup>    | $V_{IN} = V_{SS}$                                                     | 25                         | 45                  | 65                    | k $\Omega$ |
| $R_{PD}$  | Weak pull-down equivalent resistor <sup>(5)</sup>     | $V_{IN} = V_{DD}$                                                     | 25                         | 45                  | 65                    | k $\Omega$ |
| $C_{IO}$  | I/O pin capacitance                                   | -                                                                     | -                          | 5                   | -                     | pF         |

1. Guaranteed by test in production.

2. Guaranteed by design.

3. With a minimum of 200 mV.

4. The max. value may be exceeded if negative current is injected on adjacent pins.

5. Pull-up and pull-down resistors are designed with a true resistance in series with a switchable PMOS/NMOS. This PMOS/NMOS contribution to the series resistance is minimal (~10% order).

### Output driving current

The GPIOs (general purpose input/outputs) can sink or source up to  $\pm 8$  mA, and sink or source up to  $\pm 20$  mA (with the non-standard  $V_{OL}/V_{OH}$  specifications given in [Table 44](#)).

In the user application, the number of I/O pins which can drive current must be limited to respect the absolute maximum rating specified in [Section 6.2](#):

- The sum of the currents sourced by all the I/Os on  $V_{DD}$ , plus the maximum Run consumption of the MCU sourced on  $V_{DD}$ , cannot exceed the absolute maximum rating  $\Sigma I_{VDD}$  (see [Table 12](#)).
- The sum of the currents sunk by all the I/Os on  $V_{SS}$  plus the maximum Run consumption of the MCU sunk on  $V_{SS}$  cannot exceed the absolute maximum rating  $\Sigma I_{VSS}$  (see [Table 12](#)).

### Output voltage levels

Unless otherwise specified, the parameters given in [Table 44](#) are derived from tests performed under ambient temperature and  $V_{DD}$  supply voltage conditions summarized in [Table 14](#). All I/Os are CMOS and TTL compliant.

**Table 44. Output voltage characteristics**

| Symbol            | Parameter                                | Conditions                                       | Min           | Max  | Unit |
|-------------------|------------------------------------------|--------------------------------------------------|---------------|------|------|
| $V_{OL}^{(1)(2)}$ | Output low level voltage for an I/O pin  | $I_{IO} = 8$ mA<br>$2.7$ V < $V_{DD}$ < $3.6$ V  | -             | 0.4  | V    |
| $V_{OH}^{(3)(2)}$ | Output high level voltage for an I/O pin |                                                  | $V_{DD}-0.4$  | -    |      |
| $V_{OL}^{(1)(4)}$ | Output low level voltage for an I/O pin  | $I_{IO} = 4$ mA<br>$1.8$ V < $V_{DD}$ < $2.7$ V  | -             | 0.45 |      |
| $V_{OH}^{(3)(4)}$ | Output high level voltage for an I/O pin |                                                  | $V_{DD}-0.45$ | -    |      |
| $V_{OL}^{(1)(4)}$ | Output low level voltage for an I/O pin  | $I_{IO} = 20$ mA<br>$2.7$ V < $V_{DD}$ < $3.6$ V | -             | 1.3  |      |
| $V_{OH}^{(3)(4)}$ | Output high level voltage for an I/O pin |                                                  | $V_{DD}-1.3$  | -    |      |

1. The  $I_{IO}$  current sunk by the device must always respect the absolute maximum rating specified in [Table 12](#) and the sum of  $I_{IO}$  (I/O ports and control pins) must not exceed  $I_{VSS}$ .
2. Guaranteed by test in production.
3. The  $I_{IO}$  current sourced by the device must always respect the absolute maximum rating specified in [Table 12](#) and the sum of  $I_{IO}$  (I/O ports and control pins) must not exceed  $I_{VDD}$ .
4. Guaranteed by characterization results.

### Input/output AC characteristics

The definition and values of input/output AC characteristics are given in [Figure 15](#) and [Table 45](#), respectively.

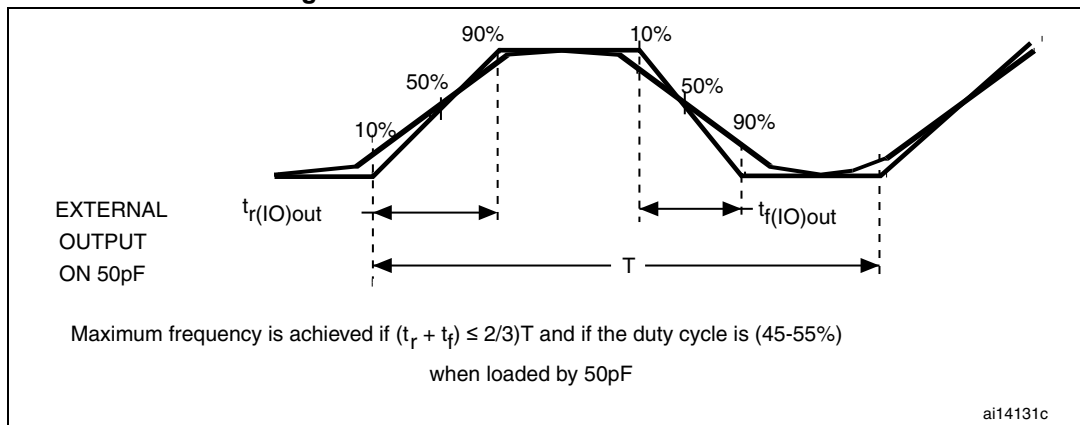
Unless otherwise specified, the parameters given in [Table 45](#) are derived from tests performed under ambient temperature and  $V_{DD}$  supply voltage conditions summarized in [Table 14](#).

**Table 45. I/O AC characteristics<sup>(1)</sup>**

| OSPEEDRx<br>[1:0] bit<br>value <sup>(1)</sup> | Symbol                                                       | Parameter                                                       | Conditions                                                         | Min | Max <sup>(2)</sup> | Unit |
|-----------------------------------------------|--------------------------------------------------------------|-----------------------------------------------------------------|--------------------------------------------------------------------|-----|--------------------|------|
| 00                                            | $f_{\max(\text{IO})\text{out}}$                              | Maximum frequency <sup>(3)</sup>                                | $C_L = 50 \text{ pF}$ , $V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$ | -   | 400                | kHz  |
|                                               |                                                              |                                                                 | $C_L = 50 \text{ pF}$ , $V_{DD} = 1.8 \text{ V to } 2.7 \text{ V}$ | -   | 400                |      |
|                                               | $t_{f(\text{IO})\text{out}}$<br>$t_{r(\text{IO})\text{out}}$ | Output rise and fall time                                       | $C_L = 50 \text{ pF}$ , $V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$ | -   | 625                | ns   |
|                                               |                                                              |                                                                 | $C_L = 50 \text{ pF}$ , $V_{DD} = 1.8 \text{ V to } 2.7 \text{ V}$ | -   | 625                |      |
| 01                                            | $f_{\max(\text{IO})\text{out}}$                              | Maximum frequency <sup>(3)</sup>                                | $C_L = 50 \text{ pF}$ , $V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$ | -   | 2                  | MHz  |
|                                               |                                                              |                                                                 | $C_L = 50 \text{ pF}$ , $V_{DD} = 1.8 \text{ V to } 2.7 \text{ V}$ | -   | 1                  |      |
|                                               | $t_{f(\text{IO})\text{out}}$<br>$t_{r(\text{IO})\text{out}}$ | Output rise and fall time                                       | $C_L = 50 \text{ pF}$ , $V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$ | -   | 125                | ns   |
|                                               |                                                              |                                                                 | $C_L = 50 \text{ pF}$ , $V_{DD} = 1.8 \text{ V to } 2.7 \text{ V}$ | -   | 250                |      |
| 10                                            | $F_{\max(\text{IO})\text{out}}$                              | Maximum frequency <sup>(3)</sup>                                | $C_L = 50 \text{ pF}$ , $V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$ | -   | 10                 | MHz  |
|                                               |                                                              |                                                                 | $C_L = 50 \text{ pF}$ , $V_{DD} = 1.8 \text{ V to } 2.7 \text{ V}$ | -   | 2                  |      |
|                                               | $t_{f(\text{IO})\text{out}}$<br>$t_{r(\text{IO})\text{out}}$ | Output rise and fall time                                       | $C_L = 50 \text{ pF}$ , $V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$ | -   | 25                 | ns   |
|                                               |                                                              |                                                                 | $C_L = 50 \text{ pF}$ , $V_{DD} = 1.8 \text{ V to } 2.7 \text{ V}$ | -   | 125                |      |
| 11                                            | $F_{\max(\text{IO})\text{out}}$                              | Maximum frequency <sup>(3)</sup>                                | $C_L = 50 \text{ pF}$ , $V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$ | -   | 50                 | MHz  |
|                                               |                                                              |                                                                 | $C_L = 50 \text{ pF}$ , $V_{DD} = 1.8 \text{ V to } 2.7 \text{ V}$ | -   | 8                  |      |
|                                               | $t_{f(\text{IO})\text{out}}$<br>$t_{r(\text{IO})\text{out}}$ | Output rise and fall time                                       | $C_L = 30 \text{ pF}$ , $V_{DD} = 2.7 \text{ V to } 3.6 \text{ V}$ | -   | 5                  | ns   |
|                                               |                                                              |                                                                 | $C_L = 50 \text{ pF}$ , $V_{DD} = 1.8 \text{ V to } 2.7 \text{ V}$ | -   | 30                 |      |
| -                                             | $t_{\text{EXTI}pw}$                                          | Pulse width of external signals detected by the EXTI controller | -                                                                  | 8   | -                  | ns   |

1. The I/O speed is configured using the OSPEEDRx[1:0] bits. Refer to the RM0038 reference manual for a description of GPIO Port configuration register.
2. Guaranteed by design.
3. The maximum frequency is defined in [Figure 15](#).

Figure 15. I/O AC characteristics definition



### 6.3.14 NRST pin characteristics

The NRST pin input driver uses CMOS technology. It is connected to a permanent pull-up resistor, RPU (see [Table 46](#)).

Unless otherwise specified, the parameters given in [Table 46](#) are derived from tests performed under ambient temperature and  $V_{DD}$  supply voltage conditions summarized in [Table 14](#).

Table 46. NRST pin characteristics

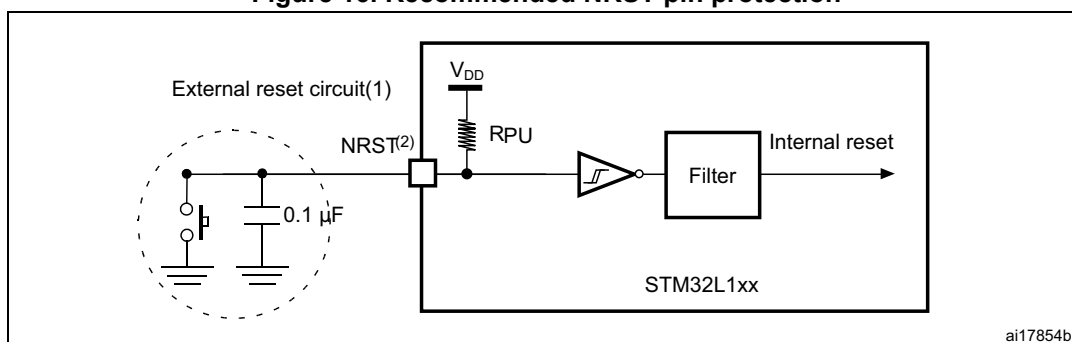
| Symbol                | Parameter                                       | Conditions                                                            | Min                | Typ                | Max          | Unit |
|-----------------------|-------------------------------------------------|-----------------------------------------------------------------------|--------------------|--------------------|--------------|------|
| $V_{IL(NRST)}^{(1)}$  | NRST input low level voltage                    | -                                                                     | -                  | -                  | $0.3 V_{DD}$ | V    |
| $V_{IH(NRST)}^{(1)}$  | NRST input high level voltage                   | -                                                                     | $0.39 V_{DD}+0.59$ | -                  |              |      |
| $V_{OL(NRST)}^{(1)}$  | NRST output low level voltage                   | $I_{OL} = 2 \text{ mA}$<br>$2.7 \text{ V} < V_{DD} < 3.6 \text{ V}$   | -                  | -                  | 0.4          |      |
|                       |                                                 | $I_{OL} = 1.5 \text{ mA}$<br>$1.8 \text{ V} < V_{DD} < 2.7 \text{ V}$ | -                  | -                  |              |      |
| $V_{hys(NRST)}^{(1)}$ | NRST Schmitt trigger voltage hysteresis         | -                                                                     | -                  | $10\%V_{DD}^{(2)}$ |              | mV   |
| $R_{PU}$              | Weak pull-up equivalent resistor <sup>(3)</sup> | $V_{IN} = V_{SS}$                                                     | 25                 | 45                 | 65           | kΩ   |
| $V_{F(NRST)}^{(1)}$   | NRST input filtered pulse                       | -                                                                     | -                  | -                  | 50           | ns   |
| $V_{NF(NRST)}^{(1)}$  | NRST input not filtered pulse                   | -                                                                     | 350                | -                  | -            | ns   |

1. Guaranteed by design.

2. 200 mV minimum value.

3. The pull-up is designed with a true resistance in series with a switchable PMOS. This PMOS contribution to the series resistance is around 10%.

Figure 16. Recommended NRST pin protection



1. The reset network protects the device against parasitic resets. 0.1 uF capacitor must be placed as close as possible to the chip.
2. The user must ensure that the level on the NRST pin can go below the  $V_{IL(NRST)}$  max level specified in [Table 46](#). Otherwise the reset will not be taken into account by the device.

### 6.3.15 TIM timer characteristics

The parameters given in [Table 47](#) are guaranteed by design.

Refer to [Section 6.3.13: I/O port characteristics](#) for details on the input/output alternate function characteristics (output compare, input capture, external clock, PWM output).

Table 47. TIMx<sup>(1)</sup> characteristics

| Symbol           | Parameter                                                                                | Conditions                     | Min    | Max                  | Unit          |
|------------------|------------------------------------------------------------------------------------------|--------------------------------|--------|----------------------|---------------|
| $t_{res(TIM)}$   | Timer resolution time                                                                    | -                              | 1      | -                    | $t_{TIMxCLK}$ |
|                  |                                                                                          | $f_{TIMxCLK} = 32 \text{ MHz}$ | 31.25  | -                    | ns            |
| $f_{EXT}$        | Timer external clock frequency on CH1 to CH4                                             | -                              | 0      | $f_{TIMxCLK}/2$      | MHz           |
|                  |                                                                                          | $f_{TIMxCLK} = 32 \text{ MHz}$ | 0      | 16                   | MHz           |
| $Res_{TIM}$      | Timer resolution                                                                         | -                              | -      | 16                   | bit           |
| $t_{COUNTER}$    | 16-bit counter clock period when internal clock is selected (timer's prescaler disabled) | -                              | 1      | 65536                | $t_{TIMxCLK}$ |
|                  |                                                                                          | $f_{TIMxCLK} = 32 \text{ MHz}$ | 0.0312 | 2048                 | µs            |
| $t_{MAX\_COUNT}$ | Maximum possible count                                                                   | -                              | -      | $65536 \times 65536$ | $t_{TIMxCLK}$ |
|                  |                                                                                          | $f_{TIMxCLK} = 32 \text{ MHz}$ | -      | 134.2                | s             |

1. TIMx is used as a general term to refer to the TIM2, TIM3 and TIM4 timers.

## 6.3.16 Communication interfaces

### I<sup>2</sup>C interface characteristics

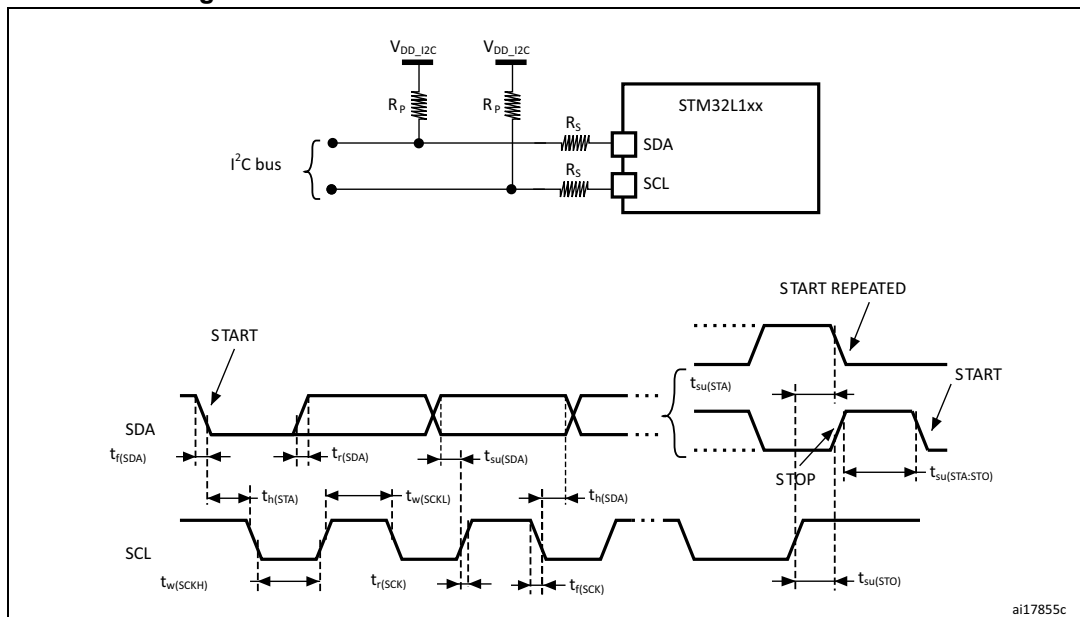
The STM32L100x6/8/B-A product line I<sup>2</sup>C interface meets the requirements of the standard I<sup>2</sup>C communication protocol with the following restrictions: SDA and SCL are not “true” open-drain I/O pins. When configured as open-drain, the PMOS connected between the I/O pin and V<sub>DD</sub> is disabled, but is still present.

The I<sup>2</sup>C characteristics are described in [Table 48](#). Refer also to [Section 6.3.12: I/O current injection characteristics](#) for more details on the input/output alternate function characteristics (SDA and SCL).

**Table 48. I<sup>2</sup>C characteristics**

| Symbol                                       | Parameter                                                      | Standard mode I <sup>2</sup> C <sup>(1)(2)</sup> |                     | Fast mode I <sup>2</sup> C <sup>(1)(2)</sup> |                    | Unit |
|----------------------------------------------|----------------------------------------------------------------|--------------------------------------------------|---------------------|----------------------------------------------|--------------------|------|
|                                              |                                                                | Min                                              | Max                 | Min                                          | Max                |      |
| t <sub>w</sub> (SCLL)                        | SCL clock low time                                             | 4.7                                              | -                   | 1.3                                          | -                  | μs   |
| t <sub>w</sub> (SCLH)                        | SCL clock high time                                            | 4.0                                              | -                   | 0.6                                          | -                  |      |
| t <sub>su</sub> (SDA)                        | SDA setup time                                                 | 250                                              | -                   | 100                                          | -                  | ns   |
| t <sub>h</sub> (SDA)                         | SDA data hold time                                             | -                                                | 3450 <sup>(3)</sup> | -                                            | 900 <sup>(3)</sup> |      |
| t <sub>r</sub> (SDA)<br>t <sub>r</sub> (SCL) | SDA and SCL rise time                                          | -                                                | 1000                | -                                            | 300                |      |
| t <sub>f</sub> (SDA)<br>t <sub>f</sub> (SCL) | SDA and SCL fall time                                          | -                                                | 300                 | -                                            | 300                |      |
| t <sub>h</sub> (STA)                         | Start condition hold time                                      | 4.0                                              | -                   | 0.6                                          | -                  | μs   |
| t <sub>su</sub> (STA)                        | Repeated Start condition setup time                            | 4.7                                              | -                   | 0.6                                          | -                  |      |
| t <sub>su</sub> (STO)                        | Stop condition setup time                                      | 4.0                                              | -                   | 0.6                                          | -                  | μs   |
| t <sub>w</sub> (STO:STA)                     | Stop to Start condition time (bus free)                        | 4.7                                              | -                   | 1.3                                          | -                  | μs   |
| C <sub>b</sub>                               | Capacitive load for each bus line                              | -                                                | 400                 | -                                            | 400                | pF   |
| t <sub>SP</sub>                              | Pulse width of spikes that are suppressed by the analog filter | 0                                                | 50 <sup>(4)</sup>   | 0                                            | 50 <sup>(4)</sup>  | ns   |

1. Guaranteed by design.
2. f<sub>PCLK1</sub> must be at least 2 MHz to achieve standard mode I<sup>2</sup>C frequencies. It must be at least 4 MHz to achieve fast mode I<sup>2</sup>C frequencies. It must be a multiple of 10 MHz to reach the 400 kHz maximum I<sup>2</sup>C fast mode clock.
3. The maximum Data hold time has only to be met if the interface does not stretch the low period of SCL signal.
4. The minimum width of the spikes filtered by the analog filter is above t<sub>SP(max)</sub>.

Figure 17. I<sup>2</sup>C bus AC waveforms and measurement circuit

1.  $R_S$  = series protection resistors
2.  $R_P$  = pull-up resistors
3.  $V_{DD\_I2C}$  = I<sup>2</sup>C bus supply
4. Measurement points are done at CMOS levels:  $0.3V_{DD}$  and  $0.7V_{DD}$ .

Table 49. SCL frequency ( $f_{PCLK1} = 32$  MHz,  $V_{DD} = V_{DD\_I2C} = 3.3$  V)<sup>(1)(2)</sup>

| $f_{SCL}$ (kHz) | I <sup>2</sup> C_CCR value |
|-----------------|----------------------------|
|                 | $R_P = 4.7$ k $\Omega$     |
| 400             | 0x801B                     |
| 300             | 0x8024                     |
| 200             | 0x8035                     |
| 100             | 0x00A0                     |
| 50              | 0x0140                     |
| 20              | 0x0320                     |

1.  $R_P$  = External pull-up resistance,  $f_{SCL}$  = I<sup>2</sup>C speed.
2. For speeds around 200 kHz, the tolerance on the achieved speed is of  $\pm 5\%$ . For other speed ranges, the tolerance on the achieved speed is  $\pm 2\%$ . These variations depend on the accuracy of the external components used to design the application.

### SPI characteristics

Unless otherwise specified, the parameters given in the following table are derived from tests performed under ambient temperature,  $f_{PCLKx}$  frequency and  $V_{DD}$  supply voltage conditions summarized in [Table 14](#).

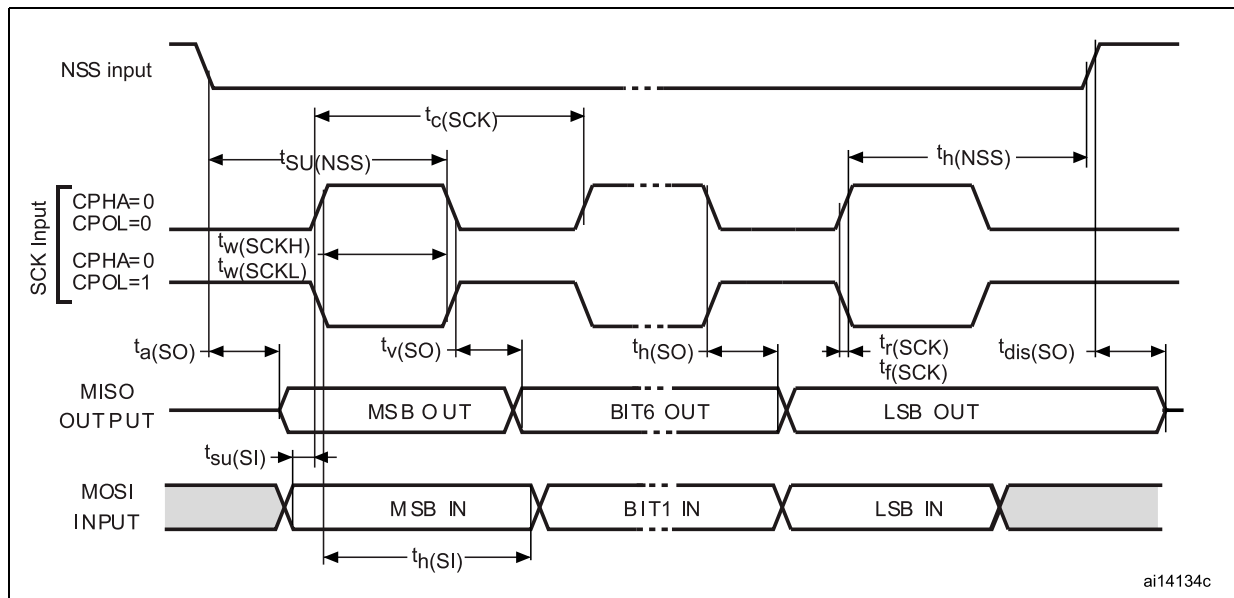
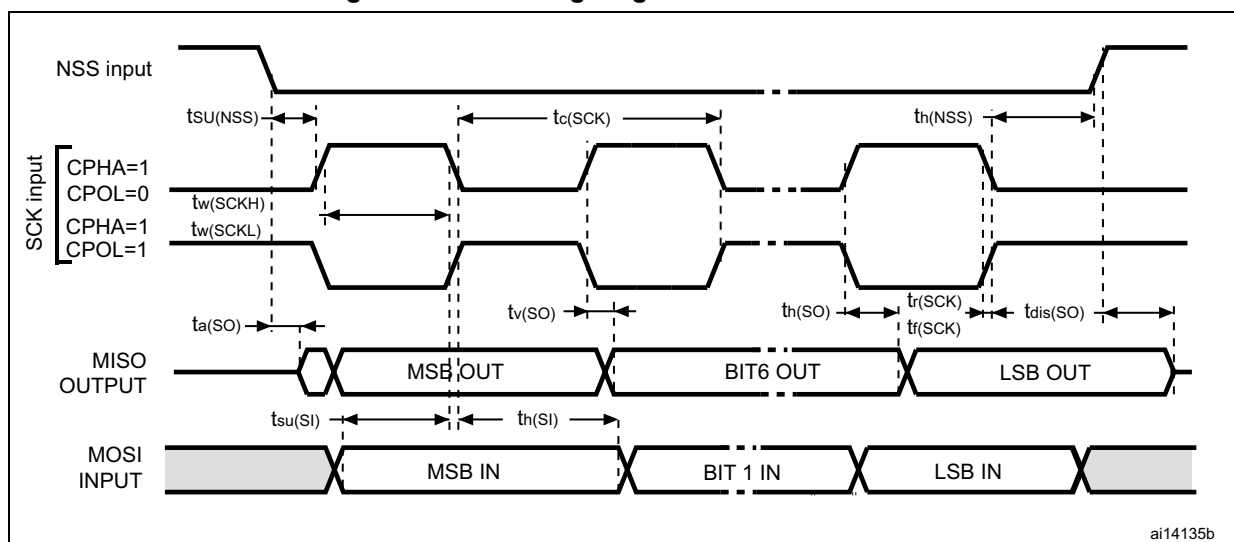
Refer to [Section 6.3.12: I/O current injection characteristics](#) for more details on the input/output alternate function characteristics (NSS, SCK, MOSI, MISO).

**Table 50. SPI characteristics<sup>(1)</sup>**

| Symbol                                     | Parameter                        | Conditions                 | Min           | Max <sup>(2)</sup> | Unit |
|--------------------------------------------|----------------------------------|----------------------------|---------------|--------------------|------|
| $f_{SCK}$<br>1/ $t_{c(SCK)}$               | SPI clock frequency              | Master mode                | -             | 16                 | MHz  |
|                                            |                                  | Slave mode                 | -             | 16                 |      |
|                                            |                                  | Slave transmitter          | -             | 12 <sup>(3)</sup>  |      |
| $t_{r(SCK)}^{(2)}$<br>$t_{f(SCK)}^{(2)}$   | SPI clock rise and fall time     | Capacitive load: C = 30 pF | -             | 6                  | ns   |
| DuCy(SCK)                                  | SPI slave input clock duty cycle | Slave mode                 | 30            | 70                 | %    |
| $t_{su(NSS)}$                              | NSS setup time                   | Slave mode                 | $4t_{HCLK}$   | -                  | ns   |
| $t_h(NSS)$                                 | NSS hold time                    | Slave mode                 | $2t_{HCLK}$   | -                  |      |
| $t_{w(SCKH)}^{(2)}$<br>$t_{w(SCKL)}^{(2)}$ | SCK high and low time            | Master mode                | $t_{SCK}/2-5$ | $t_{SCK}/2+3$      |      |
| $t_{su(MI)}^{(2)}$                         | Data input setup time            | Master mode                | 5             | -                  |      |
| $t_{su(SI)}^{(2)}$                         |                                  | Slave mode                 | 6             | -                  |      |
| $t_{h(MI)}^{(2)}$                          | Data input hold time             | Master mode                | 5             | -                  |      |
| $t_{h(SI)}^{(2)}$                          |                                  | Slave mode                 | 5             | -                  |      |
| $t_{a(SO)}^{(4)}$                          | Data output access time          | Slave mode                 | 0             | $3t_{HCLK}$        |      |
| $t_{v(SO)}^{(2)}$                          | Data output valid time           | Slave mode                 | -             | 33                 |      |
| $t_{v(MO)}^{(2)}$                          | Data output valid time           | Master mode                | -             | 6.5                |      |
| $t_{h(SO)}^{(2)}$                          | Data output hold time            | Slave mode                 | 17            | -                  |      |
| $t_{h(MO)}^{(2)}$                          |                                  | Master mode                | 0.5           | -                  |      |

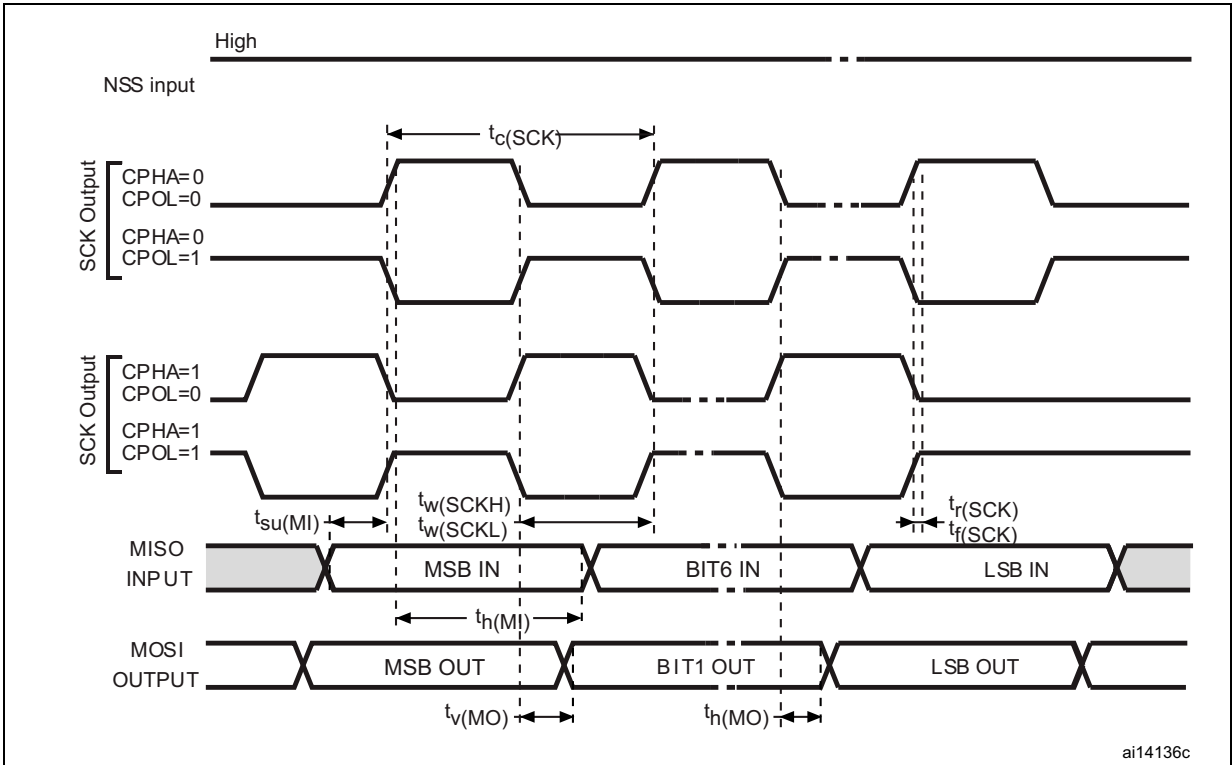
1. The characteristics above are given for voltage Range 1.
2. Guaranteed by characterization results.
3. The maximum SPI clock frequency in slave transmitter mode is given for an SPI slave input clock duty cycle (DuCy(SCK)) ranging between 40 to 60%.
4. Min time is for the minimum time to drive the output and max time is for the maximum time to validate the data.

Figure 18. SPI timing diagram - slave mode and CPHA = 0

Figure 19. SPI timing diagram - slave mode and CPHA = 1<sup>(1)</sup>

1. Measurement points are done at CMOS levels:  $0.3V_{DD}$  and  $0.7V_{DD}$ .

Figure 20. SPI timing diagram - master mode<sup>(1)</sup>



1. Measurement points are done at CMOS levels:  $0.3V_{DD}$  and  $0.7V_{DD}$ .

### USB characteristics

The USB interface is USB-IF certified (full speed).

Table 51. USB startup time

| Symbol              | Parameter                    | Max | Unit    |
|---------------------|------------------------------|-----|---------|
| $t_{STARTUP}^{(1)}$ | USB transceiver startup time | 1   | $\mu s$ |

1. Guaranteed by design.

Table 52. USB DC electrical characteristics

| Symbol                         | Parameter                            | Conditions                                                | Min. <sup>(1)</sup> | Max. <sup>(1)</sup> | Unit |
|--------------------------------|--------------------------------------|-----------------------------------------------------------|---------------------|---------------------|------|
| Input levels                   |                                      |                                                           |                     |                     |      |
| V <sub>DD</sub>                | USB operating voltage <sup>(2)</sup> | -                                                         | 3.0                 | 3.6                 | V    |
| V <sub>DI</sub> <sup>(3)</sup> | Differential input sensitivity       | I(USB_DP, USB_DM)                                         | 0.2                 | -                   | V    |
| V <sub>CM</sub> <sup>(3)</sup> | Differential common mode range       | Includes V <sub>DI</sub> range                            | 0.8                 | 2.5                 |      |
| V <sub>SE</sub> <sup>(3)</sup> | Single ended receiver threshold      | -                                                         | 1.3                 | 2.0                 |      |
| Output levels                  |                                      |                                                           |                     |                     |      |
| V <sub>OL</sub> <sup>(4)</sup> | Static output level low              | R <sub>L</sub> of 1.5 kΩ to 3.6 V <sup>(5)</sup>          | -                   | 0.3                 | V    |
| V <sub>OH</sub> <sup>(4)</sup> | Static output level high             | R <sub>L</sub> of 15 kΩ to V <sub>SS</sub> <sup>(5)</sup> | 2.8                 | 3.6                 |      |

1. All the voltages are measured from the local ground potential.
2. To be compliant with the USB 2.0 full speed electrical specification, the USB\_DP (D+) pin should be pulled up with a 1.5 k $\Omega$  resistor to a 3.0-to-3.6 V voltage range.
3. Guaranteed by characterization results.
4. Guaranteed by test in production.
5.  $R_L$  is the load connected on the USB drivers.

Figure 21. USB timings: definition of data signal rise and fall time

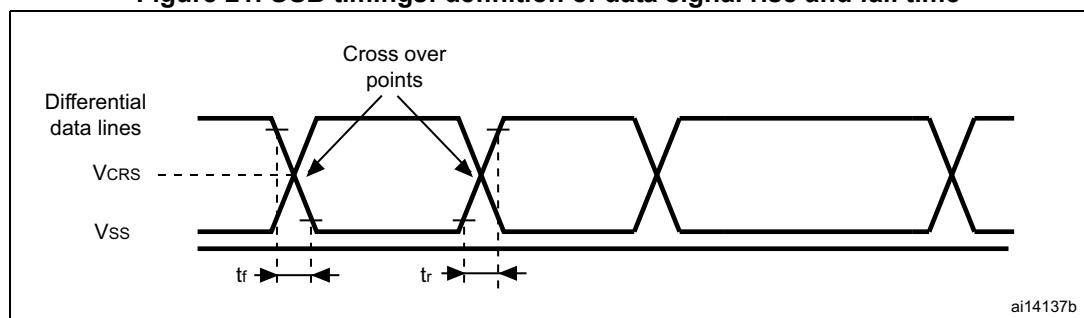


Table 53. USB: full speed electrical characteristics

| Driver characteristics <sup>(1)</sup> |                                 |               |     |     |      |
|---------------------------------------|---------------------------------|---------------|-----|-----|------|
| Symbol                                | Parameter                       | Conditions    | Min | Max | Unit |
| $t_r$                                 | Rise time <sup>(2)</sup>        | $C_L = 50$ pF | 4   | 20  | ns   |
| $t_f$                                 | Fall Time <sup>(2)</sup>        | $C_L = 50$ pF | 4   | 20  | ns   |
| $t_{rfm}$                             | Rise/ fall time matching        | $t_r/t_f$     | 90  | 110 | %    |
| $V_{CRS}$                             | Output signal crossover voltage | -             | 1.3 | 2.0 | V    |

1. Guaranteed by design.
2. Measured from 10% to 90% of the data signal. For more detailed informations, please refer to USB Specification section 7 (version 2.0).

### 6.3.17 12-bit ADC characteristics

Unless otherwise specified, the parameters given in [Table 55](#) are guaranteed by design.

**Table 54. ADC clock frequency**

| Symbol           | Parameter           | Conditions          |                                | Min   | Max | Unit |
|------------------|---------------------|---------------------|--------------------------------|-------|-----|------|
| f <sub>ADC</sub> | ADC clock frequency | Voltage Range 1 & 2 | 2.4 V ≤V <sub>DDA</sub> ≤3.6 V | 0.480 | 16  | MHz  |
|                  |                     |                     | 1.8 V ≤V <sub>DDA</sub> ≤2.4 V |       | 8   |      |
|                  |                     | Voltage Range 3     |                                |       | 4   |      |

**Table 55. ADC characteristics**

| Symbol            | Parameter                                       | Conditions                                                                     | Min                                                       | Typ  | Max              | Unit                |
|-------------------|-------------------------------------------------|--------------------------------------------------------------------------------|-----------------------------------------------------------|------|------------------|---------------------|
| $V_{\text{DDA}}$  | Power supply                                    | -                                                                              | 1.8                                                       | -    | 3.6              | V                   |
| $I_{\text{VDDA}}$ | Current on the $V_{\text{DDA}}$ input pin       | Peak                                                                           | -                                                         | 1400 | 2150             | $\mu\text{A}$       |
|                   |                                                 | Average                                                                        | -                                                         |      | 1900             |                     |
| $V_{\text{AIN}}$  | Conversion voltage range                        | -                                                                              | 0 <sup>(1)</sup>                                          | -    | $V_{\text{DDA}}$ | V                   |
| $f_{\text{S}}$    | 12-bit sampling rate                            | Direct channels                                                                | -                                                         | -    | 1                | MSPS                |
|                   |                                                 | Multiplexed channels                                                           | -                                                         | -    | 0.76             |                     |
|                   | 10-bit sampling rate                            | Direct channels                                                                | -                                                         | -    | 1.07             | MSPS                |
|                   |                                                 | Multiplexed channels                                                           | -                                                         | -    | 0.8              |                     |
|                   | 8-bit sampling rate                             | Direct channels                                                                | -                                                         | -    | 1.23             | MSPS                |
|                   |                                                 | Multiplexed channels                                                           | -                                                         | -    | 0.89             |                     |
|                   | 6-bit sampling rate                             | Direct channels                                                                | -                                                         | -    | 1.45             | MSPS                |
|                   |                                                 | Multiplexed channels                                                           | -                                                         | -    | 1                |                     |
| $t_{\text{S}}$    | Sampling time <sup>(2)</sup>                    | Direct channels<br>$2.4 \text{ V} \leq V_{\text{DDA}} \leq 3.6 \text{ V}$      | 0.25                                                      | -    | -                | $\mu\text{s}$       |
|                   |                                                 | Multiplexed channels<br>$2.4 \text{ V} \leq V_{\text{DDA}} \leq 3.6 \text{ V}$ | 0.56                                                      | -    | -                |                     |
|                   |                                                 | Direct channels<br>$1.8 \text{ V} \leq V_{\text{DDA}} \leq 2.4 \text{ V}$      | 0.56                                                      | -    | -                |                     |
|                   |                                                 | Multiplexed channels<br>$1.8 \text{ V} \leq V_{\text{DDA}} \leq 2.4 \text{ V}$ | 1                                                         | -    | -                |                     |
|                   |                                                 | -                                                                              | 4                                                         | -    | 384              | 1/ $f_{\text{ADC}}$ |
| $t_{\text{CONV}}$ | Total conversion time (including sampling time) | $f_{\text{ADC}} = 16 \text{ MHz}$                                              | 1                                                         | -    | 24.75            | $\mu\text{s}$       |
|                   |                                                 | -                                                                              | 4 to 384 (sampling phase) + 12 (successive approximation) |      |                  | 1/ $f_{\text{ADC}}$ |
| $C_{\text{ADC}}$  | Internal sample and hold capacitor              | Direct channels                                                                | -                                                         | 16   | -                | pF                  |
|                   |                                                 | Multiplexed channels                                                           | -                                                         |      | -                |                     |

Table 55. ADC characteristics (continued)

| Symbol            | Parameter                                        | Conditions                        | Min | Typ | Max                 | Unit               |
|-------------------|--------------------------------------------------|-----------------------------------|-----|-----|---------------------|--------------------|
| $f_{\text{TRIG}}$ | External trigger frequency<br>Regular sequencer  | 12-bit conversions                | -   | -   | $T_{\text{conv}}+1$ | $1/f_{\text{ADC}}$ |
|                   |                                                  | 6/8/10-bit conversions            | -   | -   | $T_{\text{conv}}$   | $1/f_{\text{ADC}}$ |
| $f_{\text{TRIG}}$ | External trigger frequency<br>Injected sequencer | 12-bit conversions                | -   | -   | $T_{\text{conv}}+2$ | $1/f_{\text{ADC}}$ |
|                   |                                                  | 6/8/10-bit conversions            | -   | -   | $T_{\text{conv}}+1$ | $1/f_{\text{ADC}}$ |
| $R_{\text{AIN}}$  | Signal source impedance <sup>(2)</sup>           | -                                 | -   | -   | 50                  | $\kappa\Omega$     |
| $t_{\text{lat}}$  | Injection trigger conversion<br>latency          | $f_{\text{ADC}} = 16 \text{ MHz}$ | 219 | -   | 281                 | ns                 |
|                   |                                                  | -                                 | 3.5 | -   | 4.5                 | $1/f_{\text{ADC}}$ |
| $t_{\text{latr}}$ | Regular trigger conversion<br>latency            | $f_{\text{ADC}} = 16 \text{ MHz}$ | 156 | -   | 219                 | ns                 |
|                   |                                                  | -                                 | 2.5 | -   | 3.5                 | $1/f_{\text{ADC}}$ |
| $t_{\text{STAB}}$ | Power-up time                                    | -                                 | -   | -   | 3.5                 | $\mu\text{s}$      |

1.  $V_{\text{SSA}}$  must be tied to ground.

2. See [Table 57: Maximum source impedance  \$R\_{\text{AIN}}\$  max](#) for  $R_{\text{AIN}}$  limitations

Table 56. ADC accuracy<sup>(1)(2)</sup>

| Symbol | Parameter                               | Test conditions                                                                                                                                                                                                                                        | Min <sup>(3)</sup> | Typ | Max <sup>(3)</sup> | Unit |
|--------|-----------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------|-----|--------------------|------|
| ET     | Total unadjusted error                  | $2.4 \text{ V} \leq V_{\text{DDA}} \leq 3.6 \text{ V}$<br>$f_{\text{ADC}} = 8 \text{ MHz}$ , $R_{\text{AIN}} = 50 \Omega$<br>$T_{\text{A}} = -40 \text{ to } 85 \text{ }^{\circ}\text{C}$                                                              | -                  | 2.5 | 4                  | LSB  |
| EO     | Offset error                            |                                                                                                                                                                                                                                                        | -                  | 1   | 2                  |      |
| EG     | Gain error                              |                                                                                                                                                                                                                                                        | -                  | 1.5 | 3.5                |      |
| ED     | Differential linearity error            |                                                                                                                                                                                                                                                        | -                  | 1   | 2                  |      |
| EL     | Integral linearity error                |                                                                                                                                                                                                                                                        | -                  | 2   | 3                  |      |
| ENOB   | Effective number of bits                | $2.4 \text{ V} \leq V_{\text{DDA}} \leq 3.6 \text{ V}$<br>$f_{\text{ADC}} = 16 \text{ MHz}$ , $R_{\text{AIN}} = 50 \Omega$<br>$T_{\text{A}} = -40 \text{ to } 85 \text{ }^{\circ}\text{C}$<br>$F_{\text{input}} = 10 \text{ kHz}$                      | 9.5                | 10  | -                  | bits |
| SINAD  | Signal-to-noise and<br>distortion ratio |                                                                                                                                                                                                                                                        | 59                 | 62  | -                  | dB   |
| SNR    | Signal-to-noise ratio                   |                                                                                                                                                                                                                                                        | 60                 | 62  | -                  |      |
| THD    | Total harmonic distortion               |                                                                                                                                                                                                                                                        | -                  | -72 | -69                |      |
| ENOB   | Effective number of bits                | $1.8 \text{ V} \leq V_{\text{DDA}} \leq 2.4 \text{ V}$<br>$f_{\text{ADC}} = 8 \text{ MHz}$ or $4 \text{ MHz}$ ,<br>$R_{\text{AIN}} = 50 \Omega$<br>$T_{\text{A}} = -40 \text{ to } 85 \text{ }^{\circ}\text{C}$<br>$F_{\text{input}} = 10 \text{ kHz}$ | 9.5                | 10  | -                  | bits |
| SINAD  | Signal-to-noise and<br>distortion ratio |                                                                                                                                                                                                                                                        | 59                 | 62  | -                  | dB   |
| SNR    | Signal-to-noise ratio                   |                                                                                                                                                                                                                                                        | 60                 | 62  | -                  |      |
| THD    | Total harmonic distortion               |                                                                                                                                                                                                                                                        | -                  | -72 | -69                |      |
| ET     | Total unadjusted error                  | $1.8 \text{ V} \leq V_{\text{DDA}} \leq 2.4 \text{ V}$<br>$f_{\text{ADC}} = 4 \text{ MHz}$ , $R_{\text{AIN}} = 50 \Omega$<br>$T_{\text{A}} = -40 \text{ to } 85 \text{ }^{\circ}\text{C}$                                                              | -                  | 2   | 3                  | LSB  |
| EO     | Offset error                            |                                                                                                                                                                                                                                                        | -                  | 1   | 1.5                |      |
| EG     | Gain error                              |                                                                                                                                                                                                                                                        | -                  | 1.5 | 2.5                |      |
| ED     | Differential linearity error            |                                                                                                                                                                                                                                                        | -                  | 1   | 2                  |      |
| EL     | Integral linearity error                |                                                                                                                                                                                                                                                        | -                  |     | 3                  |      |

1. ADC DC accuracy values are measured after internal calibration.

2. ADC accuracy vs. negative injection current: Injecting a negative current on any analog input pins should be avoided as this significantly reduces the accuracy of the conversion being performed on another analog input. It is recommended to add a Schottky diode (pin to ground) to analog pins which may potentially inject negative currents. Any positive injection current within the limits specified for  $I_{INJ(PIN)}$  and  $\Sigma I_{INJ(PIN)}$  in [Section 6.3.12](#) does not affect the ADC accuracy.
3. Guaranteed by characterization results.

Figure 22. ADC accuracy characteristics

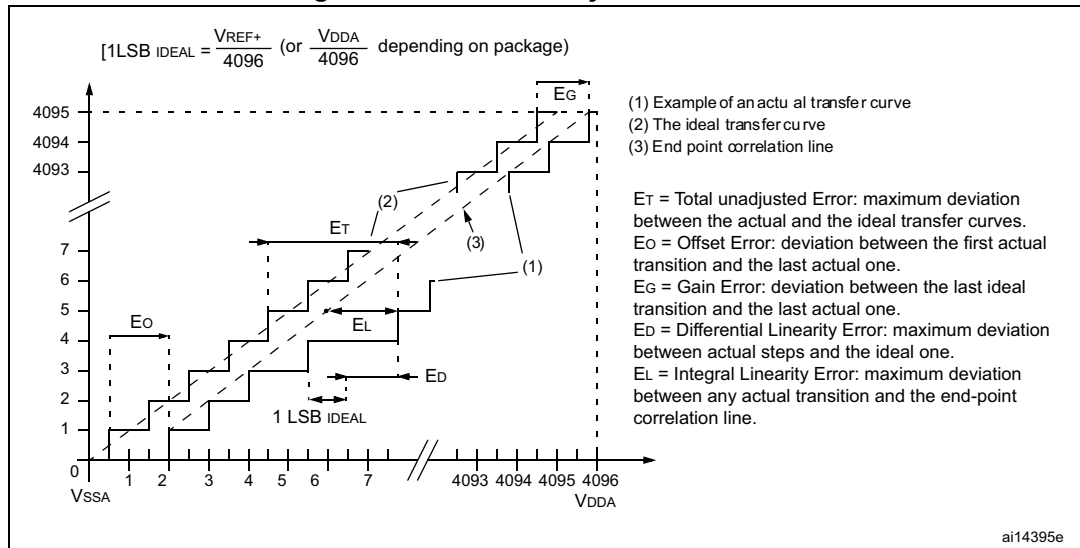
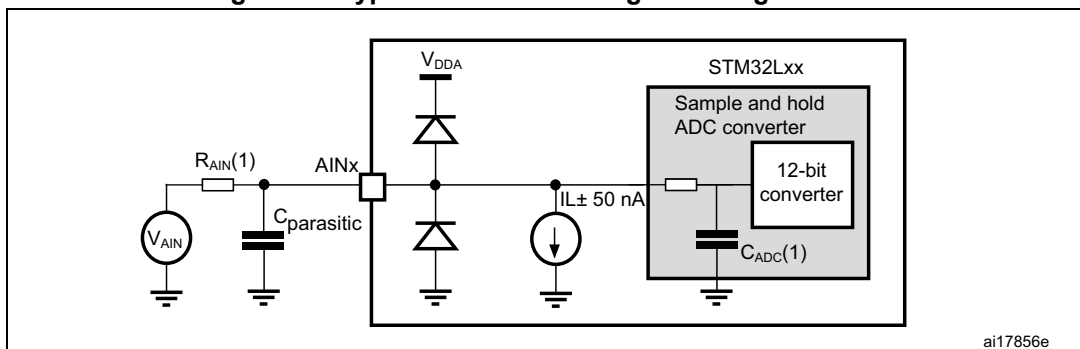
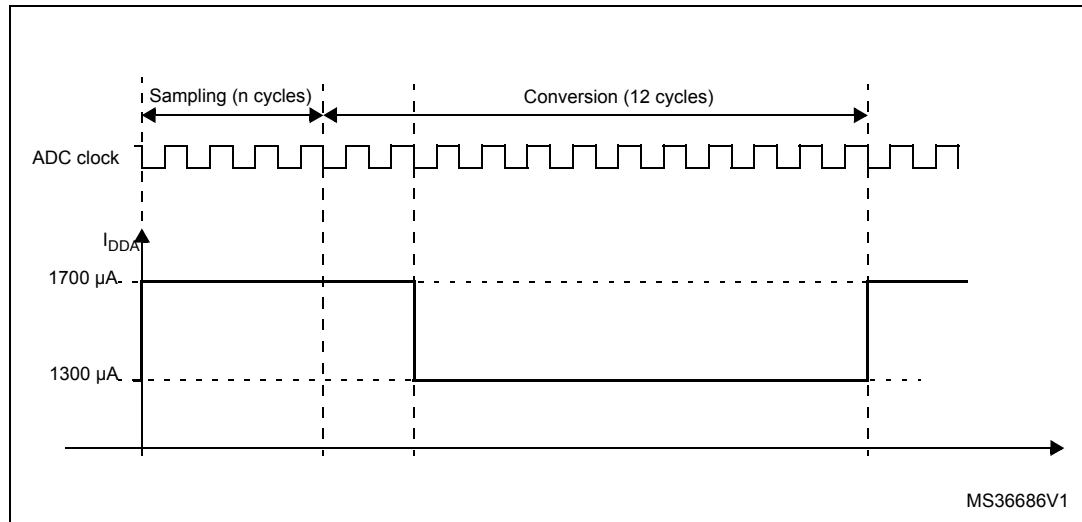


Figure 23. Typical connection diagram using the ADC



1. Refer to [Table 57: Maximum source impedance  \$R\_{AIN\ max}\$](#)  for the value of  $R_{AIN}$  and [Table 55: ADC characteristics](#) for the value of  $C_{ADC}$
2.  $C_{parasitic}$  represents the capacitance of the PCB (dependent on soldering and PCB layout quality) plus the pad capacitance (roughly 7 pF). A high  $C_{parasitic}$  value will downgrade conversion accuracy. To remedy this,  $f_{ADC}$  should be reduced.

**Figure 24. Maximum dynamic current consumption on  $V_{DDA}$  supply pin during ADC conversion****Table 57. Maximum source impedance  $R_{AIN\ max}^{(1)}$** 

| Ts<br>(μs) | R <sub>AIN</sub> max (kOhm)      |                                  |                                  |                                  | Ts (cycles)<br>f <sub>ADC</sub> = 16 MHz <sup>(2)</sup> |
|------------|----------------------------------|----------------------------------|----------------------------------|----------------------------------|---------------------------------------------------------|
|            | Multiplexed channels             |                                  | Direct channels                  |                                  |                                                         |
|            | 2.4 V < V <sub>DDA</sub> < 3.6 V | 1.8 V < V <sub>DDA</sub> < 2.4 V | 2.4 V < V <sub>DDA</sub> < 3.3 V | 1.8 V < V <sub>DDA</sub> < 2.4 V |                                                         |
| 0.25       | Not allowed                      | Not allowed                      | 0.7                              | Not allowed                      | 4                                                       |
| 0.5625     | 0.8                              | Not allowed                      | 2.0                              | 1.0                              | 9                                                       |
| 1          | 2.0                              | 0.8                              | 4.0                              | 3.0                              | 16                                                      |
| 1.5        | 3.0                              | 1.8                              | 6.0                              | 4.5                              | 24                                                      |
| 3          | 6.8                              | 4.0                              | 15.0                             | 10.0                             | 48                                                      |
| 6          | 15.0                             | 10.0                             | 30.0                             | 20.0                             | 96                                                      |
| 12         | 32.0                             | 25.0                             | 50.0                             | 40.0                             | 192                                                     |
| 24         | 50.0                             | 50.0                             | 50.0                             | 50.0                             | 384                                                     |

1. Guaranteed by design.

2. Number of samples calculated for  $f_{ADC} = 16\ MHz$ . For  $f_{ADC} = 8$  and  $4\ MHz$  the number of sampling cycles can be reduced with respect to the minimum sampling time  $T_s$  ( $\mu s$ ).

### General PCB design guidelines

Power supply decoupling should be performed as shown in [Figure 8](#). The 100 nF capacitors should be ceramic (good quality). They should be placed as close as possible to the chip.

### 6.3.18 DAC electrical specifications

Data guaranteed by design, unless otherwise specified.

**Table 58. DAC characteristics**

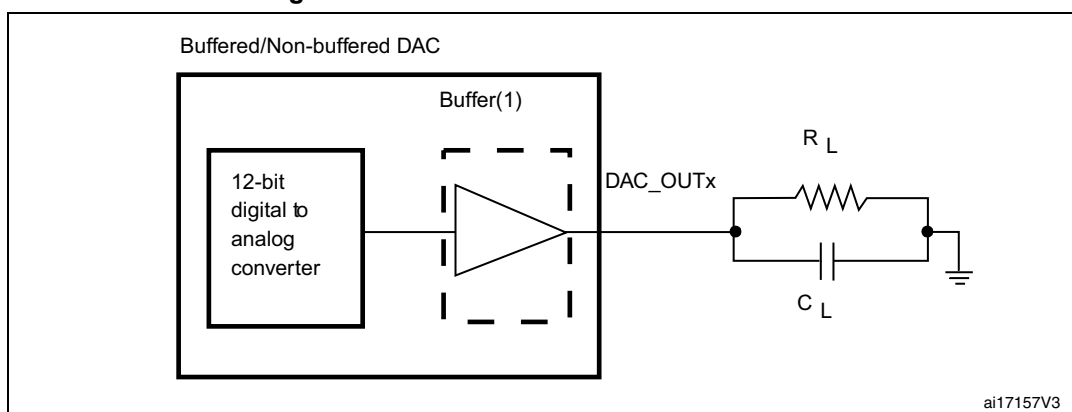
| Symbol                    | Parameter                                                    | Conditions                                                              | Min | Typ          | Max                     | Unit                         |
|---------------------------|--------------------------------------------------------------|-------------------------------------------------------------------------|-----|--------------|-------------------------|------------------------------|
| $V_{DDA}$                 | Analog supply voltage                                        | -                                                                       | 1.8 | -            | 3.6                     | V                            |
| $I_{DDA}^{(1)}$           | Current consumption on $V_{DDA}$ supply<br>$V_{DDA} = 3.3$ V | No load, middle code (0x800)                                            | -   | 330          | 540                     | $\mu$ A                      |
|                           |                                                              | No load, worst code (0xF1C)                                             | -   | 540          | 870                     | $\mu$ A                      |
| $R_L$                     | Resistive load                                               | DAC output buffer ON<br>Connected to $V_{SSA}$                          | 5   | -            | -                       | k $\Omega$                   |
|                           |                                                              | Connected to $V_{DDA}$                                                  | 25  | -            | -                       |                              |
| $C_L$                     | Capacitive load                                              | DAC output buffer ON                                                    | -   | -            | 50                      | pF                           |
| $R_O$                     | Output impedance                                             | DAC output buffer OFF                                                   | 12  | 16           | 20                      | k $\Omega$                   |
| $V_{DAC\_OUT}$            | Voltage on DAC_OUT output                                    | DAC output buffer ON                                                    | 0.2 | -            | $V_{DDA} - 0.2$         | V                            |
|                           |                                                              | DAC output buffer OFF                                                   | 0.5 | -            | $V_{DDA} - 1\text{LSB}$ | mV                           |
| $DNL^{(1)}$               | Differential non linearity <sup>(2)</sup>                    | $C_L \leq 50$ pF, $R_L \geq 5$ k $\Omega$<br>DAC output buffer ON       | -   | 1.5          | 3                       | LSB                          |
|                           |                                                              | No $R_L$ , $C_L \leq 50$ pF<br>DAC output buffer OFF                    | -   | 1.5          | 3                       |                              |
| $INL^{(1)}$               | Integral non linearity <sup>(3)</sup>                        | $C_L \leq 50$ pF, $R_L \geq 5$ k $\Omega$<br>DAC output buffer ON       | -   | 2            | 4                       |                              |
|                           |                                                              | No $R_L$ , $C_L \leq 50$ pF<br>DAC output buffer OFF                    | -   | 2            | 4                       |                              |
| Offset <sup>(1)</sup>     | Offset error at code 0x800 <sup>(4)</sup>                    | $C_L \leq 50$ pF, $R_L \geq 5$ k $\Omega$<br>DAC output buffer ON       | -   | $\pm 10$     | $\pm 25$                |                              |
|                           |                                                              | No $R_L$ , $C_L \leq 50$ pF<br>DAC output buffer OFF                    | -   | $\pm 5$      | $\pm 8$                 |                              |
| Offset1 <sup>(1)</sup>    | Offset error at code 0x001 <sup>(5)</sup>                    | No $R_L$ , $C_L \leq 50$ pF<br>DAC output buffer OFF                    | -   | $\pm 1.5$    | $\pm 5$                 |                              |
| $d\text{Offset}/dT^{(1)}$ | Offset error temperature coefficient (code 0x800)            | $V_{DDA} = 3.3\text{V}$ , $T_A = 0$ to $50$ °C<br>DAC output buffer OFF | -20 | -10          | 0                       | $\mu\text{V}/^\circ\text{C}$ |
|                           |                                                              | $V_{DDA} = 3.3\text{V}$ , $T_A = 0$ to $50$ °C<br>DAC output buffer ON  | 0   | 20           | 50                      |                              |
| Gain <sup>(1)</sup>       | Gain error <sup>(6)</sup>                                    | $C_L \leq 50$ pF, $R_L \geq 5$ k $\Omega$<br>DAC output buffer ON       | -   | +0.1 / -0.2% | +0.2 / -0.5%            | %                            |
|                           |                                                              | No $R_L$ , $C_L \leq 50$ pF<br>DAC output buffer OFF                    | -   | +0 / -0.2%   | +0 / -0.4%              |                              |

Table 58. DAC characteristics (continued)

| Symbol                  | Parameter                                                                                                                                      | Conditions                                                                    | Min | Typ | Max | Unit  |
|-------------------------|------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------|-----|-----|-----|-------|
| dGain/dT <sup>(1)</sup> | Gain error temperature coefficient                                                                                                             | V <sub>DDA</sub> = 3.3V, T <sub>A</sub> = 0 to 50 °C<br>DAC output buffer OFF | -10 | -2  | 0   | μV/°C |
|                         |                                                                                                                                                | V <sub>DDA</sub> = 3.3V, T <sub>A</sub> = 0 to 50 °C<br>DAC output buffer ON  | -40 | -8  | 0   |       |
| TUE <sup>(1)</sup>      | Total unadjusted error                                                                                                                         | C <sub>L</sub> ≤ 50 pF, R <sub>L</sub> ≥ 5 kΩ<br>DAC output buffer ON         | -   | 12  | 30  | LSB   |
|                         |                                                                                                                                                | No R <sub>L</sub> , C <sub>L</sub> ≤ 50 pF<br>DAC output buffer OFF           | -   | 8   | 12  |       |
| t <sub>SETTLING</sub>   | Settling time (full scale: for a 12-bit code transition between the lowest and the highest input codes till DAC_OUT reaches final value ±1LSB) | C <sub>L</sub> ≤ 50 pF, R <sub>L</sub> ≥ 5 kΩ                                 | -   | 7   | 12  | μs    |
| Update rate             | Max frequency for a correct DAC_OUT change (95% of final value) with 1 LSB variation in the input code                                         | C <sub>L</sub> ≤ 50 pF, R <sub>L</sub> ≥ 5 kΩ                                 | -   | -   | 1   | Msp/s |
| t <sub>WAKEUP</sub>     | Wakeup time from off state (setting the ENx bit in the DAC Control register) <sup>(7)</sup>                                                    | C <sub>L</sub> ≤ 50 pF, R <sub>L</sub> ≥ 5 kΩ                                 | -   | 9   | 15  | μs    |
| PSRR+                   | V <sub>DDA</sub> supply rejection ratio (static DC measurement)                                                                                | C <sub>L</sub> ≤ 50 pF, R <sub>L</sub> ≥ 5 kΩ                                 | -   | -60 | -35 | dB    |

1. Guaranteed by characterization results.
2. Difference between two consecutive codes - 1 LSB.
3. Difference between measured value at Code i and the value at Code i on a line drawn between Code 0 and last Code 4095.
4. Difference between the value measured at Code (0x800) and the ideal value = V<sub>DDA</sub>/2.
5. Difference between the value measured at Code (0x001) and the ideal value.
6. Difference between ideal slope of the transfer function and measured slope computed from code 0x000 and 0xFFFF when buffer is OFF, and from code giving 0.2 V and (V<sub>DDA</sub> - 0.2) V when buffer is ON.
7. In buffered mode, the output can overshoot above the final value for low input code (starting from min value).

Figure 25. 12-bit buffered /non-buffered DAC



1. The DAC integrates an output buffer that can be used to reduce the output impedance and to drive external loads directly without the use of an external operational amplifier. The buffer can be bypassed by configuring the BOFFx bit in the DAC\_CR register.

### 6.3.19 Comparator

Table 59. Comparator 1 characteristics

| Symbol              | Parameter                                                      | Conditions                                                                      | Min <sup>(1)</sup> | Typ     | Max <sup>(1)</sup> | Unit       |
|---------------------|----------------------------------------------------------------|---------------------------------------------------------------------------------|--------------------|---------|--------------------|------------|
| $V_{DDA}$           | Analog supply voltage                                          | -                                                                               | 1.8                |         | 3.6                | V          |
| $R_{400K}$          | $R_{400K}$ value                                               | -                                                                               | -                  | 400     | -                  | k $\Omega$ |
| $R_{10K}$           | $R_{10K}$ value                                                | -                                                                               | -                  | 10      | -                  |            |
| $V_{IN}$            | Comparator 1 input voltage range                               | -                                                                               | 0.6                | -       | $V_{DDA}$          | V          |
| $t_{START}$         | Comparator startup time                                        | -                                                                               | -                  | 7       | 10                 | $\mu$ s    |
| $t_d$               | Propagation delay <sup>(2)</sup>                               | -                                                                               | -                  | 3       | 10                 |            |
| $V_{offset}$        | Comparator offset                                              | -                                                                               | -                  | $\pm 3$ | $\pm 10$           | mV         |
| $d_{V_{offset}}/dt$ | Comparator offset variation in worst voltage stress conditions | $V_{DDA} = 3.6$ V<br>$V_{IN+} = 0$ V<br>$V_{IN-} = V_{REFINT}$<br>$T_A = 25$ °C | 0                  | 1.5     | 10                 | mV/1000 h  |
| $I_{COMP1}$         | Current consumption <sup>(3)</sup>                             | -                                                                               | -                  | 160     | 260                | nA         |

1. Guaranteed by characterization results.
2. The delay is characterized for 100 mV input step with 10 mV overdrive on the inverting input, the non-inverting input set to the reference.
3. Comparator consumption only. Internal reference voltage not included.

Table 60. Comparator 2 characteristics

| Symbol            | Parameter                                     | Conditions                                                                                                                              | Min | Typ     | Max <sup>(1)</sup> | Unit       |
|-------------------|-----------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------|-----|---------|--------------------|------------|
| $V_{DDA}$         | Analog supply voltage                         | -                                                                                                                                       | 1.8 | -       | 3.6                | V          |
| $V_{IN}$          | Comparator 2 input voltage range              | -                                                                                                                                       | 0   | -       | $V_{DDA}$          | V          |
| $t_{START}$       | Comparator startup time                       | Fast mode                                                                                                                               | -   | 15      | 20                 | $\mu s$    |
|                   |                                               | Slow mode                                                                                                                               | -   | 20      | 25                 |            |
| $t_{d\ slow}$     | Propagation delay <sup>(2)</sup> in slow mode | $1.8\ V \leq V_{DDA} \leq 2.7\ V$                                                                                                       | -   | 1.8     | 3.5                |            |
|                   |                                               | $2.7\ V \leq V_{DDA} \leq 3.6\ V$                                                                                                       | -   | 2.5     | 6                  |            |
| $t_{d\ fast}$     | Propagation delay <sup>(2)</sup> in fast mode | $1.8\ V \leq V_{DDA} \leq 2.7\ V$                                                                                                       | -   | 0.8     | 2                  |            |
|                   |                                               | $2.7\ V \leq V_{DDA} \leq 3.6\ V$                                                                                                       | -   | 1.2     | 4                  |            |
| $V_{offset}$      | Comparator offset error                       | -                                                                                                                                       | -   | $\pm 4$ | $\pm 20$           | mV         |
| dThreshold/<br>dt | Threshold voltage temperature coefficient     | $V_{DDA} = 3.3V$<br>$T_A = 0\ to\ 50\ ^\circ C$<br>$V_- = V_{REFINT},$<br>$3/4\ V_{REFINT},$<br>$1/2\ V_{REFINT},$<br>$1/4\ V_{REFINT}$ | -   | 15      | 100                | ppm/<br>°C |
| $I_{COMP2}$       | Current consumption <sup>(3)</sup>            | Fast mode                                                                                                                               | -   | 3.5     | 5                  | $\mu A$    |
|                   |                                               | Slow mode                                                                                                                               | -   | 0.5     | 2                  |            |

1. Guaranteed by characterization results.
2. The delay is characterized for 100 mV input step with 10 mV overdrive on the inverting input, the non-inverting input set to the reference.
3. Comparator consumption only. Internal reference voltage (necessary for comparator operation) is not included.

### 6.3.20 LCD controller

The STM32L100x6/8/B-A devices embed a built-in step-up converter to provide a constant LCD reference voltage independently from the  $V_{DD}$  voltage. An external capacitor  $C_{ext}$  must be connected to the  $V_{LCD}$  pin to decouple this converter.

**Table 61. LCD controller characteristics**

| Symbol                | Parameter                                                         | Min  | Typ           | Max       | Unit      |
|-----------------------|-------------------------------------------------------------------|------|---------------|-----------|-----------|
| $V_{LCD}$             | LCD external voltage                                              | -    | -             | 3.6       | V         |
| $V_{LCD0}$            | LCD internal reference voltage 0                                  | -    | 2.6           | -         |           |
| $V_{LCD1}$            | LCD internal reference voltage 1                                  | -    | 2.73          | -         |           |
| $V_{LCD2}$            | LCD internal reference voltage 2                                  | -    | 2.86          | -         |           |
| $V_{LCD3}$            | LCD internal reference voltage 3                                  | -    | 2.98          | -         |           |
| $V_{LCD4}$            | LCD internal reference voltage 4                                  | -    | 3.12          | -         |           |
| $V_{LCD5}$            | LCD internal reference voltage 5                                  | -    | 3.26          | -         |           |
| $V_{LCD6}$            | LCD internal reference voltage 6                                  | -    | 3.4           | -         |           |
| $V_{LCD7}$            | LCD internal reference voltage 7                                  | -    | 3.55          | -         |           |
| $C_{ext}$             | $V_{LCD}$ external capacitance                                    | 0.1  | -             | 2         | $\mu F$   |
| $I_{LCD}^{(1)}$       | Supply current at $V_{DD} = 2.2 V$                                | -    | 3.3           | -         | $\mu A$   |
|                       | Supply current at $V_{DD} = 3.0 V$                                | -    | 3.1           | -         |           |
| $R_{Htot}^{(2)}$      | Low drive resistive network overall value                         | 5.28 | 6.6           | 7.92      | $M\Omega$ |
| $R_L^{(2)}$           | High drive resistive network total value                          | 192  | 240           | 288       | $k\Omega$ |
| $V_{44}$              | Segment/Common highest level voltage                              | -    | -             | $V_{LCD}$ | V         |
| $V_{34}$              | Segment/Common 3/4 level voltage                                  | -    | $3/4 V_{LCD}$ | -         | V         |
| $V_{23}$              | Segment/Common 2/3 level voltage                                  | -    | $2/3 V_{LCD}$ | -         |           |
| $V_{12}$              | Segment/Common 1/2 level voltage                                  | -    | $1/2 V_{LCD}$ | -         |           |
| $V_{13}$              | Segment/Common 1/3 level voltage                                  | -    | $1/3 V_{LCD}$ | -         |           |
| $V_{14}$              | Segment/Common 1/4 level voltage                                  | -    | $1/4 V_{LCD}$ | -         |           |
| $V_0$                 | Segment/Common lowest level voltage                               | 0    | -             | -         |           |
| $\Delta V_{xx}^{(2)}$ | Segment/Common level voltage error<br>$T_A = -40$ to $85^\circ C$ | -    | -             | $\pm 50$  | mV        |

1. LCD enabled with 3 V internal step-up active, 1/8 duty, 1/4 bias, division ratio= 64, all pixels active, no LCD connected

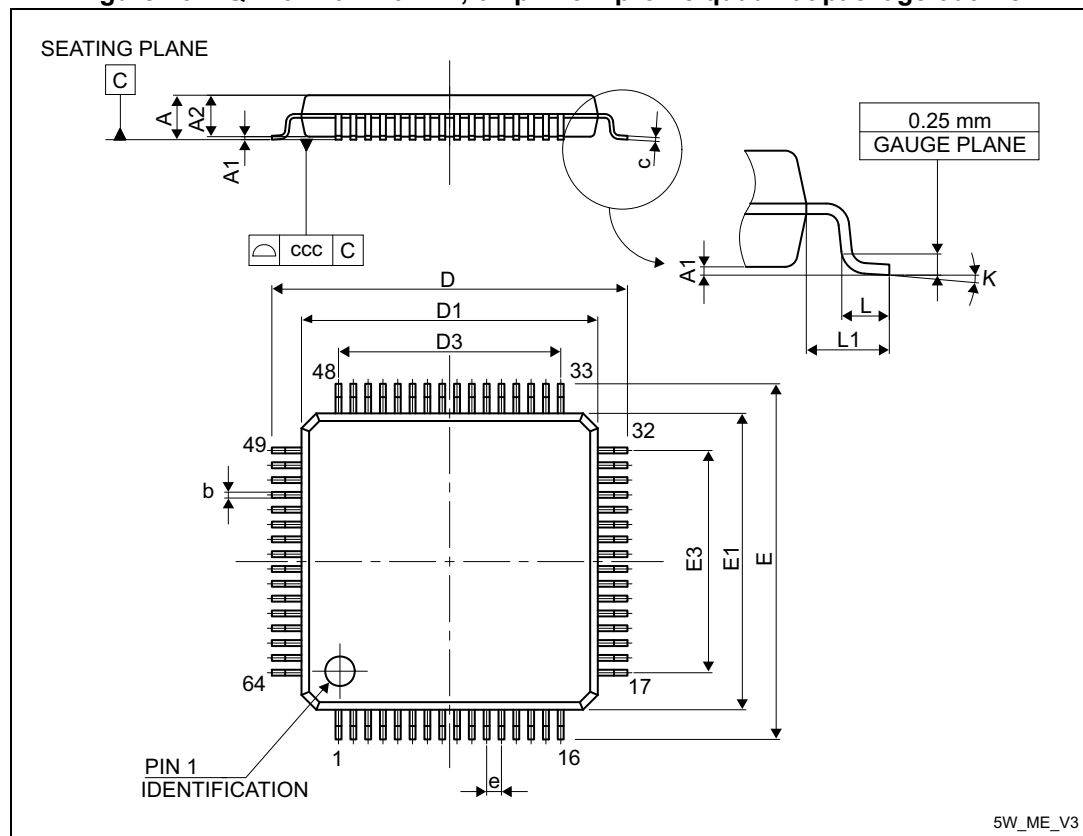
2. Guaranteed by characterization results.

## 7 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 7.1 LQFP64 10 x 10 mm, 64-pin low-profile quad flat package information

Figure 26. LQFP64 10 x 10 mm, 64-pin low-profile quad flat package outline



1. Drawing is not to scale.

Table 62. LQFP64 10 x 10 mm, 64-pin low-profile quad flat package mechanical data

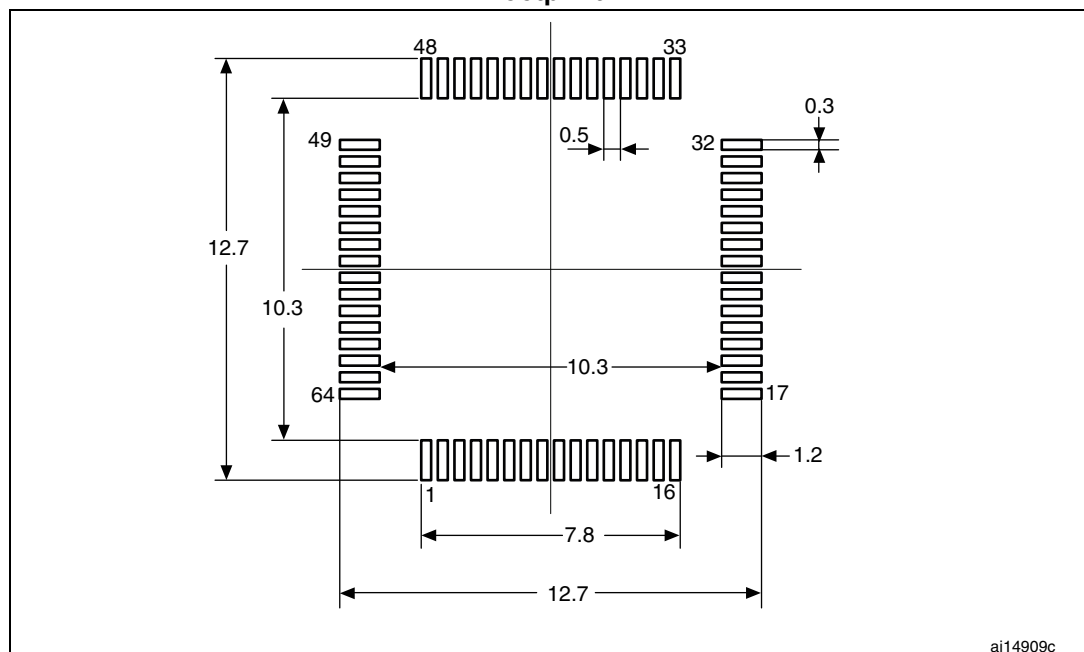
| Symbol | millimeters |       |       | inches <sup>(1)</sup> |        |        |
|--------|-------------|-------|-------|-----------------------|--------|--------|
|        | Min         | Typ   | Max   | Typ                   | Min    | Max    |
| A      | -           | -     | 1.600 | -                     | -      | 0.0630 |
| A1     | 0.050       | -     | 0.150 | 0.0020                | -      | 0.0059 |
| A2     | 1.350       | 1.400 | 1.450 | 0.0531                | 0.0551 | 0.0571 |

**Table 62. LQFP64 10 x 10 mm, 64-pin low-profile quad flat package mechanical data (continued)**

| Symbol | millimeters |        |       | inches <sup>(1)</sup> |        |        |
|--------|-------------|--------|-------|-----------------------|--------|--------|
|        | Min         | Typ    | Max   | Typ                   | Min    | Max    |
| b      | 0.170       | 0.220  | 0.270 | 0.0067                | 0.0087 | 0.0106 |
| c      | 0.090       | -      | 0.200 | 0.0035                | -      | 0.0079 |
| D      | -           | 12.000 | -     | -                     | 0.4724 | -      |
| D1     | -           | 10.000 | -     | -                     | 0.3937 | -      |
| D3     | -           | 7.500  | -     | -                     | 0.2953 | -      |
| E      | -           | 12.000 | -     | -                     | 0.4724 | -      |
| E1     | -           | 10.000 | -     | -                     | 0.3937 | -      |
| E3     | -           | 7.500  | -     | -                     | 0.2953 | -      |
| e      | -           | 0.500  | -     | -                     | 0.0197 | -      |
| K      | 0°          | 3.5°   | 7°    | 0°                    | 3.5°   | 7°     |
| L      | 0.450       | 0.600  | 0.750 | 0.0177                | 0.0236 | 0.0295 |
| L1     | -           | 1.000  | -     | -                     | 0.0394 | -      |
| ccc    | -           | -      | 0.080 | -                     | -      | 0.0031 |

1. Values in inches are converted from mm and rounded to 4 decimal digits.

**Figure 27. LQFP64 10 x 10 mm, 64-pin low-profile quad flat package recommended footprint**



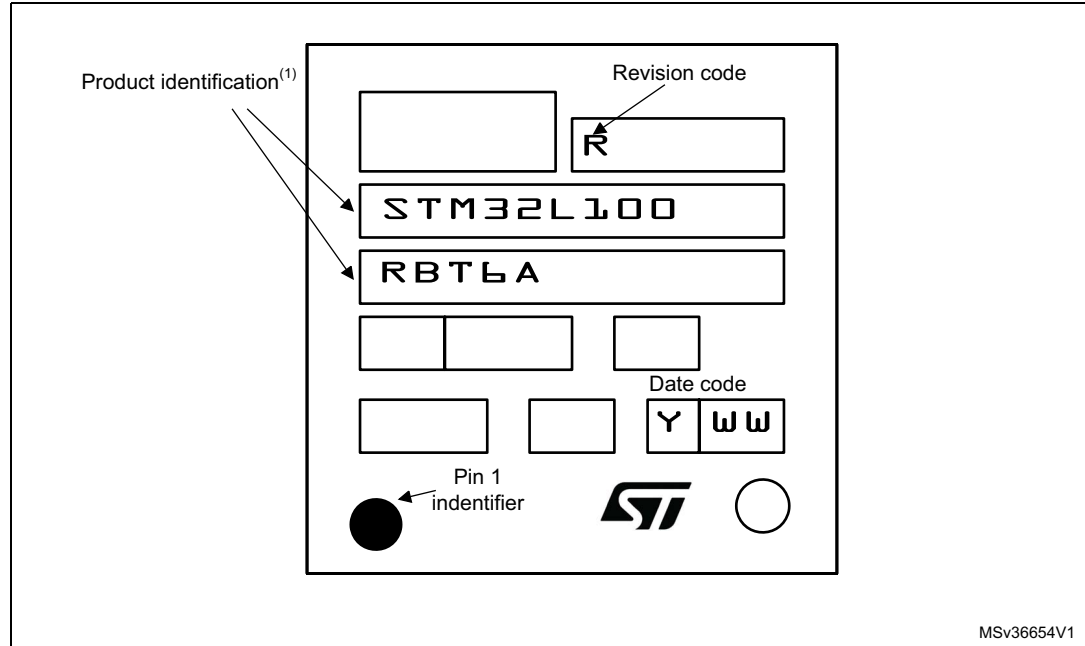
1. Dimensions are in millimeters.

### LQFP64 device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

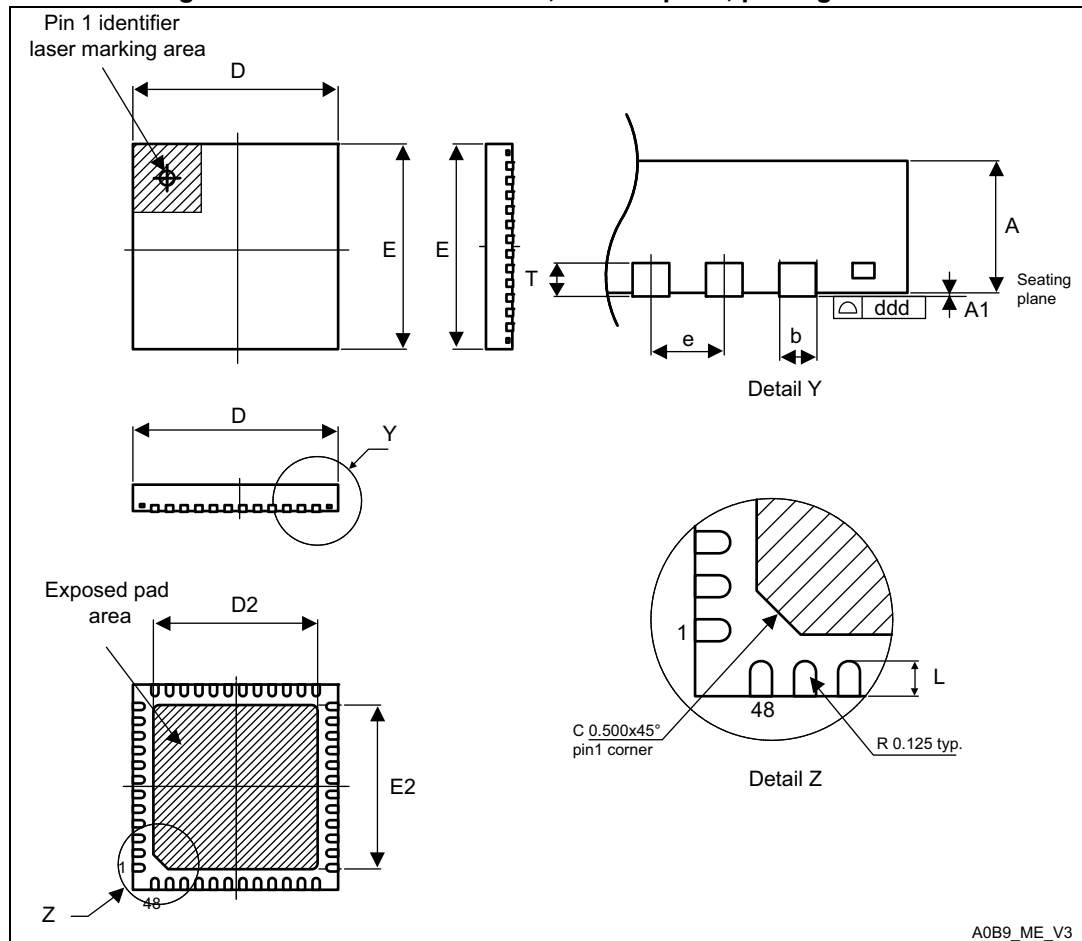
**Figure 28. LQFP64 10 x 10 mm, 64-pin low-profile quad flat package top view example**



1. Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

## 7.2 UFQFPN48 7 x 7 mm, 0.5 mm pitch, package information

Figure 29. UFQFPN48 7 x 7 mm, 0.5 mm pitch, package outline



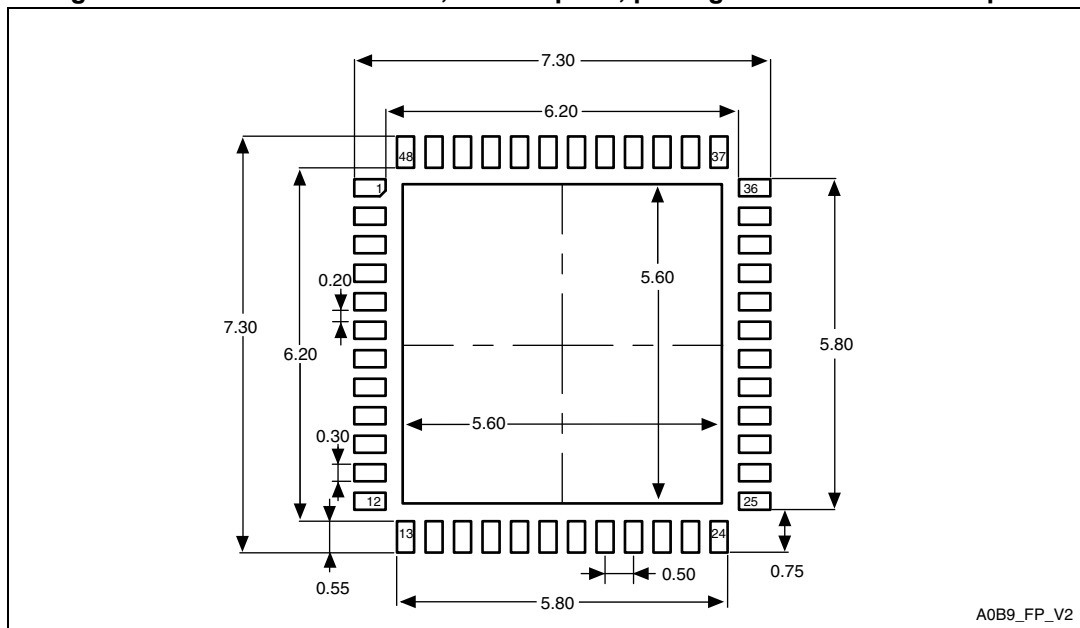
1. Drawing is not to scale.
2. All leads/pads should also be soldered to the PCB to improve the lead/pad solder joint life.
3. There is an exposed die pad on the underside of the UFQFPN package. It is recommended to connect and solder this back-side pad to PCB ground.

Table 63. UFQFPN48 7 x 7 mm, 0.5 mm pitch, package mechanical data

| Symbol | millimeters |       |       | inches <sup>(1)</sup> |        |        |
|--------|-------------|-------|-------|-----------------------|--------|--------|
|        | Min         | Typ   | Max   | Min                   | Typ    | Max    |
| A      | 0.500       | 0.550 | 0.600 | 0.0197                | 0.0217 | 0.0236 |
| A1     | 0.000       | 0.020 | 0.050 | 0.0000                | 0.0008 | 0.0020 |
| D      | 6.900       | 7.000 | 7.100 | 0.2717                | 0.2756 | 0.2795 |
| E      | 6.900       | 7.000 | 7.100 | 0.2717                | 0.2756 | 0.2795 |
| D2     | 5.500       | 5.600 | 5.700 | 0.2165                | 0.2205 | 0.2244 |
| E2     | 5.500       | 5.600 | 5.700 | 0.2165                | 0.2205 | 0.2244 |
| L      | 0.300       | 0.400 | 0.500 | 0.0118                | 0.0157 | 0.0197 |
| T      | -           | 0.152 | -     | -                     | 0.0060 | -      |
| b      | 0.200       | 0.250 | 0.300 | 0.0079                | 0.0098 | 0.0118 |
| e      | -           | 0.500 | -     | -                     | 0.0197 | -      |
| ddd    | -           | -     | 0.080 | -                     | -      | 0.0031 |

1. Values in inches are converted from mm and rounded to 4 decimal digits.

Figure 30. UFQFPN48 7 x 7 mm, 0.5 mm pitch, package recommended footprint



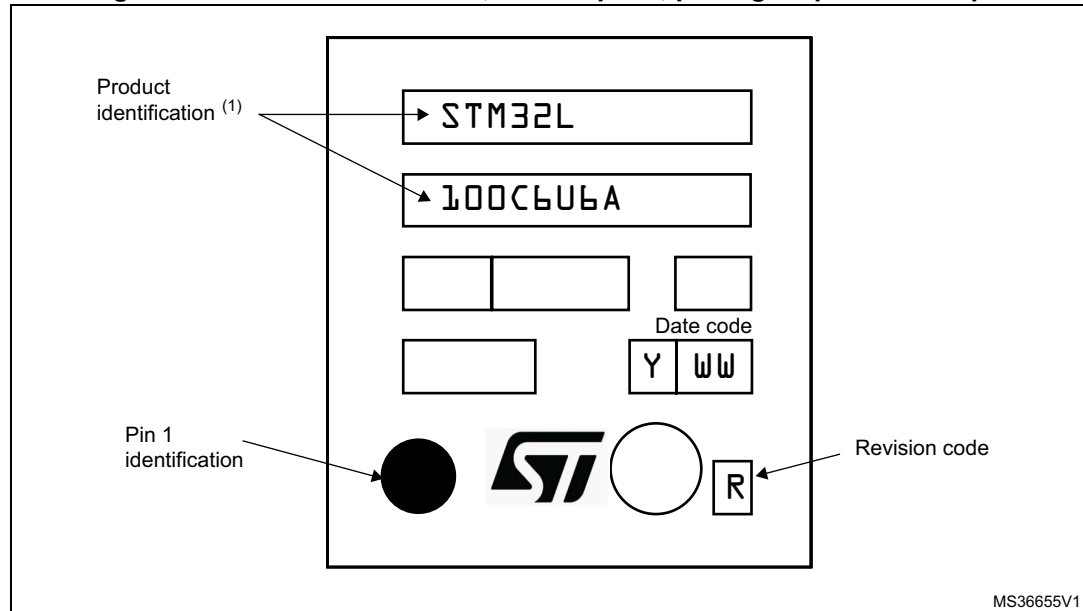
1. Dimensions are in millimeters.

### UFQFPN48 device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

**Figure 31. UFQFPN48 7 x 7 mm, 0.5 mm pitch, package top view example**



1. Parts marked as ES or E or accompanied by an engineering sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted prior to any decision to use these engineering samples to run a qualification activity.

### 7.3 Thermal characteristics

The maximum chip-junction temperature,  $T_J \text{ max}$ , in degrees Celsius, may be calculated using the following equation:

$$T_J \text{ max} = T_A \text{ max} + (P_D \text{ max} \times \Theta_{JA})$$

Where:

- $T_A \text{ max}$  is the maximum ambient temperature in  $^{\circ}\text{C}$ ,
- $\Theta_{JA}$  is the package junction-to-ambient thermal resistance, in  $^{\circ}\text{C/W}$ ,
- $P_D \text{ max}$  is the sum of  $P_{\text{INT}} \text{ max}$  and  $P_{\text{I/O}} \text{ max}$  ( $P_D \text{ max} = P_{\text{INT}} \text{ max} + P_{\text{I/O}} \text{ max}$ ),
- $P_{\text{INT}} \text{ max}$  is the product of  $I_{\text{DD}}$  and  $V_{\text{DD}}$ , expressed in Watts. This is the maximum chip internal power.

$P_{\text{I/O}} \text{ max}$  represents the maximum power dissipation on output pins where:

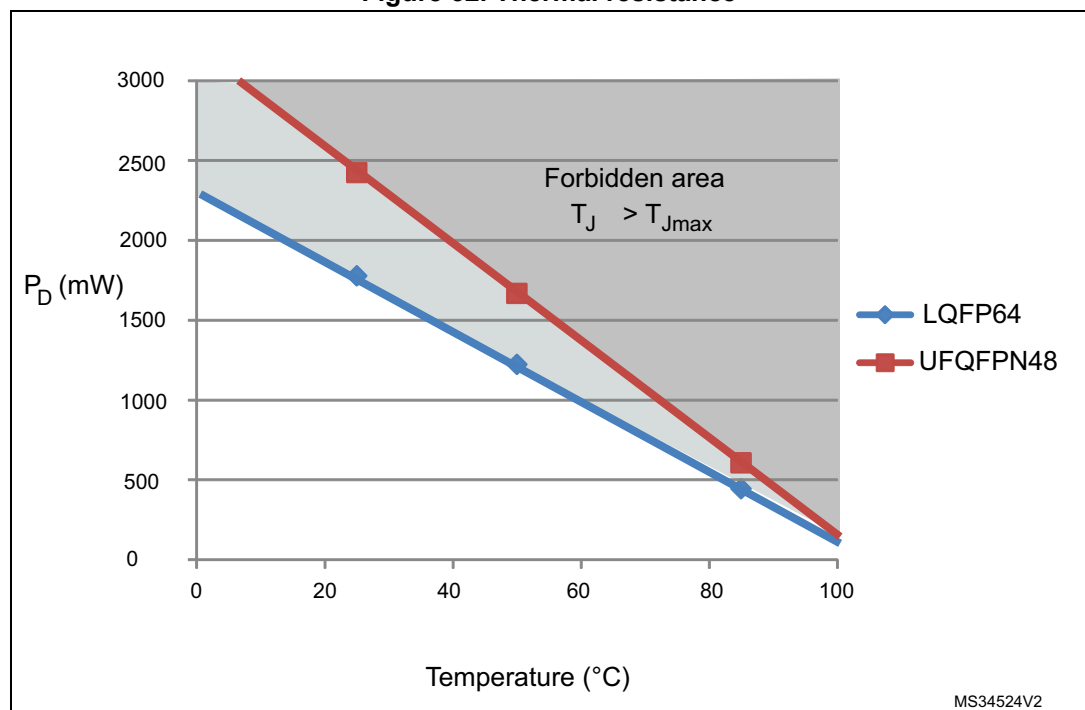
$$P_{\text{I/O}} \text{ max} = \Sigma (V_{\text{OL}} \times I_{\text{OL}}) + \Sigma ((V_{\text{DD}} - V_{\text{OH}}) \times I_{\text{OH}}),$$

taking into account the actual  $V_{\text{OL}} / I_{\text{OL}}$  and  $V_{\text{OH}} / I_{\text{OH}}$  of the I/Os at low and high level in the application.

**Table 64. Thermal characteristics**

| Symbol        | Parameter                                                                 | Value | Unit                 |
|---------------|---------------------------------------------------------------------------|-------|----------------------|
| $\Theta_{JA}$ | Thermal resistance junction-ambient<br>LQFP64 - 10 x 10 mm / 0.5 mm pitch | 45    | $^{\circ}\text{C/W}$ |
|               | Thermal resistance junction-ambient<br>UFQFPN48 - 7 x 7 mm / 0.5 mm pitch | 33    |                      |

**Figure 32. Thermal resistance**



### 7.3.1 Reference document

JESD51-2 Integrated Circuits Thermal Test Method Environment Conditions - Natural Convection (Still Air). Available from [www.jedec.org](http://www.jedec.org).

## 8 Ordering information

Table 65. Ordering information scheme

| Example:                                       | STM32 | L | 100 | R | B | T | 6 | A | TR |
|------------------------------------------------|-------|---|-----|---|---|---|---|---|----|
| <b>Device family</b>                           |       |   |     |   |   |   |   |   |    |
| STM32 = ARM-based 32-bit microcontroller       |       |   |     |   |   |   |   |   |    |
| <b>Product type</b>                            |       |   |     |   |   |   |   |   |    |
| L = Low power                                  |       |   |     |   |   |   |   |   |    |
| <b>Device subfamily</b>                        |       |   |     |   |   |   |   |   |    |
| 100                                            |       |   |     |   |   |   |   |   |    |
| <b>Pin count</b>                               |       |   |     |   |   |   |   |   |    |
| C = 48 pins                                    |       |   |     |   |   |   |   |   |    |
| R = 64 pins                                    |       |   |     |   |   |   |   |   |    |
| <b>Flash memory size</b>                       |       |   |     |   |   |   |   |   |    |
| 6 = 32 Kbytes of Flash memory                  |       |   |     |   |   |   |   |   |    |
| 8 = 64 Kbytes of Flash memory                  |       |   |     |   |   |   |   |   |    |
| B = 128 Kbytes of Flash memory                 |       |   |     |   |   |   |   |   |    |
| <b>Package</b>                                 |       |   |     |   |   |   |   |   |    |
| T = LQFP                                       |       |   |     |   |   |   |   |   |    |
| U = UFQFPN                                     |       |   |     |   |   |   |   |   |    |
| <b>Temperature range</b>                       |       |   |     |   |   |   |   |   |    |
| 6 = Industrial temperature range, -40 to 85 °C |       |   |     |   |   |   |   |   |    |
| <b>Options</b>                                 |       |   |     |   |   |   |   |   |    |
| A = Device generation A                        |       |   |     |   |   |   |   |   |    |
| <b>Packing</b>                                 |       |   |     |   |   |   |   |   |    |
| TR = tape and reel                             |       |   |     |   |   |   |   |   |    |
| No character = tray or tube                    |       |   |     |   |   |   |   |   |    |

For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest ST sales office.

## 9 Revision history

**Table 66. Document revision history**

| Date        | Revision | Changes                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
|-------------|----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 25-Mar-2014 | 1        | Initial release.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| 27-Oct-2014 | 2        | Updated DMIPS features in cover page and <a href="#">Section 2: Description</a><br>Updated current consumption in <a href="#">Table 20: Current consumption in Sleep mode</a> .<br>Updated <a href="#">Table 25: Peripheral current consumption</a> with new measured values.<br>Updated <a href="#">Table 57: Maximum source impedance RAIN max</a> adding note 2.                                                                                                                                                                                                                                                                                                                                                                                         |
| 03-Feb-2015 | 3        | Updated <a href="#">Section 7: Package information</a> with new package device markings.<br>Updated <a href="#">Figure 5: Memory map</a> .                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| 30-Apr-2015 | 4        | Updated <a href="#">Section 7: Package information</a> structure: Paragraph titles and paragraph heading level.<br>Updated <a href="#">Table 62: LQFP64 10 x 10 mm, 64-pin low-profile quad flat package mechanical data</a> .<br>Updated <a href="#">Section 7: Package information</a> for LQFP64 and UFQFPN48 package device markings, adding text for device orientation versus pin 1 identifier.<br>Updated <a href="#">Table 17: Embedded internal reference voltage</a> temperature coefficient at 100ppm/°C and table footnote 3: "guaranteed by design" changed by "guaranteed by characterization results".<br>Updated <a href="#">Table 60: Comparator 2 characteristics</a> new maximum threshold voltage temperature coefficient at 100ppm/°C. |
| 25-Apr-2016 | 5        | Updated <a href="#">Table 40: ESD absolute maximum ratings</a> CDM class.<br>Updated all the notes, removing 'not tested in production'.<br>Updated <a href="#">Table 11: Voltage characteristics</a> adding note about V <sub>REF</sub> -pin.<br>Updated <a href="#">Table 3: Functionalities depending on the operating power supply range</a> LSI and LSE functionalities putting "Y" in Standby mode.<br>Removed note 1 below <a href="#">Figure 2: Clock tree</a> .<br>Updated <a href="#">Section 7: Package information</a> replacing "Marking of engineering samples" by "device marking".<br>Updated <a href="#">Table 58: DAC characteristics</a> resistive load.                                                                                 |

Table 66. Document revision history (continued)

| Date        | Revision | Changes                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
|-------------|----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 28-Aug-2017 | 6        | <p>Updated <a href="#">Table 43: I/O static characteristics</a> pull-up and pull-down values.</p> <p>Updated <a href="#">Table 46: NRST pin characteristics</a> pull-up values.</p> <p>Updated <a href="#">Section 7: Package information</a> adding information about other optional marking or inset/upset marks.</p> <p>Updated note 1 below all the package device marking figures.</p> <p>Updated <a href="#">Nested vectored interrupt controller (NVIC)</a> in <a href="#">Section 3.2: ARM® Cortex®-M3 core with MPU</a> about process state automatically saved.</p> <p>Updated <a href="#">Table 3: Functionalities depending on the operating power supply range</a> removing I/O operation column and adding note about GPIO speed.</p> <p>Updated <a href="#">Table 42: I/O current injection susceptibility</a> note by 'injection is not possible'.</p> <p>Updated <a href="#">Figure 16: Recommended NRST pin protection</a> note about the 0.1uF capacitor.</p> <p>Updated <a href="#">Section 3.1: Low-power modes</a> Low-power run mode (MSI) RC oscillator clock.</p> <p>Updated <a href="#">Table 5: Working mode-dependent functionalities (from Run/active down to standby)</a> disabling I2C functionality in Low-power Run and Low-power Sleep modes.</p> |

**IMPORTANT NOTICE – PLEASE READ CAREFULLY**

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2017 STMicroelectronics – All rights reserved

Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

Мы предлагаем:

- Конкурентоспособные цены и скидки постоянным клиентам.
- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
- Сертификаты соответствия на поставляемую продукцию (по желанию клиента).
- Тестирование поставляемой продукции.
- Поставку компонентов, требующих военную и космическую приемку.
- Входной контроль качества.
- Наличие сертификата ISO.

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- Регистрацию проекта у производителя компонентов.
- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



Тел: +7 (812) 336 43 04 (многоканальный)

Email: [org@lifeelectronics.ru](mailto:org@lifeelectronics.ru)

[www.lifeelectronics.ru](http://www.lifeelectronics.ru)